





TPS6521905 JAJSOZ4A - JUNE 2023 - REVISED JUNE 2024

# 3つの降圧 DC/DC コンバータおよび 4 つの LDO を搭載した、ユーザー プロ グラマブル電源管理 IC (PMIC)

### 1 特長

- 最大 2.3MHz のスイッチング周波数で動作する、3 つ の降圧コンバータ。
  - 1 → Ø VIN:2.5V ~ 5.5V 、 I<sub>OUT</sub>:3.5A 、 V<sub>OUT</sub> 0.6V  $\sim$ 3.4V
  - 2 o0 VIN:2.5V $\sim$ 5.5V, I $_{
    m OUT}$ :2A, V $_{
    m OUT}$  0.6V $\sim$ 3.4V
- 4 つのリニア レギュレータ:
  - 2x VIN:1.5V~5.5V, I<sub>OUT</sub>:400mA, V<sub>OUT</sub>:0.6V ~3.4V (ロード スイッチ / バイパス モードとして構 成可能、SD カードをサポート)
  - 2x VIN:2.2V~5.5V, I<sub>OUT</sub>:300mA, V<sub>OUT</sub>:1.2V ~3.3V (ロード スイッチとして構成可能)
- 3 つの降圧コンバータすべてで、動的な電圧スケーリ ングを実現
- 低 IQ/PFM、PWM モード (擬似固定周波数)
- 電源シーケンスとデフォルト電圧をプログラム可能
- I<sup>2</sup>C インターフェイス。標準、ファースト モード、ファー ストモード+をサポート
- 14 本以上のレールを備えたシステム (マルチ PMIC) 構成で 2 台の TPS6521905 デバイス) をサポートす
- 2 つの GPO、1 つの GPIO、3 つのマルチファンクショ ンピン
- EEPROM プログラマビリティ

# 2 アプリケーション

- 消費電力が低い産業用 MPU および MCU (AM62x、 AM64x、AM243x など)
- HMI
- PLC
- 産業用 PC
- ビル セキュリティ
- HVAC
- ビデオ監視
- データ コンセントレータ
- スマートメーター
- 保護リレー
- メディカル モニタと診断
- 画像処理

### 3 概要

TPS6521905 は、携帯機器および据置型機器アプリケー ションに搭載されている、さまざまな SoC に電源を供給す るように設計されたパワー マネージメント IC (PMIC) で す。このデバイスは、-40℃~+105℃の周囲温度範囲で 特性が規定されているため、さまざまな産業用アプリケー ションに最適な PMIC です。このデバイスは、**3** つの同期 整流式降圧 DC/DC コンバータと 4 つのリニア レギュレー タを内蔵しています。

DC/DC コンバータは、1 つの 3.5A および 2 つの 2A に 対応可能です。これらのコンバータには、スイッチングモ ード構成に応じて、小型の 470nH インダクタ、4.7µF の入 力容量、およびレールあたり 10µF 以上の出力容量が必 要です。

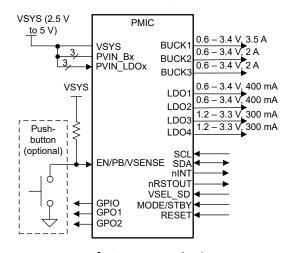
**2** つの LDO が 0.6V ~ 3.4V の出力電圧範囲で 400mA の出力電流をサポートします。これらの LDO は、バイパス モードをサポートし、負荷スイッチとして動作し、動作中に 電圧を変化させることができます。他の 2 つの LDO は、 1.2V ~ 3.3V の出力電圧範囲において 300mA の出力 電流をサポートします。 これらの LDO は、負荷スイッチ モ ードもサポートしています。

I2C インターフェイス、IO、GPIO、マルチファンクションピ ン (MFP) は、さまざまな SoC にシームレスに接続しま

### パッケージ情報

		1 27
部品番号	パッケージ <sup>(1)</sup>	パッケージ サイズ (公称)
TPS6521905	32 ピン QFN	4.00mm × 4.00mm
TPS6521905	32ピン QFN	5.00mm × 5.00mm

利用可能なすべてのパッケージについては、データシートの末尾 にある注文情報を参照してください。



アプリケーション概略図



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# 4 Pin Configuration and Functions

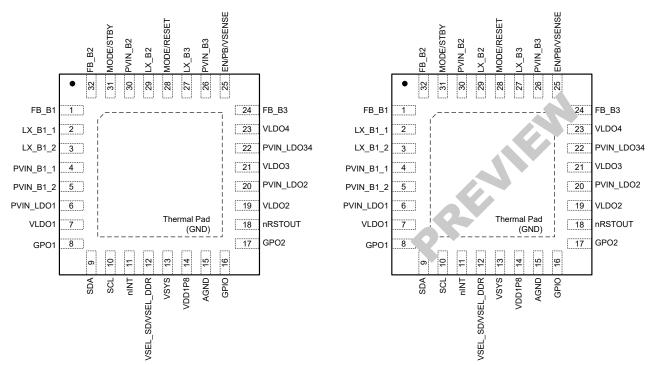


図 4-1. RHB Package, 32-pin QFN (Top View)

図 4-2. RSM Package, 32-pin QFN (Top View)

表 4-1. Pin Functions

PIN NAME	PIN NO.	TYPE	DESCRIPTION	CONNECTION if not used (output rails must be permanently disabled)
FB_B1	1	I	Feedback Input for Buck1. Connect to Buck1 output filter. Nominal output voltage is configured in EEPROM.	Connect to GND
LX_B1_1	2	PWR	Switch Pin for Buck1. Connect one side of the Buck1-inductor to this pin.	Leave floating
LX_B1_2	3	PWR	2nd Switch Pin for Buck1. Connect one side of the Buck1-inductor to this pin. Connect to LX_B1_1.	Leave floating
PVIN_B1_1	4	PWR	Power Input for BUCK1. Bypass this pin to ground with a 4.7 μF or greater ceramic capacitor. Voltage on PVIN_B1_1 pin must not exceed voltage on VSYS pin.	Connect to VSYS
PVIN_B1_2	5	PWR	2nd Power Input for BUCK1. This pin shares the bypass capacitor from pin 4. Voltage on PVIN_B1_2 pin must not exceed voltage on VSYS pin.	Connect to VSYS
PVIN_LDO1	6	PWR	Power Input for LDO1. Voltage on PVIN_LDO1 pin must not exceed voltage on VSYS pin.	Connect to VSYS
VLDO1	7	PWR	Output Voltage of LDO1. Nominal output voltage is configured in EEPROM. Bypass this pin to ground with a 2.2 µF or greater ceramic capacitor.	Leave floating
GPO1	8	0	General Purpose Open-Drain Output. Configurable in the power-up and power-down-sequence to enable an external rail.	Leave floating
SDA	9	I/O	Data Pin for the I2C Serial Port. The I2C logic levels depend on the external pull-up voltage.	Connect to VIO



# 表 4-1. Pin Functions (続き)

PIN NAME	PIN NO.	TYPE	DESCRIPTION	CONNECTION if not used (output rails must be permanently disabled)
SCL	10	I	Clock Pin for the I2C Serial Port. The I2C logic levels depend on the external pull-up voltage.	Connect to VIO
nINT	11	0	Interrupt Request Output. Open-drain driver is pulled low for fault conditions. Released if bit is cleared	Leave floating
VSEL_SD/ VSEL_DDR	12	I	Multi-Function-Pin: Configured as VSEL_SD: SD-card-IO-voltage select. Connected to SoC. Trigger a voltage change between 1.8 V and register-based VOUT on LDO1 or LDO2. Polarity is configurable. Configured as VSEL_DDR: DDR-voltage selection. Hard-wired pull-up (1.35 V), pull-down (register based VOUT) or floating (1.2 V)	n/a (connect to GND)
VSYS	Input supply pin for reference system. Bypass this		n/a	
VDD1P8	Internal Reference Voltage: For Internal Use Onl		Internal Reference Voltage: For Internal Use Only. Bypass this pin to ground with a 2.2 µF or greater ceramic capacitor.	n/a
AGND	15	GND	Ground pin for Analog GND	n/a
GPIO	16	I/O	GPO-configuration: General Purpose Open-Drain Output. Configurable in the power-up and power-down-sequence to enable an external rail. GPIO-configuration:  Synchronizing I/O. Used to synchronize two or more TPS6521905. The pin is level-sensitive.	Leave floating
GPO2	17	0	General Purpose Open-Drain Output. Configurable in the power-up and power-down-sequence to enable an external rail.	Leave floating
nRSTOUT	18	0	Reset-output to SoC. Controlled by sequencer. High in ACTIVE and STBY state.	Leave floating
VLDO2	19	PWR	Output Voltage of LDO2. Nominal output voltage is configured in EEPROM. Bypass this pin to ground with a 2.2 µF or greater ceramic capacitor.	Leave floating
PVIN_LDO2	20	PWR	Power Input for LDO2. Bypass this pin to ground with a 2.2 μF or greater ceramic capacitor. Voltage on PVIN_LDO2 pin must not exceed voltage on VSYS pin.	Connect to VSYS
VLDO3	21	PWR	Output Voltage of LDO3. Nominal output voltage is configured in EEPROM. Bypass this pin to ground with a 2.2 µF or greater ceramic capacitor.	Leave floating
PVIN_LDO34	22	PWR	Power Input for LDO3 and LDO4. Bypass this pin to ground with a 4.7 µF or greater ceramic capacitor. Voltage on PVIN_LDO34 pin must not exceed voltage on VSYS pin.	Connect to VSYS
VLDO4	23	PWR	Output Voltage of LDO4. Nominal output voltage is configured in EEPROM.Bypass this pin to ground with a 2.2 µF or greater ceramic capacitor.	Leave floating
FB_B3	24	I	Feedback Input for Buck3. Connect to Buck3 output filter. Nominal output voltage is configured in EEPROM.	Connect to GND

## 表 4-1. Pin Functions (続き)

PIN NAME	PIN NO.	TYPE	DESCRIPTION	CONNECTION if not used (output rails must be permanently disabled)
EN/PB/ VSENSE	25	ı	ON-request input. Configured as EN: Device enable pin, high level is ON-request, low-level is OFF-request. Configured as PB: Push-button monitor input. 600 ms low-level is an ON-request, 8 s low-level is an OFF-request. Configured as VSENSE: Power-fail comparator input. Set sense voltage using a resistor divider connected from the input to the pre-regulator to this pin to ground. Detects rising/falling voltage on pre-regulator and triggers ON- / OFF-request. The pin is edge-sensitive with a wait-time in PB-configuration and deglitch time for EN- and VSENSE-configuration.	n/a (configure as EN and connect to VSYS)
PVIN_B3	26	PWR	Power Input for BUCK3. Bypass this pin to ground with a 4.7 μF or greater ceramic capacitor. Voltage on PVIN_B3 pin must not exceed voltage on VSYS pin.	Connect to VSYS
LX_B3	27	PWR	Switch Pin for Buck3. Connect one side of the Buck3-inductor to this pin.	Leave floating
MODE/RESET	28	I	Multi-Function-Pin: Configured as MODE: Connected to SoC or hard- wired pull-up/-down. Forces the Buck-converters into PWM or permits auto-entry in PFM-mode. Configured as RESET: Connected to SoC. Forces a WARM or COLD reset (configurable), WARM reset resetting output voltages to defaults, COLD reset sequencing down all enabled rails and power up again. Polarity is configurable. The pin is level-sensitive for MODE-configuration, edge-sensitive for RESET-configuration.	n/a (tie high or low, dependent on configuration, see 'PWM/PFM and Reset (MODE/RESET)'
LX_B2	29	PWR	Switch Pin for Buck2. Connect one side of the Buck2-inductor to this pin.	Leave floating
PVIN_B2	30	PWR	Power Input for BUCK2. Bypass this pin to ground with a 4.7 $\mu$ F or greater ceramic capacitor. Voltage on PVIN_B2 pin must not exceed voltage on VSYS pin.	Connect to VSYS
MODE/STBY	31	I	Multi-Function-Pin: Configured as MODE: Connected to SoC or hard-wired pull-up/-down. Forces the Buck-converters into PWM or permits auto-entry in PFM-mode. Configured as STBY: Low-power-mode command, disables selected rails. Both functions, MODE and STBY, can be combined. The pin is level-sensitive.	n/a (tie high or low, dependent on configuration, see 'PWM/PFM and Low Power Modes (MODE/ STBY)'
FB_B2	32	I	Feedback Input for Buck2. Connect to Buck2 output filter. Nominal output voltage is configured in EEPROM.	Connect to GND



# 表 4-1. Pin Functions (続き)

PIN NAME	PIN NO.	TYPE	DESCRIPTION	CONNECTION if not used (output rails must be permanently disabled)
PGND	PowerPad	GND	Power-Ground. The exposed pad must be connected to a continuous ground plane of the printed circuit board by multiple interconnect vias directly under the TPS6521905 to maximize electrical and thermal conduction.	n/a

## **5 Specifications**

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

POS			MIN	MAX	UNIT
1.1.1	Input voltage	VSYS	-0.3	6	V
1.1.2	Input voltage	PVIN_B1, PVIN_B2, PVIN_B3, PVIN_LDO1, PVIN_LDO2, PVIN_LDO34	-0.3	6	V
1.1.3	Input voltage vs. VSYS for Bucks	PVIN_B1, PVIN_B2, PVIN_B3 maximum voltage exceeding VSYS		200	mV
1.1.4	Input voltage vs. VSYS for LDOs	PVIN_LDO1, PVIN_LDO2, PVIN_LDO34 maximum voltage exceeding VSYS		20	mV
1.1.5	Input voltage	FB_B1, FB_B2, FB_B3	-0.3	6	V
1.1.6	Input voltage	EN/PB/VSENSE, MODE/STBY, MODE/RESET, VSEL_SD/VSEL_DDR	-0.3	6	V
1.2.1	Output voltage	LX_B1, LX_B2, LX_B3	-0.3	PVIN_Bx + 0.3 V, up to 6 V	V
1.2.2	Output voltage	LX_B1, LX_B2, LX_B3 spikes for maximum 10ns	-2	10	V
1.2.3	Output voltage	GPO1, GPO2, GPIO	-0.3	6	V
1.2.4	Output voltage	VLDO1, VLDO2, VLDO3, VLDO4	-0.3	PVIN_LDOx + 0.3 V, up to 6 V	V
1.2.5	Output voltage	VDD1P8	-0.3	2	V
1.2.6	Output voltage	SDA, SCL	-0.3	6	V
1.2.7	Output voltage	nINT, nRSTOUT	-0.3	6	V
1.4.1	Operating junction temperatu	re, T <sub>J</sub>	-40	125	°C
1.4.2	Storage temperature, T <sub>stg</sub>		-40	150	°C

<sup>(1)</sup> Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

### 5.2 ESD Ratings

POS				VALUE	UNIT
2.1	V <sub>(ESD)</sub>		Human body model (HBM), per ANSI/ ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	±2000	V
2.2	V <sub>(ESD)</sub>	0, 0	Charged device model (CDM), per ANSI/ ESDA/JEDEC JS-002, all pins <sup>(2)</sup>	±500	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### **5.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

POS			MIN	NOM MAX	UNIT
3.1.1	V <sub>VSYS</sub>	Input voltage	2.5 <sup>(1)</sup>	5.5	V
3.1.2	V <sub>PVIN_B1</sub> , V <sub>PVIN_B2</sub> , V <sub>PVIN_B3</sub> V <sub>LX_B1</sub> , V <sub>LX_B2</sub> , V <sub>LX_B3</sub>	BUCKx Pins	2.5	5.5 (2)	V
3.1.3	ΔV <sub>VSYS_PVIN_Bx</sub>	Voltage by which V <sub>PVIN_Bx</sub> may exceed V <sub>VSYS</sub>		0	mV

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# 5.3 Recommended Operating Conditions (続き)

over operating free-air temperature range (unless otherwise noted)

POS			MIN	NOM	MAX	UNIT
3.1.4	ΔV <sub>VSYS</sub> _PVIN_LDO1,LDO2	Voltage by which V <sub>PVIN_LDO1</sub> or V <sub>PVIN_LDO2</sub> may exceed V <sub>VSYS</sub>			0	mV
3.1.5	ΔV <sub>VSYS_VLDO34</sub>	Voltage by which $V_{VSYS}$ must exceed LDO output voltage (VLDO3, VLDO4); $V_{VSYS}$ = 2.5V to 3.45V; LDO mode	150			mV
3.1.6	ΔV <sub>VSYS_VLDO34</sub>	Voltage by which $V_{VSYS}$ must exceed LDO output voltage (VLDO3, VLDO4); $V_{VSYS}$ = 3.45V to 5.5V in LDO-mode or $V_{VSYS}$ = 2.5V to 5.5V in LSW-mode	n/a			mV
3.1.7	C <sub>PVIN_B1</sub> , C <sub>PVIN_B2</sub> , C <sub>PVIN_B3</sub>	BUCKx Input Capacitance	3.9	4.7		μF
3.1.8	L <sub>B1</sub> , L <sub>B2</sub> , L <sub>B3</sub>	BUCKx Output Inductance	330	470	611	nΗ
3.1.9a	C <sub>OUT_B1</sub> , C <sub>OUT_B2</sub> , C <sub>OUT_B3</sub>	BUCKx Output Capacitance, forced PWM or auto-PFM, low bandwidth case	10	`	75	μF
3.1.10a	C <sub>OUT_B1</sub> , C <sub>OUT_B2</sub> , C <sub>OUT_B3</sub>	BUCKx Output Capacitance, forced PWM or auto-PFM, high bandwidth case	30		220	μF
3.1.11	V <sub>FB_B1</sub> , V <sub>FB_B2</sub> , V <sub>FB_B3</sub>	BUCKx FB Pins	0		5.5 <sup>(2)</sup>	V
3.1.12	V <sub>PVIN_LDO1</sub> , V <sub>PVIN_LDO2</sub>	LDO Input Voltage	1.5		5.5 <sup>(2)</sup>	V
3.1.13	V <sub>PVIN_LDO1</sub> , V <sub>PVIN_LDO2</sub>	LDO Input Voltage in bypass mode	1.5		3.6	V
3.1.14	V <sub>PVIN_LDO1</sub> , V <sub>PVIN_LDO2</sub>	Allowable delta between V <sub>PVIN_LDOx</sub> and configured V <sub>VLDOx</sub> in bypass mode	-200		200	mV
3.1.15	V <sub>VLDO1</sub> , V <sub>VLDO2</sub>	LDO Output Voltage Range	0.6		3.4	V
3.1.16	C <sub>PVIN_LDO1</sub> , C <sub>PVIN_LDO2</sub>	LDO Input Capacitance	1.6	2.2		μF
3.1.17	C <sub>VLDO1</sub> , C <sub>VLDO2</sub>	LDO Output Capacitance	1.6	2.2	20	μF
3.1.18	V <sub>PVIN_LDO3</sub> , V <sub>PVIN_LDO4</sub>	LDO Input Voltage	2.2		5.5 <sup>(2)</sup>	V
3.1.19	V <sub>VLDO3</sub> , V <sub>VLDO4</sub>	LDO Output Voltage Range	1.2		3.3	V
3.1.20	C <sub>PVIN_LDO34</sub>	LDO Input Capacitance	2.2	4.7		μF
3.1.21	C <sub>VLDO3</sub> , C <sub>VLDO4</sub>	LDO Output Capacitance	1.6	2.2	30 (3)	μF
3.1.22	V <sub>VDD1P8</sub>	VDD1P8 pin	0		1.8	V
3.1.23	C <sub>VDD1P8</sub>	Internal Regulator Decoupling Capacitance	1	2.2	4	μF
3.1.24	C <sub>VSYS</sub>	VSYS Input Decoupling Capacitance	1	2.2		μF
3.1.25	V <sub>nINT</sub> , V <sub>nRSTOUT</sub>	Digital Outputs	0		3.4	V
3.1.26	V <sub>GPO1</sub> , V <sub>GPO2</sub> , V <sub>GPIO</sub>	Digital Outputs	0		5.5 <sup>(2)</sup>	V
3.1.27	V <sub>SCL</sub> , V <sub>SDA</sub>	I2C Interface	0	',	3.4	V
3.1.28	V <sub>EN/PB/VSENSE</sub> , V <sub>MODE/STBY</sub> , V <sub>MODE/RESET</sub> , V <sub>VSEL_SD/VSEL/DDR</sub>	Digital Inputs	0		5.5 <sup>(2)</sup>	٧
3.2.1	tvsys_ramp_rise	Input voltage rising ramp Time, Input voltage controlled by a pre-regulator. $V_{VSYS} = V_{PVIN\_Bx} = V_{PVIN\_LDOx} = 0V$ to 5V	0.1		600000	ms
3.2.2	t <sub>VSYS_RAMP_FALL</sub>	Input voltage falling Ramp Time, V <sub>VSYS</sub> = V <sub>PVIN_Bx</sub> = V <sub>PVIN_LDOx</sub> = 5V to 2.5V	0.4		600000	ms
3.3.1	T <sub>A</sub>	Operating free-air temperature	-40		105	°C
3.3.2	TJ	Operating junction temperature	-40		125	°C

<sup>(1)</sup> For EEPROM programming, VSYS(min)=3.3V

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English Data Sheet: SLVSGZ4

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<sup>(2)</sup> Must not exceed VSYS

<sup>(3)</sup> In slow-ramp-mode. Fast-ramp supports 15µF maximum

### **5.4 Thermal Information**

		TPS65219	TPS65219	
	THERMAL METRIC <sup>(1)</sup>	RHB (QFN)	RSM (QFN)	UNIT
		32 PINS, 5x5mm²	32 PINS, 4x4mm²	
R <sub>⊝JA</sub>	Junction-to-ambient thermal resistance	31.3	31.9	°C/W
$R_{\Theta JC(top)}$	Junction-to-case (top) thermal resistance	20.4	25.6	°C/W
$R_{\Theta JB}$	Junction-to-board thermal resistance	10.9	10.5	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	0.3	0.3	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	10.8	10.5	°C/W
R <sub>OJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	2.8	2.9	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

## 5.5 System Control Thresholds

Over operating free-air temperature range (unless otherwise noted). Voltage level refers to the AGND ground of the device.

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Electric	al Characteristics	•					
4.1.1	VSYS	Operating Input Voltage		2.5		5.5	V
4.1.2	VSYS <sub>POR_Rising</sub>	VSYS POR rising threshold	Measured on VSYS pin, untrimmed	2.2		2.5	V
4.1.3	VSYS <sub>UVLO_Falling</sub>	VSYS UVLO falling threshold	Measured on VSYS pin, trimmed	2.175		2.25	V
4.1.4	VSYS <sub>POR_Hyst</sub>	VSYS UVLO/POR hysteresis	VSYSPOR_Rising_untrimmedTVSYSUVLO_Falling_trimmed		130		mV
4.1.5	V <sub>VSYS_OVP_Rise</sub>	VSYS OVP rising threshold, trimmed	Measured on VSYS pin, trimmed	5.9		6.1	V
4.1.6	V <sub>VSYS_OVP_Fall</sub>	VSYS OVP falling threshold, trimmed	Measured on VSYS pin, trimmed	5.7		5.95	V
4.1.7	V <sub>VSYS_OVP_Hyst</sub>	VSYS OVP hysteresis	VSYS <sub>OVP_Rising_trimmed</sub> - VSYS <sub>OVP_falling_trimmed</sub>	100	140	180	mV
4.1.8	V <sub>VDD1P8</sub>	VDD1P8 voltage		1.7	1.8	1.9	V
4.2.1a	Initialize	Current Consumption in INITIALIZE state, at 25°C	Combined Current from VSYS and PVIN_x pins. VSYS = PVIN_Bx = PVIN_LDOx = 5V. All Monitors are off. T <sub>J</sub> = 25°C		15	22	μА
4.2.1b	I <sub>INITIALIZE</sub>	Current Consumption in INITIALIZE state, 40°C to 125°C	Combined Current from VSYS and PVIN_x pins. VSYS = PVIN_Bx = PVIN_LDOx = 5V. All Monitors are off. T <sub>J</sub> = -40°C to 125°C		15	35	μА
4.2.2a	I <sub>ACTIVE</sub>	ACTIVE State Current Consumption, all rails on, at 25°C	Combined Current from VSYS and PVIN_x pins. VSYS = PVIN_Bx = PVIN_LDOx = 5V. All Outputs are on, all LDOs in LDO-mode, Bucks in PFM mode. No Load. T <sub>J</sub> = 25°C		250	290	μА
4.2.2b	l <sub>ACTIVE</sub>	ACTIVE State Current Consumption, all rails on, -40°C to 125°C	Combined Current from VSYS and PVIN_x pins. VSYS = PVIN_Bx = PVIN_LDOx = 5V. All Outputs are on, all LDOs in LDO-mode, Bucks in PFM mode. No Load. T <sub>J</sub> = -40°C to 125°C		250	430	μА

資料に関するフィードバック(ご意見やお問い合わせ)を送信

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## 5.5 System Control Thresholds (続き)

Over operating free-air temperature range (unless otherwise noted). Voltage level refers to the AGND ground of the device.

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
4.2.3a	I <sub>STBY</sub>	STBY State Current Consumption, only LDO1 on, at 25°C	Combined Current from VSYS and PVIN_x pins. VSYS = PVIN_Bx = PVIN_LDOx = 5V. Only LDO1 on in LDO-mode. No Load. T <sub>J</sub> = 25°C		105	125	μА
4.2.3b	I <sub>STBY</sub>	STBY State Current Consumption, only LDO1 on, -40°C to 125°C	Combined Current from VSYS and PVIN_x pins. VSYS = PVIN_Bx = PVIN_LDOx = 5V. Only LDO1 on in LDO-mode. No Load. T <sub>J</sub> = -40°C to 125°C		105	150	μА
4.2.4a	I <sub>STBY</sub>	STBY State Current Consumption, all rails on, VMON on at 25°C	Combined Current from VSYS and PVIN_x pins. VSYS = PVIN_Bx = PVIN_LDOx = 5V. All Outputs are on, all LDOs in LDO-mode, Bucks in PFM mode. No Load. Output-voltage Monitors are on, VSYS-monitor (UV/OVP) are on. T <sub>J</sub> = 25°C		250	290	μА
4.2.4b	I <sub>STBY</sub>	STBY State Current Consumption, all rails on, VMON on, -40°C to 125°C	Combined Current from VSYS and PVIN_x pins. VSYS = PVIN_Bx = PVIN_LDOx = 5V. All Outputs are on, all LDOs in LDO-mo, Bucks in PFM mode. No Load. Output-voltage Monitors are on, VSYS-monitor (UV/OVP) are on. T <sub>J</sub> = -40°C to 125°C		250	430	μА
Timing	Requirements						
4.3.1	t <sub>OFF_TO_INIT</sub>	Time from VSYS passing VSYS_POR until entering INITIALIZE state, including EEPROM-read, ready for ON- request	Time from VSYS passing VSYS_POR until entering INITIALIZE state. On request execution gated by HOT and RV			3.2	ms
4.3.2a	t <sub>TIMEOUT_UV</sub>	UV-detection in case a rail does not reach UV-threshold during ramp-up				end of t <sub>RAMP +</sub> sample- and deglitch time	
4.3.2b	t <sub>TIMEOUT_UV_</sub> SLOT	Timeout in case a rail does not reach UV-threshold during ramp-up, applicable in Multi-PMIC-configuration only				end of slot- extensi on time (3ms, 4ms or 13ms)	
4.3.3	t <sub>TIMEOUT_Discharge</sub>	Timeout in case a rail cannot be discharged when transitioning from STBY to ACTIVE state		72	80	88	ms

### 5.6 BUCK1 Converter

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT
Electrica	al Characteristics					
5.1.1a	V <sub>IN_BUCK1</sub>	Input voltage <sup>(1)</sup>	Buck supply voltage, maximum VSYS	2.5	5.5	V

Product Folder Links: TPS6521905

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English Data Sheet: SLVSGZ4

# 5.6 BUCK1 Converter (続き)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
5.1.1b	Vout_Buck1	Buck Output Voltage configurable Range	Output voltage configurable in 25mV-steps for $0.6V \le V_{OUT} \le 1.4V$ , in 100mV steps for $1.4V < V_{OUT} \le 3.4V$	0.6		3.4	V
5.1.2a	I <sub>Q_BUCK1</sub>	Quiescent Current at 25°C, PFM, low BW case	PFM, BUCK1 enabled, no load, V <sub>IN</sub> = 5.0V, V <sub>OUT</sub> = 1.2V, T <sub>J</sub> =25°C		10	13	μΑ
5.1.2b	I <sub>Q_BUCK1</sub>	Quiescent Current -40°C to 125°C, PFM, low BW case	PFM, BUCK1 enabled, no load, V <sub>IN</sub> = 5.0V, V <sub>OUT</sub> = 1.2V, T <sub>J</sub> =-40°C to 125°C		15	44	μA
5.1.2c	I <sub>Q_BUCK1</sub>	Quiescent Current -40°C to 150°C, PFM, low BW case	PFM, BUCK1 enabled, no load, V <sub>IN</sub> = 5.0V, V <sub>OUT</sub> = 1.2V, T <sub>J</sub> =-40°C to 150°C		20	63	μA
5.1.3a	V <sub>HEADROOM_PWM</sub>	Input to Output Voltage Headroom <sup>(2)</sup>	Corner cases at maximum load I <sub>OUT</sub> = 2.5A	500			mV
5.1.3b	V <sub>HEADROOM_PWM</sub>	Input to Output Voltage Headroom at I <sub>OUT</sub> = I <sub>OUT_MAX</sub> (2)	Corner cases at I <sub>OUT</sub> = I <sub>OUT_MAX</sub>	700			mV
5.1.4	V <sub>OUT_STEP_LOW</sub>	Output voltage Steps	0.6V ≤ V <sub>OUT</sub> ≤ 1.4V		25		mV
5.1.5	V <sub>OUT_STEP_HIGH</sub>	Output voltage Steps	1.5V ≤ V <sub>OUT</sub> ≤ 3.4V		100		mV
5.1.6a	VOUT_ACC_DC_PW	DC Output Voltage Accuracy in forced PWM mode, low and high BW case	$\begin{split} I_{OUT} &= I_{OUT\_MAX}, \\ V_{OUT} &\geq 0.7V \text{ to } 3.4V, \\ V_{IN} &- V_{OUT} > 700 \text{ mV} \\ \text{forced PWM, low BW case} \end{split}$	-1.5%		1.5%	
5.1.6b	V <sub>OUT_ACC_DC_PW</sub>	DC Output Voltage Accuracy in forced PWM mode, low and high BW case	$\begin{split} &I_{OUT} = I_{OUT\_MAX}, \\ &V_{OUT} = 0.6V \text{ to } 0.7V, \\ &V_{IN} - V_{OUT} > 700 \text{ mV} \\ &\text{forced PWM, low BW case} \end{split}$	-10		10	mV
5.1.6c	V <sub>OUT_ACC_DC_PFM</sub>	DC Output Voltage Accuracy in auto-PFM mode, low and high BW case	$\begin{split} I_{OUT} &= 1 \text{mA}, \\ V_{OUT} &= 0.6 \text{V to } 3.4 \text{V}, \\ V_{\text{IN}} &- V_{OUT} > 500 \text{ mV} \\ \text{auto-PFM, low BW case} \end{split}$	-3.0%		3.5%	
5.1.7	R <sub>FB_INPUT</sub>	Feedback input impedance	Converter enabled	2.3	3.75	5.0	МΩ
5.2.1a	VLOAD_REG_PWM	DC Load Regulation, forced PWM, low BW case	$\begin{aligned} &V_{\text{IN}} = 5.0\text{V, } V_{\text{OUT}} = 1.2\text{V,} \\ &I_{\text{OUT}} = 0 \text{ to } I_{\text{OUT\_MAX,}} \\ &\text{forced PWM, low BW case, } C_{\text{OUT}} = \\ &40\mu\text{F} \end{aligned}$		0.1	0.16	%/A
5.2.2a	V <sub>LINE_REG</sub>	DC Line Regulation, forced PWM, low BW case	$\begin{aligned} &V_{\text{IN}} = 3.3 \text{V to } 5.5 \text{V,} \\ &V_{\text{OUT}} = 1.2 \text{V,} \\ &I_{\text{OUT}} = 1 \text{mA and } I_{\text{OUT\_MAX}} \\ &\text{forced PWM, low BW case, } C_{\text{OUT}} = \\ &40 \mu \text{F} \end{aligned}$		0.1	0.16	%/V
5.2.3a	VLOAD_TRANSIENT	Load Transient, V <sub>OUT</sub> =0.75V, auto-PFM, high BW case	$\begin{aligned} &V_{\text{IN}} = 5.0\text{V, } V_{\text{OUT}} = 0.75\text{V,} \\ &I_{\text{OUT}} = 100\text{mA to } 1100\text{mA to } 100\text{mA,} \\ &t_{\text{R}} = t_{\text{F}} = 500\text{ns,} \\ &\text{auto-PFM, high BW case, } C_{\text{OUT}} = \\ &80\mu\text{F} \end{aligned}$	-27.5		27.5	mV
5.2.3b	VLOAD_TRANSIENT	Load Transient, V <sub>OUT</sub> =0.75V, forced PWM, high BW case	$\begin{aligned} &V_{\text{IN}} = 5.0\text{V, } V_{\text{OUT}} = 0.75\text{V,} \\ &I_{\text{OUT}} = 100\text{mA to } 1100\text{mA to } 100\text{mA,} \\ &t_{\text{R}} = t_{\text{F}} = 500\text{ns,} \\ &\text{forced PWM, high BW case, } C_{\text{OUT}} = \\ &80~\mu\text{F} \end{aligned}$	-27.5		27.5	mV
5.2.4a	V <sub>LOAD_</sub> TRANSIENT	Load Transient, V <sub>OUT</sub> =1.8V, auto- PFM, low BW case	$V_{IN} = 5.0V, V_{OUT} = 1.8V, \\ I_{OUT} = 1 mA to 1A to 1 mA, \\ t_{R} = t_{F} = 1 \mu s, \\ auto-PFM, C_{OUT} = 40 \mu F$	-90		90	mV

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## 5.6 BUCK1 Converter (続き)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
5.2.4b	VLOAD_TRANSIENT	Load Transient, V <sub>OUT</sub> =1.8V, forced PWM, low BW case	$V_{\text{IN}}$ = 5.0V, $V_{\text{OUT}}$ = 1.8V, $I_{\text{OUT}}$ = 1mA to 1A to 1mA, $t_{\text{R}}$ = $t_{\text{F}}$ = 1 $\mu$ s, forced PWM, $C_{\text{OUT}}$ = 40 $\mu$ F	-60		60	mV
5.2.5a	V <sub>LINE_</sub> TRANSIENT	Line Transient, V <sub>OUT</sub> =1.2V, forced PWM, low BW case	$V_{\text{IN}}$ = 3.3V to 5.5V in 50µs, $V_{\text{OUT}}$ = 1.2V, $I_{\text{OUT}}$ = 1mA and $I_{\text{OUT\_MAX}}$ , forced PWM, low BW case, $C_{\text{OUT}}$ = 40µF	-50		50	mV
5.2.6a	VRIPPLE_PP_PWM	Forced PWM Mode, low BW case	$\label{eq:volume} \begin{split} &V_{\text{IN}} = 5.0\text{V}, V_{\text{OUT}} = 2.5\text{V}, \\ &\text{forced PWM, low BW case, $C_{\text{OUT}}$ = } \\ &40\text{uF}, X5\text{R}, \text{ESR} = 10\text{mOhm}, \\ &L = 470\text{nH}, \text{DCR} = 50\text{m}\Omega \\ &I_{\text{OUT}} = 1\text{A} \end{split}$		10	20	mV <sub>PP</sub>
5.2.6b	VRIPPLE_PP_PFM	Auto PFM Mode, low BW case	$\begin{aligned} &V_{\text{IN}} = 5.0\text{V, } V_{\text{OUT}} = 2.5\text{V,} \\ &\text{auto PFM, low BW case, } C_{\text{OUT}} = \\ &40\text{uF, } X5\text{R, ESR} = 10\text{mOhm,} \\ &\text{L} = 470\text{nH, DCR} = 50\text{m}\Omega \\ &\text{I}_{\text{OUT}} = 20\text{mA} \end{aligned}$		20	40	$mV_PP$
5.3.1	I <sub>OUT_MAX</sub>	Maximum Operating Current				3.5	Α
5.3.2	I <sub>CURRENT_LIMIT</sub>	Peak Current Limit	V <sub>IN</sub> = 2.5V to 5.5V	4.6	5.7	6.9	Α
5.3.3	I <sub>REV_CUR_LIMIT</sub>	Reverse Peak Current Limit	V <sub>IN</sub> = 2.5V to 5.5V	-2.0	-1.5	-1.0	Α
5.3.4a	R <sub>DSON_HS</sub>	High Side MOSFET On Resistance, 5V-supply	Measured Pin to Pin, V <sub>IN</sub> = 5V			70	mΩ
5.3.4b	R <sub>DSON_HS</sub>	High Side MOSFET On Resistance, 3.3V-supply	Measured Pin to Pin, V <sub>IN</sub> = 3.3V			80	mΩ
5.3.5a	R <sub>DSON_LS</sub>	Low Side MOSFET On Resistance, 5V-supply	Measured Pin to Pin, V <sub>IN</sub> = 5V			40	mΩ
5.3.5b	R <sub>DSON_LS</sub>	Low Side MOSFET On Resistance, 3.3V-supply	Measured Pin to Pin, V <sub>IN</sub> = 3.3V			50	mΩ
5.3.6	R <sub>DISCHARGE</sub>	Output Discharge Resistance	Active only when converter is disabled	60	125	200	Ω
5.4.1	L <sub>SW</sub>	Output Inductance	DCR = 50mΩ max	330	470	611	nΗ
5.4.2a	C <sub>OUT</sub>	Output Capacitance in auto-PFM or forced PWM for low BW case	ESR = 10mΩ max	10		75	μF
5.4.3a	C <sub>OUT_HIGH_BW</sub>	Output Capacitance in auto-PFM or forced PWM for high BW case	ESR = 10mΩ max	30		220	μF
Timing	Requirements						
5.5.1	t <sub>RAMP</sub>	Ramp Time in forced PWM, low BW case	Time from enable to 98% of target value, assuming no residual voltage	0.3		1.65	ms
5.5.2a	DVFS_RISE_ QFF	DVFS timing requirements in forced PWM, rising slope	Step-duration during DVFS voltage adjustments from 0.6V to 1.4V	2.9	3.2	3.5	mV/μs
5.5.2c	DVFS_FALL	DVFS timing requirements in forced PWM, falling slope	Step-duration during DVFS voltage adjustments from 1.4V to 0.6V	0.45	0.53	0.61	mV/μs
Switchi	ng Characteristics	3					
5.6.1a	$f_{SW}$	Switching Frequency, forced PWM, high or low BW case	Forced PWM, V <sub>IN</sub> = 3.3V to 5V, V <sub>OUT</sub> = 0.8V to 1.8V, I <sub>OUT</sub> = 1A to 3A		2.3		MHz
	1		1				

<sup>(1)</sup> PVIN\_Bx must not exceed VSYS

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<sup>(2)</sup> Refers to DC-regulation only. Transient response may require more headroom. With low headroom, the frequency variation increases for quasi-fixed frequency.



# 5.7 BUCK2, BUCK3 Converter

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Electric	al Characteristics						
6.1.1a	V <sub>IN_BUCK23</sub>	Input Voltage <sup>(1)</sup>	Buck supply voltage, maximum VSYS	2.5		5.5	V
6.1.1b	V <sub>OUT_ВИСК23</sub>	Buck Output Voltage configurable Range	Output voltage configurable in 25mV-steps for $0.6V \le V_{OUT} \le 1.4V$ , in 100mV steps for $1.4V < V_{OUT} \le 3.4V$	0.6		3.4	V
6.1.2a	I <sub>Q_BUCK23</sub>	Quiescent Current at 25°C, PFM	PFM, BUCKx enabled, no load, V <sub>IN</sub> = 5.0V, V <sub>OUT</sub> = 1.2V, T <sub>J</sub> =25°C		10	13	μΑ
6.1.2b	I <sub>Q_BUCK23</sub>	Quiescent Current -40°C to 125°C, PFM, low BW case	PFM, BUCKx enabled, no load, V <sub>IN</sub> = 5.0V, V <sub>OUT</sub> = 1.2V, T <sub>J</sub> =-40°C to 125°C		15	43	μΑ
6.1.2c	I <sub>Q_BUCK23</sub>	Quiescent Current -40°C to 150°C, PFM, low BW case	PFM, BUCKx enabled, no load, V <sub>IN</sub> = 5.0V, V <sub>OUT</sub> = 1.2V, T <sub>J</sub> =-40°C to 150°C		20	63	μA
6.1.3a	V <sub>HEADROOM_PWM</sub>	Input to Output Voltage Headroom <sup>(2)</sup>	Corner cases at maximum load I <sub>OUT</sub> = 65% of I <sub>OUT_MAX</sub>	500			mV
6.1.3b	V <sub>HEADROOM_PWM</sub>	Input to Output Voltage Headroom at I <sub>OUT</sub> = I <sub>OUT_MAX</sub> (2)	Corner cases at I <sub>OUT</sub> = I <sub>OUT_MAX</sub>	700			mV
6.1.4	V <sub>OUT_STEP_LOW</sub>	Output voltage Steps Buck2 and Buck3	0.6V ≤ V <sub>OUT</sub> ≤ 1.4V		25		mV
6.1.5	V <sub>OUT_STEP_HIGH</sub>	Output voltage Steps Buck2, Buck3	1.5V ≤ V <sub>OUT</sub> ≤ 3.4V		100		mV
6.1.6a	VOUT_ACC_DC_PW	DC Output Voltage Accuracy in forced PWM mode, low and high BW case	$\begin{split} I_{OUT} &= I_{OUT\_MAX}, \\ V_{OUT} &\geq 0.7 \text{V to } 3.4 \text{V}, \\ V_{\text{IN}} &- V_{OUT} > 700 \text{ mV} \\ \text{forced PWM, low BW case} \end{split}$	-1.5%		1.5%	
6.1.6b	Vout_acc_dc_pw	DC Output Voltage Accuracy in forced PWM mode, low and high BW case	I <sub>OUT</sub> = I <sub>OUT_MAX</sub> , V <sub>OUT</sub> = 0.6V to 0.7V, V <sub>IN</sub> - V <sub>OUT</sub> > 700 mV forced PWM, low BW case	-10		10	mV
6.1.6c	Vout_ACC_DC_PFM	DC Output Voltage Accuracy in auto-PFM mode, low and high BW case	$\begin{split} I_{OUT} &= 1\text{mA}, \\ V_{OUT} &= 0.6\text{V to } 3.4\text{V}, \\ V_{\text{IN}} &= V_{OUT} > 500 \text{ mV} \\ \text{auto-PFM, low BW case} \end{split}$	-3.0%		3.5%	
6.1.9	R <sub>FB_INPUT</sub>	Feedback input impedance	Converter enabled	2.3	3.75	5.0	МΩ
6.2.1a	V <sub>LOAD_REG_PWM</sub>	DC Load Regulation, forced PWM, low BW case	V <sub>IN</sub> = 5.0V, V <sub>OUT</sub> = 1.2V, I <sub>OUT</sub> = 0 to I <sub>OUT_MAX</sub> , forced PWM, low BW case		0.1	0.16	%/A
6.2.2a	V <sub>LINE_REG</sub>	DC Line Regulation, forced PWM, low BW case	$\begin{array}{l} V_{IN}=3.3V \text{ to } 5.5V, \\ V_{OUT}=1.2V, \\ I_{OUT}=1\text{mA and } I_{OUT\_MAX} \\ \text{forced PWM, low BW case, } C_{OUT}=40\mu\text{F} \end{array}$		0.1	0.16	%/V
6.2.3a	VLOAD_TRANSIENT	Load Transient, V <sub>OUT</sub> =0.75V, auto-PFM, high BW case	$\begin{split} &V_{\text{IN}} = 5.0\text{V}, V_{\text{OUT}} = 0.75\text{V}, \\ &I_{\text{OUT}} = 100\text{mA to } 1100\text{mA to} \\ &100\text{mA}, \\ &t_{\text{R}} = t_{\text{F}} = 500\text{ns}, \\ &\text{auto-PFM, high BW case, } C_{\text{OUT}} = \\ &80\mu\text{F} \end{split}$	-27.5		27.5	mV
6.2.3b	V <sub>LOAD_</sub> TRANSIENT	Load Transient, V <sub>OUT</sub> =0.75V, forced PWM, high BW case	$\begin{array}{l} V_{IN}=5.0\text{V, } V_{OUT}=0.75\text{V,} \\ I_{OUT}=100\text{mA to } 1100\text{mA to} \\ 100\text{mA,} \\ t_{R}=t_{F}=500\text{ns,} \\ \text{forced PWM, high BW case, } C_{OUT}=80~\mu\text{F} \end{array}$	-27.5		27.5	mV



# 5.7 BUCK2, BUCK3 Converter (続き)

over operating free-air temperature range (unless otherwise noted)

POS		mperature range (unless otherwis	TEST CONDITIONS	MIN	TYP	MAX	UNIT
6.2.4a	V <sub>LOAD_TRANSIENT</sub>	Load Transient, V <sub>OUT</sub> =1.8V, auto- PFM, low BW case	$V_{IN}$ = 5.0V, $V_{OUT}$ = 1.8V, $I_{OUT}$ = 1mA to 1A to 1mA, $t_R$ = $t_F$ = 1 $\mu$ s, auto-PFM, $C_{OUT}$ = 40 $\mu$ F	-90		90	mV
6.2.4b	VLOAD_TRANSIENT	Load Transient, V <sub>OUT</sub> =1.8V, forced PWM, low BW case	$\begin{split} &V_{\text{IN}} = 5.0\text{V, } V_{\text{OUT}} = 1.8\text{V,} \\ &I_{\text{OUT}} = 1\text{mA to 1A to 1mA,} \\ &t_{\text{R}} = t_{\text{F}} = 1\mu\text{s,} \\ &\text{forced PWM, } C_{\text{OUT}} = 40\mu\text{F} \end{split}$	-60		60	mV
6.2.5a	V <sub>LINE_</sub> TRANSIENT	Line Transient, V <sub>OUT</sub> =1.2V, forced PWM, low BW case	$V_{IN}$ = 3.3V to 5.5V in 50 $\mu$ s, $V_{OUT}$ = 1.2V, $I_{OUT}$ = 1mA and $I_{OUT\_MAX}$ , forced PWM, low BW case, $C_{OUT}$ = 40 $\mu$ F	-50		50	mV
6.2.6a	V <sub>RIPPLE_PP_PWM</sub>	Forced PWM Mode, low BW case	$\begin{aligned} &V_{\text{IN}} = 5.0\text{V, } V_{\text{OUT}} = 2.5\text{V,} \\ &\text{forced PWM, low BW case, } C_{\text{OUT}} = \\ &40\text{uF, X5R, ESR} = 10\text{mOhm,} \\ &L = 470\text{nH, DCR} = 50\text{m}\Omega \\ &I_{\text{OUT}} = 1\text{A} \end{aligned}$		10	20	$mV_PP$
6.2.6b	V <sub>RIPPLE_PP_PFM</sub>	Auto PFM Mode, low BW case	$\begin{split} &V_{\text{IN}} = 5.0\text{V},  V_{\text{OUT}} = 2.5\text{V}, \\ &\text{auto PFM, low BW case, } C_{\text{OUT}} = \\ &40\text{uF, X5R, ESR} = 10\text{mOhm,} \\ &\text{L} = 470\text{nH, DCR} = 50\text{m}\Omega \\ &\text{I}_{\text{OUT}} = 20\text{mA} \end{split}$		20	40	$mV_PP$
6.3.1	I <sub>OUT_MAX</sub>	Maximum Operating Current				2.0	Α
6.3.2	I <sub>CURRENT_LIMIT</sub>	Peak Current Limit	V <sub>IN</sub> = 2.5V to 5.5V	3.1	3.9	4.7	Α
6.3.3	I <sub>REV_CUR_LIMIT</sub>	Reverse Peak Current Limit	V <sub>IN</sub> = 2.5V to 5.5V	-2.0	-1.5	-1.0	Α
6.3.4a	R <sub>DSON_HS</sub>	High Side MOSFET On Resistance, 5V-supply	Measured Pin to Pin, V <sub>IN</sub> = 5V			110	mΩ
6.3.4b	R <sub>DSON_HS</sub>	High Side MOSFET On Resistance, 3.3V-supply	Measured Pin to Pin, V <sub>IN</sub> = 3.3V			135	mΩ
6.3.5a	R <sub>DSON_LS</sub>	Low Side MOSFET On Resistance, 5V-supply	Measured Pin to Pin, V <sub>IN</sub> = 5V			110	mΩ
6.3.5b	R <sub>DSON_LS</sub>	Low Side MOSFET On Resistance, 3.3V-supply	Measured Pin to Pin, V <sub>IN</sub> = 3.3V			130	mΩ
6.3.6	R <sub>DISCHARGE</sub>	Output Discharge Resistance	Active only when converter is disabled	60	125	200	Ω
6.4.1	L <sub>SW</sub>	Output Inductance	DCR = 50mΩ max	330	470	611	nΗ
6.4.2a	C <sub>OUT</sub>	Output Capacitance in auto-PFM or forced PWM for low BW case	ESR = 10mΩ max	10		75	μF
6.4.3a	C <sub>OUT_HIGH_BW</sub>	Output Capacitance in auto-PFM or forced PWM for high BW case	ESR = 10mΩ max	30		220	μF
Timing	Requirements						
6.5.1	t <sub>RAMP</sub>	Ramp Time in quasi-fixed-frequency mode	Time from enable to 98% of target value, assuming no residual voltage	0.3		1.65	ms
6.5.2a	DVFS_SLOPE_ QFF	DVFS timing requirements in forced PWM, low BW case	Step-duration during DVFS voltage adjustments from 0.6V to 1.4V	2.9	3.2	3.5	mV/μs
Switchi	ng Characteristics	· · · · · · · · · · · · · · · · · · ·					
6.5.2c	DVFS_FALL	DVFS timing requirements in forced PWM, falling slope	Step-duration during DVFS voltage adjustments from 1.4V to 0.6V	0.45	0.53	0.61	mV/μs
6.6.1a	f <sub>SW</sub>	Switching Frequency, forced PWM, high or low BW case	Forced PWM, V <sub>IN</sub> = 3.3V to 5V, V <sub>OUT</sub> = 0.8V to 1.8V, I <sub>OUT</sub> = 1A to 1.8A		2.3		MHz

(1) PVIN\_Bx must not exceed VSYS

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(2) Refers to DC-regulation only. Transient response may require more headroom. With low headroom, the frequency variation increases for quasi-fixed frequency.

## 5.8 General Purpose LDOs (LDO1, LDO2)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Electric	al Characteristics						
7.1.1	V <sub>IN_LDO</sub>	Input Voltage (LDO-mode) <sup>(1)</sup>	LDO-mode, maximum VSYS	1.5		5.5	V
7.1.2	V <sub>IN_LDO_BYP</sub>	Input Voltage (bypass-mode) <sup>(1) (5)</sup>	Bypass-mode, maximum VSYS	1.5		3.4	V
7.1.3	V <sub>IN_LDO_LSW</sub>	Input Voltage (LSW-mode) <sup>(1)</sup>	LSW-mode, maximum VSYS	1.5		5.5	V
7.1.4	V <sub>OUT_LDO</sub>	LDO Output Voltage configurable Range	LDO mode, with 50-mV steps, $V_{\text{IN}}$ - $V_{\text{OUT}}$ > 300 mV	0.6		3.4	V
7.1.5	V <sub>OUT_LDO_BYP</sub>	LDO Output Voltage configurable Range in bypass-mode	Bypass mode, configurable V <sub>OUT</sub> range with 50-mV steps	1.5		3.4	V
7.1.6	V <sub>OUT_STEP</sub>	Output Voltage Steps	LDO mode, 0.6V ≤ V <sub>OUT</sub> ≤ 3.4V		50		mV
7.1.7	V <sub>DROPOUT</sub>	Dropout Voltage	$V_{INmin} \le V_{IN} \le V_{INmax}$ , $I_{OUT} = 400$ mA		150	300	mV
7.1.8	Vout_accuracy_	Total DC Output Voltage accuracy, including Voltage References, DC load and line regulations, process and temperature variations	LDO-mode, $V_{IN}$ - $V_{OUT}$ > 300 mV, $V_{OUT}$ ≥ 1V	-1%		1%	
7.1.9	Vout_accuracy_L	Total DC Output Voltage accuracy, including Voltage References, DC load and line regulations, process and temperature variations	LDO-mode, V <sub>IN</sub> - V <sub>OUT</sub> > 300 mV, V <sub>OUT</sub> < 1V	-10		10	mV
7.1.10	R <sub>BYPASS_H</sub>	Bypass Resistance, high output voltage	$2.5 \text{ V} \le \text{V}_{\text{IN}} \le 3.6 \text{ V}, \text{V}_{\text{IN}} \le \text{VSYS},$ $\text{I}_{\text{OUT}} = 400 \text{ mA, bypass-mode}$			200	mΩ
7.1.11	R <sub>BYPASS_L</sub>	Bypass Resistance, low output voltage	$1.5 \text{ V} \le \text{V}_{\text{IN}} \le 2.5 \text{ V}, \text{V}_{\text{IN}} \le \text{VSYS},$ $\text{I}_{\text{OUT}} = 400 \text{ mA, bypass-mode}$			250	mΩ
7.1.12	R <sub>LSW_H</sub>	LSW Resistance, high output voltage	$2.5~\text{V} \leq \text{V}_{\text{IN}} \leq 5.5~\text{V},~\text{V}_{\text{IN}} \leq \text{VSYS},\\ \text{I}_{\text{OUT}} = 400~\text{mA, LSW-mode}$			200	mΩ
7.1.13	R <sub>LSW_L</sub>	LSW Resistance, low output voltage	$\begin{aligned} 1.5 \text{ V} \leq \text{V}_{\text{IN}} \leq 2.5 \text{ V}, \text{V}_{\text{IN}} \leq \text{VSYS}, \\ \text{I}_{\text{OUT}} = 400 \text{ mA, LSW-mode} \end{aligned}$			250	mΩ
7.2.1	V <sub>LOAD_TRANSIENT</sub>	Transient Load Regulation, ΔVOUT	$I_{OUT}$ = 20% to 80% to 20% of $I_{OUT\_MAX}$ , $t_r$ = $t_f$ = 1 $\mu s$	-35		35	mV
7.2.2	V <sub>LINE_TRANSIENT</sub>	Transient Line Regulation	$V_{IN}$ step = 600 mV <sub>PP</sub> , $t_R$ = $t_F$ = 10 $\mu$ s, LDO not in dropout condition, LDO-mode	-25		25	mV
7.2.3	NOISE <sub>RMS</sub>	RMS Noise	100 Hz < f $\leq$ 100 kHz, V <sub>IN</sub> = 3.3 V, V <sub>OUT</sub> = 1.8 V, I <sub>OUT</sub> = 300 mA		600		$\mu V_{RMS}$
7.2.4	V <sub>RIPPLE</sub>	Voltage Ripple				5	$mV_{PP}$
7.3.1	I <sub>OUT_MAX</sub>	Output Current	$\begin{aligned} &V_{PVIN\_LDOxmin} \leq V_{IN} \leq V_{PVIN\_LDOxmax}, \\ &Applies to LDO-, bypass- and LSW- \\ &mode \end{aligned}$			400	mA
7.3.2	I <sub>CURRENT_LIMIT</sub>	Short Circuit Current Limit	V <sub>IN</sub> = 3.6V, V <sub>OUT</sub> = 0V	600	980	1600	mA
7.3.3	I <sub>IN_RUSH_LDO</sub>	LDO Inrush Current	LDO-mode, with maximum 20-μF load connected to VLDOx, , I <sub>OUT</sub> = 0 mA or 400mA			1500	mA
7.3.4	I <sub>IN_RUSH_LDO_BYP</sub>	LDO Inrush Current in bypass-mode	Bypass-mode, with maximum 50-μF load connected to VLDOx			1500	mA
7.3.5	I <sub>IN_RUSH_LDO_LSW</sub>	LDO Inrush Current in LSW-mode	LSW-mode, with maximum 50-μF load connected to VLDOx			1500	mA
7.3.6	R <sub>DISCHARGE</sub>	Pulldown Discharge Resistance at LDO Output	Active only when converter is disabled. Applies to LDO-, bypass- and LSW-mode	100	200	300	Ω

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# 5.8 General Purpose LDOs (LDO1, LDO2) (続き)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
7.3.7a	I <sub>Q_ACTIVE_LDO</sub>	Quiescent Current in ACTIVE state at 25°C, LDO-mode	LDO-mode, I <sub>OUT</sub> = 0 mA, T <sub>J</sub> = 25°C		50	62	μΑ
7.3.7b	I <sub>Q_ACTIVE_LDO</sub>	Quiescent Current in ACTIVE state -40°C to 125°C, LDO-mode	LDO-mode, I <sub>OUT</sub> = 0 mA, T <sub>J</sub> = -40°C to 125°C		50	65	μΑ
7.3.7b	I <sub>Q_ACTIVE_LDO</sub>	Quiescent Current in ACTIVE state -40°C to 150°C, LDO-mode	LDO-mode, I <sub>OUT</sub> = 0 mA, T <sub>J</sub> = -40°C to 150°C		50	66	μА
7.3.8a	I <sub>Q_ACTIVE_LDO_BY</sub>	Quiescent Current in ACTIVE state at 25°C, bypass-mode	bypass-mode, I <sub>OUT</sub> = 0 mA, T <sub>J</sub> = 25°C		43	48	μΑ
7.3.8b	I <sub>Q_ACTIVE_LDO_BY</sub>	Quiescent Current in ACTIVE state -40°C to 125°C, bypass-mode	bypass-mode, I <sub>OUT</sub> = 0 mA, T <sub>J</sub> = -40°C to 125°C		43	50	μΑ
7.3.8b	IQ_ACTIVE_LDO_BY	Quiescent Current in ACTIVE state -40°C to 150°C, bypass-mode	bypass-mode, I <sub>OUT</sub> = 0 mA, T <sub>J</sub> = -40°C to 150°C		43	50	μΑ
7.3.9a	I <sub>Q_ACTIVE_LDO_LS</sub>	Quiescent Current in ACTIVE state at 25°C, LSW-mode	LSW-mode, I <sub>OUT</sub> = 0 mA, T <sub>J</sub> = 25°C		46	53	μΑ
7.3.9b	I <sub>Q_ACTIVE_LDO_LS</sub>	Quiescent Current in ACTIVE state -40°C to 125°C, LSW-mode	LSW-mode, I <sub>OUT</sub> = 0 mA, T <sub>J</sub> = -40°C to 125°C		46	53	μΑ
7.3.9b	IQ_ACTIVE_LDO_LS	Quiescent Current in ACTIVE state -40°C to 150°C, LSW-mode	LSW-mode, I <sub>OUT</sub> = 0 mA, T <sub>J</sub> = -40°C to 150°C		46	54	μА
7.4.1	C <sub>IN</sub>	Input Filtering Capacitance (2)	Connected from PVIN_LDOx to GND Applies to LDO-, bypass- and LSW-mode	1.6	2.2		μF
7.4.2	C <sub>OUT</sub>	Output Filtering Capacitance <sup>(3)</sup>	Connected from VLDOx to GND, LDO-mode	1.6	2.2	4	μF
7.4.3	C <sub>OUT_TOTAL</sub>	Total Capacitance at Output (Local + POL), LDO-mode <sup>(4)</sup>	1 MHz < f < 10 MHz			20	μF
7.4.4	C <sub>OUT_TOTAL_BYP</sub>	Total Capacitance at Output (Local + POL), bypass-mode <sup>(4)</sup>	1 MHz < f < 10 MHz			50	μF
7.4.5	C <sub>OUT_TOTAL_LSW</sub>	Total Capacitance at Output (Local + POL), LSW-mode <sup>(4)</sup>	1 MHz < f < 10 MHz			50	μF
7.4.6	C <sub>ESR</sub>	Filtering capacitor ESR max	1 MHz < f < 10 MHz		10	20	mΩ
Timing	Requirements	1					
7.5.1	tramp	Ramp Time LDO in LDO- and bypass-mode	Measured from enable to 98% of target value, LDO-mode or bypass-mode, measured when enabled individually, assuming no residual voltage			950	µs
7.5.2	t <sub>RAMP_SLEW</sub>	Ramp up Slew Rate in LDO- and bypass-mode	V <sub>OUT</sub> from 0.3 V to 90% of V <sub>OUT</sub>			12	mV/μs
7.5.3	t <sub>RAMP_LSW</sub>	Ramp Time LSW-mode	Measured from enable to target value, LSW-mode, assuming no residual voltage			1250	μs

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## 5.8 General Purpose LDOs (LDO1, LDO2) (続き)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
7.5.4	t <sub>RAMP_SLEW</sub>	Ramp up Slew Rate in LSW-mode	V <sub>OUT</sub> from 0.3 V to 90% of V <sub>OUT</sub>			12	mV/μs
7.5.5	t <sub>TRANS_1P8_3P3</sub>	Transition Time 1.8V - 3.3V	V <sub>IN</sub> = 4.0V, I <sub>OUT</sub> = 300mA		2		ms
7.5.6	t <sub>TRANS_3P3_1P8</sub>	Transition Time 3.3V - 1.8V	V <sub>IN</sub> = 4.0V, I <sub>OUT</sub> = 300mA		2		ms

- (1) PVIN LDOx must not exceed VSYS
- (2) Input capacitors must be placed as close as possible to the device pins.
- (3) When DC voltage is applied to a ceramic capacitor, the effective capacitance is reduced due to DC bias effect. The table above therefore lists the minimum value as CAPACITANCE. In order to meet the minimum capacitance requirement, the nominal value of the capacitor may have to be scaled accordingly to take the drop of capacitance into account for a given dc voltage at the outputs of regulators.
- (4) Additional capacitance, including local and POL, beyond the specified value can cause the LDO to become unstable
- (5) PVIN\_LDOx voltage must be within (configured VOUT) and (configured VOUT + 200mV), maximum 3.6V.

## 5.9 General Purpose LDOs (LDO3, LDO4)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Electric	cal Characteristics						
8.1.1	V <sub>IN</sub>	Input Voltage (LDO-mode) (1)	LDO-mode, maximum V <sub>VSYS</sub>	2.2		5.5	V
8.1.2	V <sub>IN</sub>	Input Voltage (LSW-mode) (1)	LSW-mode, maximum V <sub>VSYS</sub>	2.2		5.5	V
8.1.3	V <sub>OUT</sub>	LDO Output Voltage configurable Range	V <sub>IN</sub> = 2.2V to 5.5V, maximum V <sub>VSYS</sub>	1.2		3.3	V
8.1.4	V <sub>OUT_STEP</sub>	Output voltage Steps	1.2V ≤ V <sub>OUT</sub> ≤ 3.3V		50		mV
8.1.5	V <sub>DROPOUT</sub>	Dropout Voltage	$V_{INmin} \le V_{IN} \le V_{INmax}, I_{OUT} = I_{OUTmax}$		150	300	mV
8.1.6	V <sub>OUT_DC_ACCURA</sub>	Total DC accuracy including DC load and line regulation for all valid output voltages	LDO-mode, V <sub>IN</sub> - V <sub>OUT</sub> > 300 mV	-1%		1%	
8.1.7	R <sub>BYPASS</sub>	Bypass resistance in LSW-mode	V <sub>IN</sub> = 3.3V, I <sub>OUT</sub> = 100mA, Loadswitch-mode enabled			1	Ω
8.2.1	V <sub>LOAD_TRANSIENT</sub>	Transient load regulation, ΔV <sub>OUT</sub>	$V_{IN}$ = 3.3V, $V_{OUT}$ = 1.80V, $I_{OUT}$ = 20% of $I_{OUT\_MAX}$ to 80% of $I_{OUT\_MAX}$ in 1µs, $C_{OUT}$ = 2.2µF	-25		25	mV
8.2.2	V <sub>LINE_TRANSIENT</sub>	Transient line regulation, ΔVOUT / VOUT	On mode, not under dropout condition, $V_{IN}$ step = 600 m $V_{PP}$ , $t_r$ = $t_f$ = 10 $\mu$ s	-25		25	mV
8.2.3	NOISE <sub>RMS</sub>	RMS Noise	LDO-mode, f=100Hz to 100KHz, V <sub>IN</sub> = 3.3V, V <sub>OUT</sub> = 1.8V, I <sub>OUT</sub> = 300mA		15		$\mu V_{RMS}$
8.2.4	PSRR <sub>1KHZ</sub>	Power Supply Ripple Rejection	LDO-mode, V <sub>IN</sub> = 3.3V, V <sub>OUT</sub> = 1.8V, I <sub>OUT</sub> = 300mA		71		db
8.2.5	PSRR <sub>10KHZ</sub>	Power Supply Ripple Rejection	LDO-mode, V <sub>IN</sub> = 3.3V, V <sub>OUT</sub> = 1.8V, I <sub>OUT</sub> = 300mA		64		db
8.2.6	PSRR <sub>100KHZ</sub>	Power Supply Ripple Rejection	LDO-mode, V <sub>IN</sub> = 3.3V, V <sub>OUT</sub> = 1.8V, I <sub>OUT</sub> = 300mA		61		db
8.2.7	PSRR <sub>1MHZ</sub>	Power Supply Ripple Rejection	LDO-mode, V <sub>IN</sub> = 3.3V, V <sub>OUT</sub> = 1.8V, I <sub>OUT</sub> = 300mA		26		db
8.3.1	I <sub>OUT</sub>	Output Current				300	mA
8.3.2	I <sub>CURRENT_LIMIT</sub>	Short Circuit Current Limit	V <sub>IN</sub> = 3.6V, V <sub>OUT</sub> = 0V, Tested under a pulsed load condition	400		900	mA
8.3.3	I <sub>IN_RUSH</sub>	LDO inrush current	LDO- or LSW-mode, $V_{\rm IN}$ = 3.3V and then LDO is enabled, $C_{\rm OUT}$ = 4 $\mu$ F, $I_{\rm OUT}$ = 0 mA or 300mA			650	mA

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## 5.9 General Purpose LDOs (LDO3, LDO4) (続き)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
8.3.4	R <sub>DISCHARGE</sub>		Active only when converter is disabled	120	250	400	Ω
8.3.5a	I <sub>Q_ACTIVE</sub>	Quiescent Current in ACTIVE state at 25°C	$V_{VSYS} = V_{IN} = 3.3 \text{ V}, I_{OUT} = 0 \text{ mA}$ Applies to LDO-mode, $T_J = 25^{\circ}\text{C}$		25	30	μА
8.3.5b	I <sub>Q_ACTIVE</sub>	Quiescent Current in ACTIVE state -40°C to 125°C	$V_{VSYS} = V_{IN} = 3.3 \text{ V, } I_{OUT} = 0 \text{ mA}$ Applies to LDO-mode, $T_{J} = -40^{\circ}\text{C}$ to 125°C		25	40	μA
8.3.5b	I <sub>Q_ACTIVE</sub>	Quiescent Current in ACTIVE state -40°C to 150°C	$V_{VSYS} = V_{IN} = 3.3 \text{ V, } I_{OUT} = 0 \text{ mA,}$ Applies to LDO-mode, $T_J = -40^{\circ}\text{C}$ to 150°C		25	40	μA
8.3.5c	I <sub>Q_ACTIVE</sub>	Quiescent Current in ACTIVE state at 25°C	$V_{VSYS} = V_{IN} = 3.3 \text{ V, } I_{OUT} = 0 \text{ mA}$ Applies to LSW-mode, $T_J = 25^{\circ}\text{C}$		60	112	μA
8.3.5d	I <sub>Q_ACTIVE</sub>	Quiescent Current in ACTIVE state -40°C to 125°C	$V_{VSYS} = V_{IN} = 3.3 \text{ V, } I_{OUT} = 0 \text{ mA}$ Applies to LSW-mode, $T_J = -40^{\circ}\text{C}$ to 125°C		70	145	μА
8.3.5d	I <sub>Q_ACTIVE</sub>	Quiescent Current in ACTIVE state -40°C to 150°C	$V_{VSYS} = V_{IN} = 3.3 \text{ V, } I_{OUT} = 0 \text{ mA,}$ Applies to LSW-mode, $T_J = -40^{\circ}\text{C}$ to 150°C		70	145	μA
8.4.1	C <sub>IN</sub>	Input Filtering Capacitance (2)		2.2	4.7		μF
8.4.2	C <sub>OUT</sub>	Output Filtering Capacitance (2)	Connected from VLDOx to GND, LDO-mode	1.6	2.2	4	μF
8.4.3a	C <sub>OUT_TOTAL_FAST</sub>	Total Capacitance at Output (Local + POL), fast ramp-time (3)	1 MHz < f < 10 MHz, impedance between output and point-of-load maximum 6nH			15	μF
8.4.3b	C <sub>OUT_TOTAL_SLOW</sub>	Total Capacitance at Output (Local + POL), slow ramp-time (3)	1 MHz < f < 10 MHz, impedance between output and point-of-load maximum 6nH			30	μF
8.4.4	C <sub>ESR</sub>	Filtering capacitor ESR max	1MHz to 10MHz		10	20	mΩ
Timing	Requirements						
8.5.1a	t <sub>RAMP_FAST</sub>	Ramp Time fast	Measured from enable to 98% of target value, LDO-mode, measured when enabled individually, assuming no residual voltage			660	μs
8.5.1b	t <sub>RAMP_SLOW</sub>	Ramp Time slow	Measured from enable to 98% of target value, LDO-mode, measured when enabled individually, assuming no residual voltage			2.3	ms
8.5.2a	t <sub>RAMP_SLEW_FAST</sub>	Ramp Up Slew Rate fast	LDO- or LSW-mode, measured from 0.5V to target value			25	mV/μs
8.5.2b	t <sub>RAMP_SLEW_SLOW</sub>	Ramp Up Slew Rate slow	LDO- or LSW-mode, measured from 0.5V to target value			9	mV/μs

<sup>(1)</sup> PVIN\_LDOx must not exceed VSYS

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<sup>(2)</sup> When DC voltage is applied to a ceramic capacitor, the effective capacitance is reduced due to DC bias effect. The table above therefore lists the minimum value as CAPACITANCE. In order to meet the minimum capacitance requirement, the nominal value of the capacitor may have to be scaled accordingly to take the drop of capacitance into account for a given dc voltage at the outputs of regulators.

<sup>(3)</sup> Additional capacitance, including local and POL, beyond the specified value can cause the LDO to become unstable



# 5.10 GPIOs and multi-function pins (EN/PB/VSENSE, nRSTOUT, nINT, GPO1, GPO2, GPIO, MODE/RESET, MODE/STBY, VSEL\_SD/VSEL\_DDR)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Electric	al Characteristics						
9.1.1	V <sub>OL</sub>	Low-level Output Voltage (open-drain)	VIO = 3.6V, I <sub>OL</sub> = 2mA, GPO1, GPO2, GPIO, nRSTOUT, nINT			0.40	V
9.1.2	V <sub>IL</sub>	Low-level Input Voltage	EN/PB, MODE/STBY, MODE/ RESET and VSEL_SD/VSEL_DDR, GPIO			0.4	V
9.1.3	V <sub>IH</sub>	High-level Input Voltage	EN/PB, MODE/STBY, MODE/ RESET and VSEL_SD/VSEL_DDR, GPIO	1.26			V
9.1.4	V <sub>VSENSE</sub>	VSENSE Comparator Threshold (EN/PB/VSENSE)		1.08	1.20	1.32	V
9.1.5	V <sub>VSENSE_HYS</sub>	VSENSE Comparator Hysteresis (EN/PB/VSENSE)		8	30	55	mV
9.1.6	I <sub>LKG</sub>	Input leakage current (GPIO, EN/PB/VSENSE, MODE/STBY, MODE/RESET, VSEL_SD/VSEL/ DDR)	V <sub>IN</sub> = 3.3 V			1.0	μΑ
9.1.7	C <sub>IN</sub>	Internal input pin capacitance (GPIO, EN/PB/ VSENSE, MODE/STBY, MODE/ RESET, VSEL_SD/VSEL/DDR)				10	pF
9.1.8	I <sub>PD</sub>	pull-down current, available 100us after VSYS is applied	on pins GPO1, GPO2, GPIO, MODE/STBY, MODE/RESET, VSEL_SD/VSEL_DDR, nINT, nRSTOUT	18	25	35	nA
9.1.9	I <sub>LKG_VSYS_ONLY</sub>	Pin leakage when VSYS is present, but digital supply VDD1P8 is not	SDA only			1	μΑ
9.1.10	V <sub>PIN_VSYS_ONLY</sub>	Pin voltage when VSYS is present, but digital supply VDD1P8 is not	GPO1, GPO2, GPIO, nRSTOUT, nINT, I <sub>OL</sub> =2mA			0.4	V
Timing	Requirements					,	
9.2.1a	t <sub>FALL</sub>	Output buffer fall time (90% to 10%)	GPO1, GPO2, GPIO, nRSTOUT, nINT, C <sub>OUT</sub> = 10pF			50	ns
9.2.1b	t <sub>RISE</sub>	GPIO Output buffer rise time (10% to 90%)	GPIO, applicable in Multi-PMIC-configuration			5	μs
9.2.1.1	t <sub>DLY_FALL</sub>	Output buffer falling time delay (input crossing 50% to output crossing 50%)	C <sub>OUT</sub> = 10pF			50	ns
9.2.2.1	t <sub>DLY_RISE</sub>	Open Drain Output buffer rising time delay (digital input to output crossing 50%)	C <sub>OUT</sub> = 10pF, R <sub>PU</sub> =1k (external pull up), VIO = 1.8V			300	ns
9.2.2.3	FLT_HIGH <sub>Duration</sub>	Time the digital has allotted for the test to see if the pin can be pulled high internally	C <sub>OUT</sub> = 10pF	15			μs
9.2.2.4	FLT_LOW <sub>Duration</sub>	Time the digital has allotted for the test to see if the pin can be pulled low internally	C <sub>OUT</sub> = 10pF	15			μs
9.2.2a	t <sub>PB_ON_SLOW</sub>	EN/PB/VSENSE, Wait Time PB, ON request, slow	PB, falling Edge	540	600	660	ms
9.2.2b	t <sub>PB_ON_FAST</sub>	EN/PB/VSENSE, Wait Time PB, ON request, fast	PB, falling Edge	180	200	220	ms

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# 5.10 GPIOs and multi-function pins (EN/PB/VSENSE, nRSTOUT, nINT, GPO1, GPO2, GPIO, MODE/RESET, MODE/STBY, VSEL\_SD/VSEL\_DDR) (続き)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
9.2.3	t <sub>PB_OFF</sub>	EN/PB/VSENSE, Wait Time PB, OFF request	PB, falling Edge	7.2	8.0	8.8	s
9.2.4	t <sub>PB_RISE_DEGL</sub>	EN/PB/VSENSE, Deglitch time PB, rising edge	PB, rising Edge, applicable after the successful long-press-OFF-request	115	200	275	ms
9.2.5	t <sub>PB_INT_DEGL</sub>	EN/PB/VSENSE, Deglitch time PB, rising or falling edge	PB, rising or falling Edge	59	100	137	ms
9.2.6	t <sub>DEGL_EN_Rise_Slow</sub>	EN/PB/VSENSE, DeglitchTime EN slow, rising	EN, rising Edge	45	50	55	ms
9.2.7	t <sub>DEGL_EN_Rise_Fast</sub>	EN/PB/VSENSE, DeglitchTime EN fast, rising	EN, rising Edge	60	120	150	μs
9.2.8	t <sub>DEGL_EN_Fall</sub>	EN/PB/VSENSE, DeglitchTime EN, falling	EN, falling Edge	50	70	93	μs
9.2.9	t <sub>DEGL_VSENSE_Rise</sub>	VSENSE rising: only gated by VSYS <sub>POR_Rising</sub> and VSENSE-voltage	VSENSE, rising Edge		N/A		
9.2.10	t <sub>DEGL_VSENSE_Fall</sub>	EN/PB/VSENSE, DeglitchTime VSENSE, falling, regardless of fast/ slow setting	VSENSE, falling Edge	50	70	93	μs
9.2.11	t <sub>DEGL_EN/</sub> VSENSE_I2C	EN/VSENSE falling edge deglitch time after I2C-triggered shutdown	EN/VSENSE falling edge after previous shutdown request by I2C (shorter than 9.2.8)	12.5	25	37.5	μs
9.2.12	t <sub>DEGL_RESET</sub>	MODE/RESET, Deglitch Time RESET	RESET, rising and falling Edge	90	120	150	μs
9.2.13	t <sub>DEGL_MFP</sub>	Deglitch Time MODE/STBY, MODE(not/RESET), VSEL_SD/ VSEL_DDR	Rising and falling Edge	90	120	150	μs
9.2.14	t <sub>DEGL_GPIO</sub>	Deglitch Time GPIO	Rising and falling Edge	6.6	15.6	18	μs
9.2.15	t <sub>REACTION_ON</sub>	ON-request propagation delay (after deglitch)	Includes oscillator startup, sampling delay and reaction delay (excluding deglitch)		75	103	μs
9.2.16	t <sub>REACTION_OFF</sub>	OFF-request propagation delay (after deglitch)	Includes sampling delay and reaction delay (excluding deglitch)	39	56	73.5	μs

### **5.11 Voltage and Temperature Monitors**

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT		
Electric	cal Characteristics				-5% -10%			
10.1.1	V <sub>BUCKx_UV_TH_5</sub> , V <sub>LDOx_UV_TH_5</sub>	Undervoltage monitoring for buck output, programable low-going threshold accuracy	UV_THR = 0x0		-5%			
10.1.2	VBUCKX_UV_TH_10, VLDOX_UV_TH_10	Undervoltage monitoring for buck output and LDO output, programable low-going threshold accuracy	UV_THR = 0x1	-	-10%			
10.1.3	V <sub>BUCKx_UV_H_ACC</sub> , , V <sub>LDOx_UV_H_ACC</sub>	Undervoltage Threshold Accuracy, V <sub>OUT</sub> ≥ 1V	V <sub>OUT</sub> ≥ 1V	-1.5%	+1.5%			
10.1.4	V <sub>BUCKx_UV_L_ACC</sub> , V <sub>LDOx_UV_L_ACC</sub>	Undervoltage Threshold Accuracy, V <sub>OUT</sub> < 1V	V <sub>OUT</sub> < 1V	-10	+10	mV		

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## 5.11 Voltage and Temperature Monitors (続き)

over operating free-air temperature range (unless otherwise noted)

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
10.1.5	V <sub>BUCKx_UV_HYS</sub> , V <sub>LDOx_UV_HYS</sub>	Undervoltage Hysteresis		0.25%	1%	1.75%	
10.1.6	VBUCKx_SCG_TH, VLDOx_SCG_TH	Short-circuit (SCG) and residual voltage (RV) detection low-going threshold		220	260	300	mV
10.1.7	VBUCKx_SCG_HYS, VLDOx_SCG_HYS	Short-circuit (SCG) and residual voltage (RV) detection threshold hysteresis			75		mV
10.2.1a	T <sub>WARM_Rising</sub>	Temperature rising Warning Threshold (WARM)	for each of the four sensors	110	120	130	°C
10.2.1b	T <sub>WARM_Falling</sub>	Temperature falling Warning Threshold (WARM)	for each of the four sensors	105	115	125	°C
10.2.2a	T <sub>HOT_Rising</sub>	Temperature rising Shutdown Threshold (TSD, HOT)	for each of the four sensors	130	140	150	°C
10.2.2b	T <sub>HOT_Falling</sub>	Temperature falling Shutdown Threshold (TSD, HOT)	for each of the four sensors	125	135	145	°C
10.2.3	T <sub>HYS</sub>	Temperature Hysteresis for WARM	for each of the four sensors		<b>-</b> 5		°C
Timing	Requirements			ı			
10.3.1a	t <sub>DEGLITCH</sub>	Fault Detection Deglitch Time for Under Voltage (UV) and Short to GND (SCG)	Measured from UV/SCG event	13	20	27	μs
10.3.1b	t <sub>DEGLITCH_OC_short</sub>	Fault Detection Deglitch Time for Over Current (OC), rising edge, short	Measured from OC event, rising edge	26	35	45	μs
10.3.1c	t_DEGLITCH_OC_long	Fault Detection Deglitch Time for Over Current (OC), rising edge, long	Measured from OC event, rising edge	1.6	2	2.2	ms
10.3.2a	t <sub>REACTION</sub>	Fault Reaction Time for Under Voltage (UV) and Short to GND (SCG) (including deglitch time)	Measured from UV/SCG event to nINT pulled low	26	40	54	μs
10.3.2b	t <sub>REACTION_OC_shor</sub>	Fault Reaction Time for Over Current (OC) (including deglitch time)	Measured from UV/OC/SCG event to nINT pulled low	45	65	81	μs
10.3.2c	tREACTION_OC_long	Fault Detection Deglitch Time for Over Current (OC), rising edge, long	Measured from OC event, rising edge	1.6	2	2.2	ms
10.3.2d	t <sub>REACTION_WARM</sub>	Fault Reaction Time for Temperature Warning (WARM), Thermal Shutdown (TSD / HOT)	Measured from WARM/HOT event to nINT pulled low			525	μs

# 5.12 I<sup>2</sup>C Interface

Over operating free-air temperature range (unless otherwise noted). Device supports standard mode (100 kHz), fast mode (400 kHz), and fast mode+ (1 MHz) when VIO is 3.3V or 1.8V.

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
Electrical Characteristics									
11.1.1	V <sub>OL</sub>	Low-level Output Voltage	VIO = 3.6V, I <sub>OL</sub> = 3mA for Standard mode and Fast mode, I <sub>OL</sub> = 20mA for Fast mode+, SDA			0.40	V		
11.1.2	V <sub>IL</sub>	Low-level Input Voltage	SDA, SCL			0.40	V		
11.1.3	V <sub>IH</sub>	High-level Input Voltage	SDA, SCL	1.26			V		
11.1.4	V <sub>HYST</sub>	Input buffer Hysteresis	EN_BP/VSENSE, MODE_RESET, MODE_STBY, SDA, SCL, GPIO	100		500	mV		

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# 5.12 I<sup>2</sup>C Interface (続き)

Over operating free-air temperature range (unless otherwise noted). Device supports standard mode (100 kHz), fast mode (400 kHz), and fast mode+ (1 MHz) when VIO is 3.3V or 1.8V.

POS		PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
11.1.5	Св	Capacitive Load for SDA and SCL				400	pF
Timing	Requirements						
11.2.1			Standard mode			100	1.11-
11.2.2	$f_{\sf SCL}$	Serial Clock Frequency	Fast mode			400	kHz
11.2.3			Fast mode+			1	MHz
11.3.1			Standard mode	4.7			
11.3.2	t <sub>LOW</sub>	SCL low Time	Fast mode	1.3			μs
11.3.3			Fast mode+	0.50			
11.4.1			Standard mode	4.0			
11.4.2	t <sub>HIGH</sub>	SCL high Time	Fast mode	0.60			μs
11.4.3			Fast mode+	0.26			
11.5.1			Standard mode	250			
11.5.2	t <sub>SU;DAT</sub> Data setup Time	Data setup Time	Fast mode	100			ns
11.5.3			Fast mode+	50			
11.6.1			Standard mode	10		3450	
11.6.2	t <sub>HD;DAT</sub> Da	Data hold Time	Fast mode	10		900	ns
11.6.6			Fast mode+	10			
11.7.1		Setup Time for a Start or a	Standard mode	4.7			
11.7.2	tsu:sta Setup Time for a Start or a REPEATED Start Condition		Fast mode	0.60			μs
11.7.3		Fast mode+	0.26				
11.8.1			Standard mode	4.7			
11.8.2	t <sub>HD;STA</sub>	Hold Time for a Start or a REPEATED Start Condition	Fast mode	0.60			μs
11.8.3		THE EXTENSION OF THE STATE OF T	Fast mode+	0.26			
11.9.1			Standard mode	4.7			
11.9.2	t <sub>BUF</sub>	Bus free Time between a STOP and Start Condition	Fast mode	1.3			μs
11.9.3		Start Condition	Fast mode+	0.50			
11.10.1			Standard mode	0.60			
11.10.2	t <sub>su;sto</sub>	Setup Time for a STOP Condition	Fast mode	0.60			μs
11.10.3			Fast mode+	0.26			
11.10.1			Standard mode, VIO = 1.8V, $R_{PU}$ = 10 k $\Omega$ and $C_B$ = 400 pF			1000	
11.10.2	t <sub>rDA</sub>	Rise Time of SDA Signal	Fast mode, VIO = 1.8V, $R_{PU}$ = 1 k $\Omega$ and $C_B$ = 400 pF	20		300	ns
11.10.3			Fast mode+, VIO = 1.8V, $R_{PU}$ = 330 $\Omega$ and $C_B$ = 400 pF			120	
11.12.1			Standard mode, VIO = 1.8V, $R_{PU}$ = 10 k $\Omega$ and $C_{B}$ = 400 pF			300	
11.12.2	t <sub>fDA</sub>	Fall Time of SDA Signal	Fast mode, VIO = 1.8V, $R_{PU}$ = 1 k $\Omega$ and $C_B$ = 400 pF	6.5		300	ns
11.12.3			Fast mode+, VIO = 1.8V, $R_{PU}$ = 330 $\Omega$ and $C_B$ = 400 pF	6.5		120	

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## 5.12 I<sup>2</sup>C Interface (続き)

Over operating free-air temperature range (unless otherwise noted). Device supports standard mode (100 kHz), fast mode (400 kHz), and fast mode+ (1 MHz) when VIO is 3.3V or 1.8V.

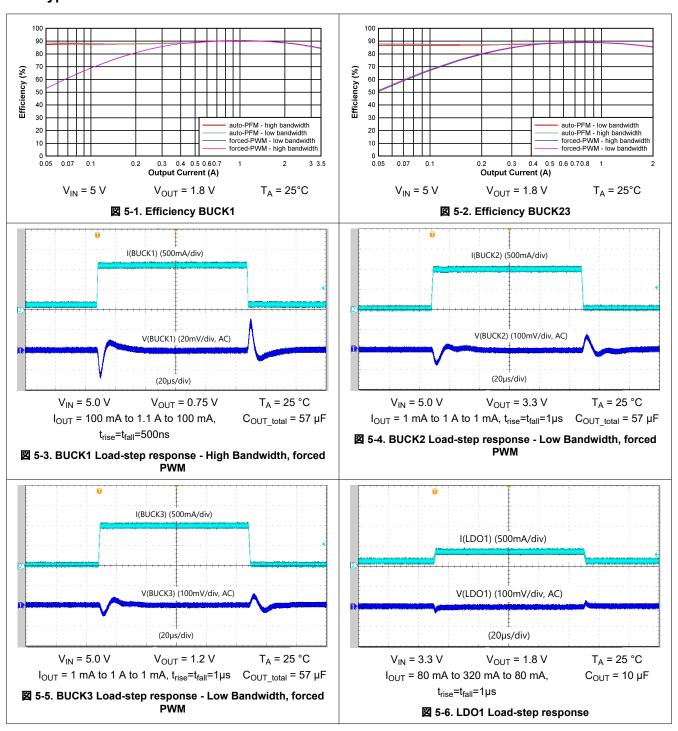
POS		PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT
11.13.1			Standard mode, VIO = 1.8V, $R_{PU}$ = 10 k $\Omega$ and $C_B$ = 400 pF		1000	
11.13.2	t <sub>rCL</sub>	Rise Time of SCL Signal	Fast mode, VIO = 1.8V, $R_{PU}$ = 1 k $\Omega$ and $C_B$ = 400 pF	20	300	ns
11.13.3			Fast mode+, VIO = 1.8V, $R_{PU}$ = 330 $\Omega$ and $C_{B}$ = 400 pF		120	
11.14.1			Standard mode, VIO = 1.8V, $R_{PU}$ = 10 k $\Omega$ and $C_{B}$ = 400 pF		300	
11.14.2	t <sub>fCL</sub>	Fall Time of SCL Signal	Fast mode, VIO = 1.8V, $R_{PU}$ = 1 k $\Omega$ and $C_B$ = 400 pF	6.5	300	ns
11.14.3			Fast mode+, VIO = 1.8V, $R_{PU}$ = 330 $\Omega$ and $C_B$ = 400 pF	6.5	120	
11.15.1	t <sub>SP</sub>	Pulse Width of Spike suppressed (SCL and SDA Spikes that are less than the indicated Width are suppressed)	Fast mode, and fast mode+		50	ns

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Product Folder Links: *TPS6521905*English Data Sheet: SLVSGZ4



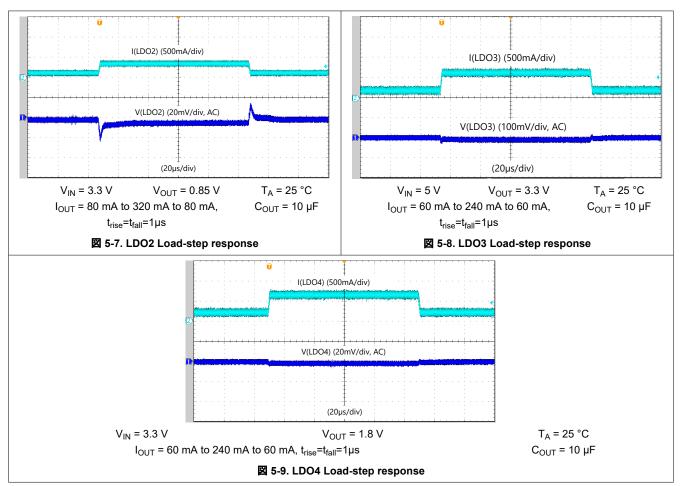
## **5.13 Typical Characteristics**



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## 5.13 Typical Characteristics (continued)



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## 6 Detailed Description

### 6.1 Overview

The TPS6521905 provides three step-down converters, four LDOs, three general-purpose I/Os and three multi-Function pins. The system can be supplied by a single cell Li-Ion battery, two primary cells or a regulated supply. The device is characterized across a -40°C to +105°C temperature range, which makes the PMIC an excellent choice for various industrial applications.

The I2C interface provides comprehensive features for using TPS6521905. All rails, the GPOs and the GPIO can be enabled or disabled. Voltage thresholds for the undervoltage monitoring can be customized.

The integrated voltage supervisor monitors Buck 1–3 and LDO1–4 for undervoltage. The monitor has two sensitivity settings. A power good signal is provided to report the successful ramp of the power rails and GPIOs. The nRSTOUT pin is pulled low until the device enters ACTIVE state. When powering down from ACTIVE- or STBY-state, nRSTOUT is pulled low again. The nRSTOUT pin has an open-drain output. A fault-pin, nINT, notifies the SoC about faults.

Buck1 step-down converter can supply up to 3.5 A of current, Buck2 and Buck3 can supply up to 2 A each. The default output voltages for each converter can be adjusted through the I2C interface. All three buck-converters feature dynamic voltage scaling. The step-down converters operate in a low power mode at light load or can be forced into PWM operation for noise sensitive applications.

LDO1 and LDO2 support output currents of 400 mA at an output voltage range of 0.6 V to 3.4 V. These LDOs support bypass mode, acting as a load-switch, and allow voltage-changes during operation for applications like SD-card-supply, adjusting the IO-supply of the SD-card from 3.3 V to 1.8 V after initialization.

LDO3 and LDO4 support output currents of 300 mA at an output voltage range of 1.2 V to 3.3 V. These LDOs support load-switch-mode, but not bypass mode.

The I2C-interface, IOs, GPIOs, and multi-function-pins (MFP) allow a seamless interface to a wide range of SoCs.

All configurations of the rails, for example output-voltages, sequencing, are backed up by EEPROM. Please refer to the Technical Reference Manual (TRM) of the chosen configuration.

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### 6.2 Functional Block Diagram

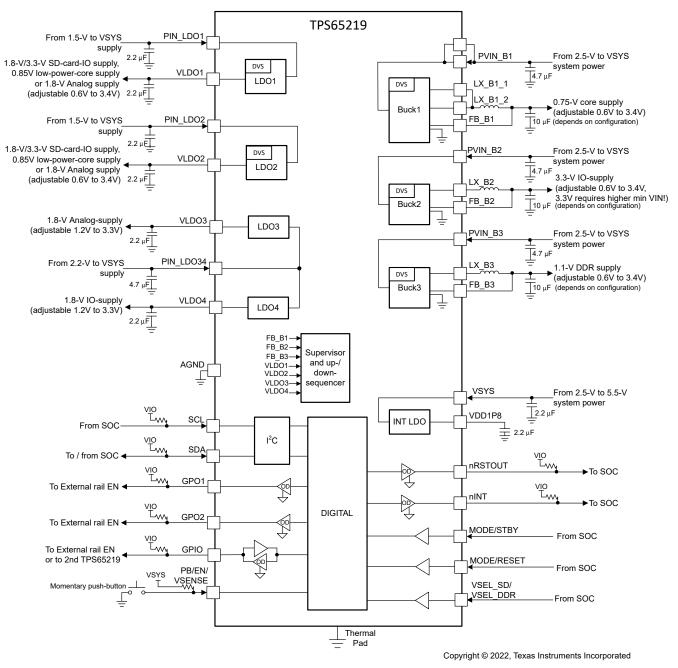


図 6-1. Functional Block Diagram

注

VIO is the external pull-up supply that must be selected within the recommended operating voltage range.

Product Folder Links: TPS6521905

## 6.3 Feature Description

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### 6.3.1 Power-Up Sequencing

The TPS6521905 allows flexible sequencing of the rails. The order of the rails, including GPO1, GPO2, GPIO for the external rails, and the nRSTOUT pin is defined by the NVM. Prior to starting the power-up sequence, the device checks if the voltage on all rails fell below the SCG-threshold to avoid starting into a pre-biased rail. The sequence is timing based. In addition, the previous rail must have passed the UV-threshold, else the subsequent rail is not enabled. If UV is masked, the sequence proceeds even if the UV-threshold is not reached. GPO1, GPO2, GPIO, and LDOs configured in bypass- or LSW-mode are not monitored for under-voltage, thus their outputs do not gate subsequent rails.

In case the sequence is interrupted due to an unmasked fault on a rail, the device powers down. The TPS6521905 attempts to power up two more times. If both of those re-tries fail to enter ACTIVE state, the device remains in INITIALIZE state until VSYS is power-cycled. While it is encouraged to keep this retry-counter active, one can disable it by setting bit MASK\_RETRY\_COUNT in INT\_MASK\_UV register.

To disable the retry-counter, set bit MASK\_RETRY\_COUNT in INT\_MASK\_UV register. When set, the device attempts to retry infinitely.

The TPS6521905 allows to configure the power-down sequence independent from the power-up sequence. The sequences are configured in the non-volatile memory.

At initial power-up, the device monitors the VSYS supply voltage and allows power-up and transition to INITIALZE state only if VSYS passed the VSYS<sub>POR Rising</sub> threshold.

The power-up sequence is configured as follows:

- The slot (respectively the position in the sequence) for each rail and GPO1, GPO2, GPIO, and nRSTOUT is
  defined using the corresponding \*\_SEQUENCE\_SLOT registers, the four MSB for the power-up sequence,
  the four LSB for the power-down sequence.
- The duration of each slot is defined in the POWER\_UP\_SLOT\_DURATION\_x registers and can be configured as 0 ms, 1.5 ms, 3 ms or 10 ms. In total, 16 slots can be configured, allowing the sequence to span over multiple TPS6521905-devices if more rails need to be supported.
- In addition to the timing as defined above, the power-up-sequence is also gated by the UV-monitor: a subsequent rail only gets enabled after the previous one passed the under-voltage threshold (unless UV is masked). If a rail has not reached the UV-threshold by the end of to the spectively transport transport to the sequence is aborted and the device sequences down at the end of the slot-duration. For the respective rail, the device sets INT\_BUCK\_x\_y\_IS\_SET respectively INT\_LDO\_x\_y\_IS\_SET bit in INT\_SOURCE register and BUCKx\_UV respectively LDOx\_UV bit in INT\_BUCK\_x\_y respectively INT\_LDO\_x\_y register as well as bit TIMEOUT in the INT\_TIMEOUT\_RV\_SD register.
- The initiation of the sequence is gated by the successful discharge of all rails, irrespective if enabled during
  the sequence or not. If the device is unable to discharge all rails below the SCG-threshold, the device sets
  INT\_BUCK\_x\_y\_IS\_SET respectively INT\_LDO\_x\_y\_IS\_SET bit in INT\_SOURCE register and BUCKx\_RV
  respectively LDOx\_RV bit if the residual voltage is still present after 4 ms to 5 ms and the device remains in
  INITIALIZE state.
- The initiation of the sequence is gated by the die-temperature: if any one of the WARM detections is
  unmasked, the device does not power-up until the temperature on all sensors fell below T<sub>WARM\_falling</sub>
  threshold if INITIALIZE state was entered due to a thermal event, respectively until the temperature on all
  sensors is below T<sub>WARM\_rising</sub> threshold if INITIALIZE state was entered from OFF-state. If all thermal sensors
  are masked (WARM detection not causing a power-down), the device does not power-up until the
  temperature on all sensors is below T<sub>HOT\_falling</sub> threshold

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All rails get discharged prior to enable (irrespective if discharge-function is disabled).

An ON-request is deglitched to not trigger on noise. After the deglitch time, the device takes approximately 300 µs until the first slot of the sequence starts. In case discharging of pre-biased rails is not completed by that time, the start of the sequence is further gated until all rails have discharged below SCG-voltage level.

Product Folder Links: TPS6521905

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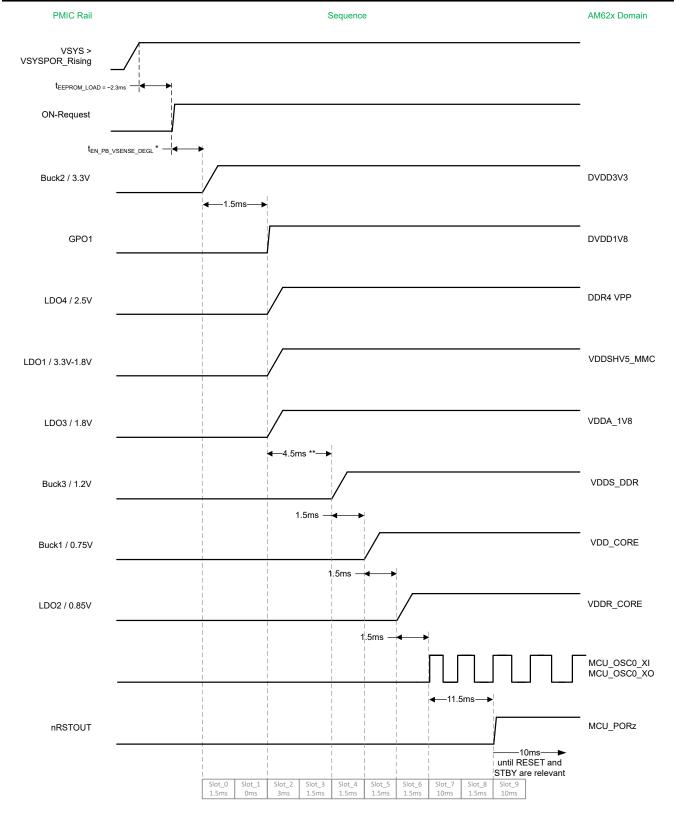


Below graphic shows the power-up-sequence for NVM-ID 0x01, revision 0x2 as an example:

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<sup>\*</sup> depends on EN / PB / VSENSE and long/short configuration, ~0 if FSD is enabled \*\* if applicable, slot-duration needs to adopt for enable- & ramp-time of external rail

図 6-2. Power-up sequencing (example)

For details on ON-requests please see Push Button and Enable Input (PB/EN/VSENSE).

### 注意

I2C commands must only be issued after EEPROM-load completed.

### 6.3.2 Power-Down Sequencing

An OFF-request or a shut-down-fault triggers the power-down sequence. The OFF-request can be triggered by a falling edge on EN/PB/VSENSE if configured for EN or VSENSE respectively a long press of the push-button if configured as PB or by an I2C-command to I2C\_OFF\_REQ in MFP\_CTRL register. This bit self-clears.

An I2C-triggered shut-down requires a renewed ON-request on the EN/PB/VSENSE pin. In case of EN- or VSENSE-configuration, a low-going edge followed by a high-going-edge is required on the EN/PB/VSENSE-pin. The falling-edge deglitch time for EN or VSENSE configuration  $t_{DEGL\_EN/VSENSE\_I2C}$  is shorter than the deglitch-time for pin-induced OFF-requests ( $t_{DEGL\_EN\_Fall}$  and  $t_{DEGL\_VSENSE\_Fall}$ ). The deglitch-times for PB-configuration remain.

In many cases, the power-down sequence follows the reverse power-up sequence. In some applications, all rails can be required to shut down at the same time with no delay between rails or require wait-times to allow discharging of rail.

The power-down sequence is configured as follows:

- The slot (respectively the position in the sequence) for each rail and GPO1, GPO2, GPIO, and nRSTOUT is
  defined using the corresponding \*\_SEQUENCE\_SLOT registers, the four MSB for the ON-sequence, the four
  LSB for the down-sequencing.
- The duration of each slot is defined in the POWER\_DOWN\_SLOT\_DURATION\_x registers and can be configured as 0 ms, 1.5 ms, 3 ms or 10 ms. In total, 16 slots can be configured, allowing the sequence to span over multiple TPS6521905-devices if more rails need to be supported.
- In addition to the slot-duration, the power-down sequence is also gated by the previous rail being discharged below the SCG-threshold, unless active discharge is disabled on the previous rail. If that does not occur, the power-down of subsequent rails is paused. To allow for power-down in case of biased or shorted rails, the sequence continues despite an incomplete discharge of the previous rail after eight times the slot-duration (or 12 ms in case of slot-duration of 0 ms).
- To bypass the discharge-check, set the bit BYPASS\_RAILS\_DISCHARGED\_CHECK in register GENERAL CONFIG to '1'.

注

In case active discharge on a rail is disabled, unsuccessful discharge of the rail within the slot duration does not gate the disable of the subsequent rail, but the sequence is purely timing based. In case of residual voltage, the RV-bit is be set regardless.

Active discharge is enabled by default and not NVM based. Thus, if desired, discharge need to be disabled after each VSYS-power-cycle. During RESET or OFF-request, the discharge configuration is not reset, as long as VSYS is present. However, in INITIALIZE state and prior to the power-up-sequence, all rails get discharged, regardless of the setting.

During the power-down-sequence, non-EEPROM-backed bits get reset, with the exception of unmasked interrupt bits and \* DISCHARGE EN bits.

Product Folder Links: TPS6521905

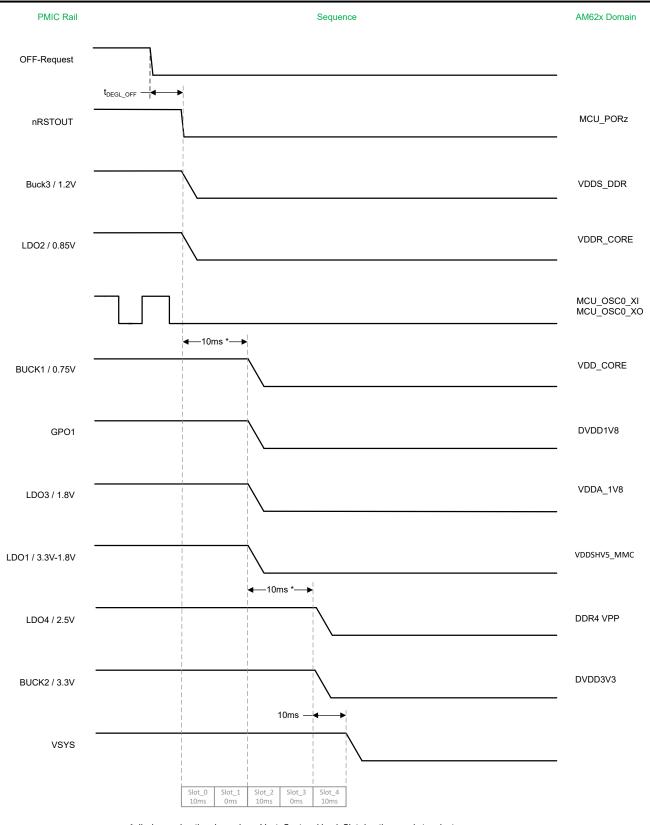
Below graphic shows the power-down-sequence for NVM-ID 0x01, revision 0x2 as an example:

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<sup>\*</sup> discharge-duration depends on Vout, Cout and load. Slot-duration needs to adopt. Slot-duration extends up to 8x its configured value.

図 6-3. Power-down sequencing (example)



#### 注意

Do not change the registers related to an ongoing sequence by I2C-command!

Non-NVM-bits are not accessible for approximately 80 µs after starting a transition into INITIALIZE state.

### 6.3.3 Push Button and Enable Input (EN/PB/VSENSE)

The EN/PB/VSENSE pin is used to enable the PMIC. The pin can be configured in three ways:

- Device enable (EN):
  - This pin needs to be pulled high to enable the device. Pulling this pin low disables the device.
  - The deglitch-time of the EN-pin is configured by EN PB VSENSE DEGL in MFP 2 CONFIG register.
  - The power-up sequence starts if the EN input is above the V<sub>IL</sub>-threshold low for the configured t<sub>DEGL\_EN\_Rise</sub>.
  - To signify the power-up based on an EN/PB/VSENSE pin-event, the device sets bit
     POWER\_UP\_FROM\_EN\_PB\_VSENSE in POWER\_UP\_STATUS\_REG register. This bit does not assert the nINT pin. Write W1C to clear the bit.
  - The power-down sequence starts if the EN input is below the V<sub>IH</sub>-threshold for t<sub>DEGI EN Fall</sub>.
  - In case of a shut-down fault, no renewed on-request is required. The device automatically executes the power-up sequence if EN input is still above the V<sub>IH</sub>-threshold. (EN considered level-sensitive)
  - In case of a cold reset (regardless if by RESET-pin or I2C-request), no renewed on-request is required.
     The device automatically executes the power-up sequence if EN input is still above the V<sub>IH</sub>-threshold. (EN considered level-sensitive)
- Push-Button (PB):
  - The PB pin is a CMOS-type input used to power-up the PMIC. Typically, the PB pin is connected to a momentary switch to ground and an external pullup resistor.
  - The hold-time of the push-button is configured by EN\_PB\_VSENSE\_DEGL in MFP\_2\_CONFIG register.
  - The power-up sequence starts if the PB input is below the V<sub>II</sub> -threshold low for the configured t<sub>PB ON</sub>.
  - To signify the power-up based on an EN/PB/VSENSE pin-event, the device sets bit POWER\_UP\_FROM\_EN\_PB\_VSENSE in POWER\_UP\_STATUS\_REG register. This bit does not assert the nINT pin. Write W1C to clear the bit.
  - The PB pin has a rising-edge deglitch t<sub>PB RISE DEGL</sub> to filter bouncing of the switch
  - The power-down sequence starts if the PB input is held low for t<sub>PB OFF</sub>-time (not configurable).
  - In case of a shut-down fault, no renewed on-request is required. The device automatically executes the power-up sequence without a PB-press.
  - In case of a cold reset (regardless if by RESET-pin or I2C-request), no renewed on-request is required.
     The device automatically executes the power-up sequence without a PB-press.
  - A push-button press is only recognized after VSYS is above VSYS\_POR-threshold or the PB must be held long enough after VSYS is above VSYS POR-threshold.
  - Following bits in the signify the PB-press events:
    - PB\_FALLING\_EDGE\_DETECTED: PB was pressed for a time-interval longer than t<sub>PB\_INT\_DEGL</sub> since the previous time this bit was cleared. This bit when set, does assert nINT pin (if config bit MASK\_INT\_FOR\_PB='0'). Write W1C to clear.
    - PB\_RISING\_EDGE\_DETECTED: PB was released for a time-interval longer than t<sub>PB\_INT\_DEGL</sub> since the previous time this bit was cleared. This bit when set, does assert nINT pin (if config bit MASK\_INT\_FOR\_PB='0'). Write W1C to clear.
    - PB\_REAL\_TIME\_STATUS: Deglitched (t<sub>PB\_INT\_DEGL</sub>) real-time status of PB pin. Valid only when EN/PB/VSENSE pin is configured as PB. This bit does not assert the nINT pin.
- Power-fail comparator input (VSENSE):
  - Connected to a resistor divider from the supply-line of the pre-regulator, this pin can be used to sense the supply-voltage to the pre-regulator.

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- The deglitch-time of the VSENSE-pin is configurable by EN\_PB\_VSENSE\_DEGL in MFP\_2\_CONFIG register.
- Power-up is gated by VSYS being above the VSYS<sub>POR\_Rising</sub>-threshold and the VSENSE input is above the V<sub>VSENSE</sub>-threshold (not deglitched)
- The power-up sequence starts if the VSENSE input rises above V<sub>VSENSE</sub>.
- To signify the power-up based on an EN/PB/VSENSE pin-event, the device sets bit POWER\_UP\_FROM\_EN\_PB\_VSENSE in POWER\_UP\_STATUS\_REG register. This bit does not assert the nINT pin. Write W1C to clear the bit.
- The power-down sequence starts if the VSENSE input falls below the V<sub>VSENSE</sub>-threshold for t<sub>DEGL VSENSE Fall</sub>, to avoid an un-sequenced power-off due to the loss of VSYS-supply-voltage.
- In case of a shut-down fault, no renewed on-request is required. The device automatically executes the power-up sequence if VSENSE input is still above the V<sub>VSENSE</sub>-threshold.
- In case of a cold reset (regardless if by RESET-pin or I2C-request), no renewed on-request is required.
   The device automatically executes the power-up sequence if VSENSE input is still above the V<sub>VSENSE</sub>-threshold.
- OFF-request by I2C-command
  - An OFF-request can also be triggered by an I2C-command to I2C\_OFF\_REQ in MFP\_CTRL register.
  - After an OFF-request, a new ON-request is required:
    - In case of EN-configuration, the EN input requires a rising edge (EN considered edge-sensitive)
    - In case of PB-configuration, the PB needs to be pressed for a valid ON-request
    - In case of VSENSE-configuration, the VSENSE input requires a rising edge (VSENSE considered edge-sensitive). This ON request can be triggered by power cycling the pre-regulator.
    - The falling-edge deglitch time for EN or VSENSE configuration t<sub>DEGL\_EN/VSENSE\_I2C</sub> is shorter than the deglitch-time for pin-induced OFF-requests (t<sub>DEGL\_EN\_Fall</sub> and t<sub>DEGL\_VSENSE\_Fall</sub>). The deglitch-times for PB-configuration remain.
- First Supply detection (FSD)
  - First Supply detection (FSD) allows power-up as soon as supply voltage is applied, even if EN/PB/ VSENSE pin is at OFF REQ status.
  - FSD can be used in combination with any ON-request configuration, EN, PB or VSENSE.
  - FSD can be enabled by setting PU ON FSD bit in MFP 2 CONFIG.
  - At first power-up the EN/PB/VSENSE pin is treated as if the pin had a valid ON request.
  - Once VSYS is above the VSYS<sub>POR Rising</sub>-threshold, the PMIC
    - · loads the EEPROM
    - enters INITIALIZE state
    - · perform the discharge-check
    - initiates the power-up-sequence, regardless of the EN/PB/VSENSE-pin-state.
  - To signify the power-up based on FSD, the device sets bit POWER\_UP\_FROM\_FSD in POWER\_UP\_STATUS\_REG register. The nINT-pin does not toggle based on this bit. Write W1C to clear the bit.
  - Thereafter, the EN/PB/VSENSE-pin is treated as if the pin had a valid ON-request, until we enter ACTIVE state (at the expiration of the last slot in the power-up-sequence).
  - After that the device adheres to post-deglitch EN/PB/VSENSE-pin-status: if pin status has changed prior
    to entering ACTIVE state or in ACTIVE state, the device does adhere to the pin state. For example, if the
    EN/PB/VSENSE-pin is configured for EN, the device does power down in case the EN-pin is low (for
    longer than the deglitch time) at the time the device enters ACTIVE state.
  - The duration for how long the ON-request is considered valid, regardless of the pin-state, can be controlled by length of nRSTOUT slot (and empty slots thereafter), as the PMIC enters ACTIVE state only after the last slot of the sequence expired.

## 6.3.4 Reset to SoC (nRSTOUT)

The reset output (nRSTOUT) is an open-drain output, intended to release the reset to the SoC or FPGA at the end of the power-up sequence. The timing for nRSTOUT is configured in the sequence. nRSTOUT is driven low

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until the device enters ACTIVE state or when powering-down from ACTIVE- or STBY-state. The pin is driven high during ACTIVE- and STBY-state.

### 6.3.5 Buck Converters (Buck1, Buck2, and Buck3)

The TPS6521905 integrates three buck converters. Buck1 is capable of supporting up to 3.5 A and Buck2/Buck3 are capable of supporting up to 2 A of load current. The buck converters have an input voltage range from 2.5 V to 5.5 V, and can be connected either directly to the system power or the output of a another buck converter. The output voltage is programmable in the range of 0.6 V to 3.4 V: in 25mV-steps up to 1.4V, in 100mV-steps between 1.4V and 3.4V.

- The ON/OFF state of the buck converters in ACTIVE state is controlled by the corresponding BUCKx\_EN bit in the ENABLE\_CTRL register.
- The ON/OFF state of the buck converters in STBY state is controlled by the corresponding BUCKx\_STBY\_EN bit in the STBY\_1\_CONFIG register.
- In INITIALIZE state, the buck converters are off, regardless of bit-settings.

### 注意

In case of buck-regulators that are not to be used at all, the FB\_Bx pin must be tied to GND and the LX\_Bx pin must be left floating.

• The converters activity can be controlled by the sequencer or through I2C communication.

### **Buck-switch-modes:**

### Quasi-fixed-frequency mode

- The converters can operate in forced-PWM mode, irrespective of load-current, or can be allowed to enter pulse-frequency-modulation (PFM) for low load-currents. The mode is controlled by either the MODE/STBY pin or the MODE/RESET pin if either of those is configured as 'MODE', or by an I2C-command to MODE\_I2C\_CTRL bit in MFP\_1\_CONFIG register (see pin-configuration and I2C-command in 'PWM/PFM and Low Power Modes (MODE/STBY)' and PWM/PFM and Reset (MODE/RESET)' section.
- During a transition to ACTIVE state or to INITIALIZE state, the buck converters are forced to PWM, irrespective of the pin-state. PFM-entry is only allowed when the device enters ACTIVE state, upon completion of the sequence and expiration of the last power-up-slot.
- In case of a DVFS-induced output voltage change, the TPS6521905 temporarily forces the buck-regulators into PWM until the voltage change completed. If PFM is allowed, the entry and exit into PFM is load-current dependent. PFM starts when the inductor current reaches 0 A, which is the case at a load current approximately calculated by:
- $I_{LOAD} = \{ [(V_{PVIN Bx} V_{BUCKx}) / L] \times (V_{BUCKx} / V_{PVIN Bx}) \times (1 / f_{SW}) \} / 2$

#### 注意

The user MUST NOT CHANGE the BUCK\_FF\_ENABLE! The bit is pre-configured by the manufacturer.

- The converters can be individually configured further for a high-bandwidth-mode for optimum transient-response or lower bandwidth, allowing minimum output filter capacitance. The selection is done by the BUCKx\_BW\_SEL bits in GENERAL\_CONFIG register. This bit must only change if this regulator is disabled. Please note the higher output-capacitance requirements for high bandwidth use case!
- If VSEL\_SD/VSEL\_DRR is configured as 'VSEL\_DDR' by the VSEL\_DDR\_SD bit in MFP\_1\_CONFIG
  register, the output voltage of Buck3 can be controlled by pulling the VSEL\_SD/VSEL\_DDR pin high, low or
  leave the pin floating. These settings supports DDR3LV, DDR4, and DDR4LV supply voltages without an
  EEPROM change.

注意

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The VSEL\_DDR-pin needs to be hard-wired and must not change during operation.

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- The buck converters have an active discharge function. The discharge function can be disabled individually
  per rail in the DISCHARGE\_CONFIG register. If discharge is enabled, the device discharges the output is
  discharged to ground whenever a rail is disabled.
- Prior to a sequence into ACTIVE state (from INITIALIZE or STBY state), the device discharges the disabled rails regardless of the discharge-configuration to avoid starting into a pre-biased output.
- If a rail is enabled by an I2C-command, active discharge is not enforced, but the rail is only enabled if the output voltage is below the SCG-threshold.
- This register is not EEPROM-backed and does reset if the device enters OFF-state.
- When in INITIALIZE state (during RESET or an I2C-OFF-request), the discharge configuration is not reset. Note: the power-down-sequence can be violated if the discharge function is disabled.

All Buck Converters support Dynamic Voltage Frequency Scaling (DVFS). The output-voltage can be changed during the operation to optimize the operating voltage for the operation point of the SoC in the lower output voltage range between 0.6 V and 1.4 V. The voltage change is controlled by writing to BUCK1\_VOUT respectively BUCK2\_VOUT or BUCK3\_VOUT registers. During a DVFS-induced voltage transition, the active discharge function is temporarily enabled, irrespective of the discharge-configuration.

### **Output Capacitance Requirements**

The buck converters require sufficient output-capacitance for stability. The required minimum and supported maximum capacitance depends on the configuration:

- for quasi-fixed-frequency, low-bandwidth configuration, a minimum capacitance of 10uF is required and a maximum total capacitance of 75uF is supported
- for quasi-fixed-frequency, high-bandwidth configuration, a minimum capacitance of 30uF is required and a maximum total capacitance of 220uF is supported

### **Buck Fault Handling**

The TPS6521905 detects under voltages on the buck converter outputs. The reaction to the detection of an under-voltage is dependent on the configuration of the respective BUCKx\_UV bit and the MASK\_EFFECT bit in INT\_MASK\_BUCKS. If not masked, the device sets bit INT\_BUCK\_1\_2\_IS\_SET respectively INT\_BUCK\_3\_IS\_SET bit in INT\_SOURCE register and bit BUCKx\_UV in INT\_BUCK\_1\_2 respectively INT\_BUCK\_3 register.

During a voltage transition (for example, when triggered by a DVFS induced voltage change), the device blanks the undervoltage detection by default and activates the undervoltage detection when the voltage transition completed.

If the device detects an undervoltage during the sequence into ACTIVE state (from INITIALIZE or STBY) and UV is not masked, the power-down-sequence starts at the end of the current slot.

If the device detects an undervoltage in ACTIVE-state or STBY-state and UV is not masked, the power-down sequence starts immediately. OC-detection is not maskable.

The TPS6521905 provides cycle-by-cycle current-limit on the buck converter outputs. If the device detects over-current for t<sub>DEGLITCH\_OC\_short</sub>, respectively for t<sub>DEGLITCH\_OC\_long</sub> (configurable individually per rail with EN\_LONG\_DEGL\_FOR\_OC\_BUCKx in OC\_DEGL\_CONFIG register; applicable for rising-edge only), the device sets INT\_BUCK\_1\_2\_IS\_SET respectively INT\_BUCK\_3\_IS\_SET bit in INT\_SOURCE register and bit BUCKx\_OC (for positive over-current) respectively BUCKx\_NEG\_OC (for negative over-current) in INT\_BUCK\_1\_2 respectively INT\_BUCK\_3 register.

During a voltage transition (for example, when triggered by a DVFS induced voltage change), the over current detection is blanked and only gets activated when the voltage transition is completed.

If the over-current occurs during the sequence into ACTIVE state (from INITIALIZE or STBY), the device disables the affected rail immediately and starts the power-down-sequence at the end of the current slot.

If the over-current occurs in ACTIVE-state or STBY-state, the device disables the affected rail immediately and starts the power-down sequence.

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OC-detection is not maskable, but the deglitch-time is configurable. It is strongly recommended to use  $t_{DEGLITCH\_OC\_short}$ . Extended over-current can lead to increased aging or overshoot upon recovery.

 The TPS6521905 detects short-to-ground (SCG) faults on the buck-outputs. The reaction to the detection of an SCG event is to set INT\_BUCK\_1\_2\_IS\_SET respectively INT\_BUCK\_3\_IS\_SET bit in INT\_SOURCE register and bit BUCKx\_SCG in INT\_BUCK\_1\_2 respectively INT\_BUCK\_3 register. The affected rail is disabled immediately. The device sequences down all outputs and transitions into the INITIALIZE state.

SCG-detection is not maskable.

If a rail gets enabled, the device blanks SCG detection initially to allow the rail to ramp above the SCG-threshold.

- The TPS6521905 detects residual voltage (RV) faults on the buck-outputs. The reaction to the detection of an RV event is to set INT\_RV\_IS\_SET bit in INT\_SOURCE register and bit BUCKx\_RV in INT\_RV register. The RV-detection is not maskable, but the nINT-reaction can be configured globally for all rails by MASK\_INT\_FOR\_RV in INT\_MASK\_WARM register. The BUCKx\_RV-flag is set regardless of masking, INT\_RV\_IS\_SET bit is only set if nINT is asserted. The fault-reaction time and potential state-transition depends on the situation when residual voltage is detected:
  - If the device detects residual voltage during an ON-request in the INITIALIZE state, the device gates
    power-up and the device remains in INITIALIZE state. If the RV-condition exists for more than 4 ms to 5
    ms, the device sets BUCKx\_RV-bit. If the RV-condition is not present any more, the device transitions to
    ACTIVE state.
  - If the device detects residual voltage during power-up, ACTIVE\_TO\_STANDBY, or STANDBY TO ACTIVE sequences, the sequence is aborted and the device powers down.
  - If the device detects residual voltage for more than 80 ms on any rail that was disabled during STBY state during a request to leave STBY state, the device transitions into INITIALIZE state. The device sets the BUCKx RV-bit if the condition persists for 4 ms to 5 ms, but less than 80 ms.
  - If the device detects residual voltage during power-up, ACTIVE\_TO\_STANDBY, or STANDBY\_TO\_ACTIVE sequences, the sequence is aborted and the device powers down.
  - If residual voltage is detected during an EN-command of the rail by I2C, the BUCKx\_RV-flag is set immediately, but no state transition occurs.
- The buck converters have a local over-temperature sensor. The reaction to a temperature warning is dependent on the configuration of the respective SENSOR\_x\_WARM\_MASK bit in MASK\_CONFIG register and the MASK\_EFFECT bits in INT\_MASK\_BUCKS register. If the temperature at the sensor exceeds Twarm\_Rising and is not masked, the device sets INT\_SYSTEM\_IS\_SET bit in INT\_SOURCE register and SENSOR\_x\_WARM bit in INT\_SYSTEM register. In case the sensor detects a temperature exceeding Thot\_Rising, the converters power dissipation and junction temperature exceeds safe operating value. The device powers down all active outputs immediately and sets INT\_SYSTEM\_IS\_SET bit in INT\_SOURCE register and SENSOR\_x\_HOT bit in INT\_SYSTEM register. The TPS6521905 automatically recovers once the temperature drops below the Twarm\_Falling threshold value (or below the Thot\_Falling threshold value in case T\_WARM is masked). The \_HOT bit remains set and needs to be cleared by writing '1'. The HOT-detection is not maskable.

#### 注意

The buck can only supply output currents up to the respective current limit, including during start-up. Depending on the charge-current into the filter- and load-capacitance, the device potentially cannot drive the full output current to the load while ramping. As a rule of thumb, for a total load-capacitance exceeding 50  $\mu$ F, the load current must not exceed 25% of the rated output current. This limit applies also for dynamic output-voltage changes.

#### 注意

The TPS6521905 does not offer differential feedback pins. The device does not support remote sensing. Since a single-ended trace is susceptible to noise and must be as short as possible and thus connect directly to the output filter.

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# 表 6-1. BUCK output voltage settings

BUCKx_VSET [decimal]	BUCKx_VSET [binary]	BUCKx_VSET [hexadecimal]	VOUT (Buck1 & Buck2 and Buck3) [V]
0	000000	00	0.600
1	000001	01	0.625
2	000010	02	0.650
3	000011	03	0.675
4	000100	04	0.700
5	000101	05	0.725
6	000110	06	0.750
7	000111	07	0.775
8	001000	08	0.800
9	001001	09	0.825
10	001010	0A	0.850
11	001011	0B	0.875
12	001100	0C	0.900
13	001101	0D	0.925
14	001110	0E	0.950
15	001111	0F	0.975
16	010000	10	1.000
17	010001	11	1.025
18	010010	12	1.050
19	010011	13	1.075
20	010100	14	1.100
21	010101	15	1.125
22	010110	16	1.150
23	010111	17	1.175
24	011000	18	1.200
25	011001	19	1.225
26	011010	1A	1.250
27	011011	1B	1.275
28	011100	1C	1.300
29	011101	1D	1.325
30	011110	1E	1.350
31	011111	1F	1.375
32	100000	20	1.400
33	100001	21	1.500
34	100010	22	1.600
35	100011	23	1.700
36	100100	24	1.800
37	100101	25	1.900
38	100110	26	2.000
39	100111	27	2.100
40	101000	28	2.200
41	101001	29	2.300
42	101010	2A	2.400
	101011	2B	2.500

表 6-1. BUCK output voltage settings (続き)

BUCKx_VSET [decimal]	BUCKx_VSET [binary]	BUCKx_VSET [hexadecimal]	VOUT (Buck1 & Buck2 and Buck3) [V]
44	101100	2C	2.600
45	101101	2D	2.700
46	101110	2E	2.800
47	101111	2F	2.900
48	110000	30	3.000
49	110001	31	3.100
50	110010	32	3.200
51	110011	33	3.300
52	110100	34	3.400
53	110101	35	3.400
54	110110	36	3.400
55	110111	37	3.400
56	111000	38	3.400
57	111001	39	3.400
58	111010	3A	3.400
59	111011	3B	3.400
60	111100	3C	3.400
61	111101	3D	3.400
62	111110	3E	3.400
63	111111	3F	3.400

#### 6.3.6 Linear Regulators (LDO1 through LDO4)

The TPS6521905 offers a total of four linear regulators, where LDO1 and LDO2 share their properties and LDO3 and LDO4 share theirs.

#### LDO1 and LDO2: 400 mA, 0.6 V .. 3.4 V

Both, LDO1 and LDO2 are general-purpose LDOs intended to provide power to analog circuitry on the SOC or peripherals. The LDOs have an input voltage range from 1.5V to 5.5V, and can be connected either directly to the system power or the output of a Buck converter. The output voltage is programmable in the range of 0.6V to 3.4V in 50mV-steps. Both LDOs support up to 400 mA. The LDOs can be configured in by-pass-mode, acting as load-switches. If configured in bypass-mode, the desired output voltage still needs to be specified in LDOx\_VOUT register. The LDOs also support output-voltage changes while enabled, supporting functions like SD-card-IO-supply, changing from 3.3V to 1.8V after initialization, either in LDO-mode at a supply-voltage above 3.3V or with a 3.3V supply changing between bypass-mode and LDO-mode. The LDOs also support Load-switch mode (LSW\_mode): in this case, output voltages of 1.5V up to 5.5V are supported. The desired voltage does not need to be configured in the LDOx\_VOUT register.

- In case of SD-card-supply, one of the LDOs can be controlled by the VSEL\_SD/VSEL\_DDR, configured as VSEL\_SD. Which LDO is controlled is selected by VSEL\_RAIL bit in MFP\_1\_CONFIG register. The polarity of the pin can be configured via VSEL\_SD\_POLARITY bit in MFP\_1\_CONFIG register.
  - Alternatively, an I2C communication to VSEL\_SD\_I2C\_CTRL in MFP\_1\_CONFIG register controls the change of the output voltage. Therefore, even if VSEL\_SD/VSEL\_DDR pin is configured as VSEL\_DDR, the VSEL\_RAIL bit still needs to be configured to define which LDO is affected by the I2C-command.
- The LDOs can be configured as linear regulators or operate in bypass-mode or be configured as a loadswitch (LSW-mode). The mode is configured by LDOx\_LSW\_CONFIG and LSW\_BYP\_CONFIG bits in LDOx\_VOUT register.

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#### 注意

If an LDO is configured in bypass-mode, the output voltage must be configured and the PVIN\_LDOx supply voltage must match the configured output voltage. PVIN\_LDOx voltage must be within (configured VOUT) and (configured VOUT + 200mV). Violation of this can result in instability.

In bypass- or LSW-mode, the LDO acts as a switch, where VOUT is VIN minus the drop over the FET-resistance ( $R_{BYPASS}$ ,  $R_{LSW}$ ).

### **Output Capacitance Requirements**

The LDO regulators require sufficient output-capacitance for stability. The required minimum and supported maximum capacitance depends on the configuration:

- in LDO-mode, a minimum capacitance of 1.6 uF is required and a maximum total load capacitance (output filter and point-of-load combined) of 20 uF is supported
- in LSW- or bypass-mode, a minimum capacitance of 1.6 uF is required and a maximum total capacitance (output filter and point-of-load combined) of 50 uF is supported

#### LDO3 and LDO4: 300 mA, 1.2 V .. 3.3 V

Both, LDO3 and LDO4 are general-purpose LDOs intended to provide power to analog circuitry on the SoC or peripherals. The LDOs have an input voltage range from 2.2 V to 5.5 V, and can be connected either directly to the system power or the output of a Buck converter. Note, these LDOs need a headroom between VSYS and the LDO-output voltage of minimum 150 mV. The output voltage is programmable in the range of 1.2 V to 3.3 V in 50 mV-steps. Both LDOs support up to 300 mA. The LDOs can be configured to act as load-switches. In this case, output voltages of 2.2 V up to 5.5 V are supported. The desired voltage does not need to be configured in the LDOx VOUT register.

These LDOs support a fast-ramp-mode with limited output capacitance and a slow-ramp-mode, allowing for larger total load capacitance.

### **Output Capacitance Requirements**

The LDO regulators require sufficient output-capacitance for stability. The required minimum and supported maximum capacitance depends on the configuration:

- for slow-ramp LDO-mode or LSW-mode, a minimum capacitance of 1.6 uF is required and a maximum total capacitance (output filter and point-of-load combined) of 30 uF is supported
- for fast-ramp LDO-mode or LSW-mode, a minimum capacitance of 1.6 uF is required and a maximum total capacitance (output filter and point-of-load combined) of 15 uF is supported

#### LDO1, LDO2, LDO3 and LDO4

- The ON/OFF state of the LDOs in ACTIVE state is controlled by the corresponding LDOx\_EN bit in the ENABLE CTRL register.
- The ON/OFF state of the LDOs in STBY state is controlled by the corresponding LDOx\_STBY\_EN bit in the STBY\_1\_CONFIG register.
- In INITIALIZE state, the LDOs are off, regardless of bit-settings.

### 注意

In case of linear regulators that are not to be used at all, the VLDOx pin must be left floating.

Each of the LDOs can be configured as linear regulators or be configured as a load-switch (LSW-mode).
 LDO1 and LDO2 can also operate in bypass-mode. The mode is configured by LDOx\_LSW\_CONFIG and LSW BYP CONFIG bits in LDOx VOUT register individually per regulator.

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#### 注意

A mode change between LDO(/bypass) and LSW-mode must only be performed, when the regulator is disabled!

(A change between LDO and bypass-mode (supported by LDO1 and LDO2 only) is supported during operation.)

- The LDOs have an active discharge function. Whenever LDOx is disabled, the output is discharged to ground. The discharge function can be disabled individually per rail in the DISCHARGE\_CONFIG register.
- Prior to a sequence into ACTIVE state (from INITIALIZE or STBY state), the device discharges the disabled rails regardless of the discharge-configuration to avoid starting into a pre-biased output.
- If a rail is enabled by an I2C-command, active discharge is not enforced, but the rail is only enabled if the output voltage is below the SCG-threshold.
- This register is not EEPROM-backed and is reset if the device enters OFF-state.
- When in INITIALIZE state (during RESET or an I2C-OFF-request), the discharge configuration is not reset. Note: the power-down-sequence can be violated if the discharge function is disabled

### **LDO Fault Handling**

The TPS6521905 detects under-voltages on the LDO-outputs. The reaction to the detection of an under-voltage is dependent on the configuration of the LDOx\_UV\_MASK bit in INT\_MASK\_LDOS register and the MASK\_EFFECT in INT\_MASK\_BUCKS register. If not masked, the device sets bit INT\_LDO\_1\_2\_IS\_SET respectively INT\_LDO\_3\_4\_IS\_SET bit in INT\_SOURCE register and bit LDOx\_UV in INT\_LDO\_1\_2 register respectively INT\_LDO\_3\_4 register.

During a voltage transition (at power-up or triggered by toggling VSEL\_SD-pin or an I2C-command), the device blanks the undervoltage detection by default and activates the undervoltage detection when the voltage transition completed.

If the device detects an undervoltage during the sequence into ACTIVE state (from INITIALIZE or STBY) and UV is not masked, the power-down-sequence starts at the end of the current slot.

If the device detects an undervoltage in ACTIVE-state or STBY-state and UV is not masked, the power-down sequence starts immediately. OC-detection is not maskable.

#### 注意

If a LDO is configured in bypass-mode or LSW-mode, UV-detection is not supported.

• The TPS6521905 provides current-limit on the LDO-outputs. If the PMIC detects over-current for t<sub>DEGLITCH\_OC\_short</sub>, respectively for t<sub>DEGLITCH\_OC\_long</sub> (configurable individually per rail with EN\_LONG\_DEGL\_FOR\_OC\_LDOx in OC\_DEGL\_CONFIG register; applicable for rising-edge only), the device sets INT\_LDO\_1\_2\_IS\_SET respectively INT\_LDO\_3\_4\_IS\_SET bit in INT\_SOURCE register and bit LDOx\_OC in INT\_LDO\_1\_2 respectively INT\_LDO\_3\_4 register. The effected rail is disabled immediately.

During a voltage transition (at power-up or triggered by toggling VSEL\_SD-pin or an I2C-command), the overcurrent detection is blanked and gets activated when the voltage transition completed.

If the over-current occurs during the sequence into ACTIVE state (from INITIALIZE or STBY), the device disables the affected rail immediately and starts the power-down-sequence at the end of the current slot.

If the over-current occurs in ACTIVE-state or STBY-state, the device disables the affected rail immediately and starts the power-down sequence.

OC-detection is not maskable, but the deglitch-time is configurable. It is strongly recommended to use t<sub>DEGLITCH OC short</sub>. Extended over-current can lead to increased aging or overshoot upon recovery.

The TPS6521905 detects short-to-ground (SCG) faults on the LDO-outputs. The reaction to the detection of an SCG event is to set INT\_LDO\_1\_2\_IS\_SET respectively INT\_LDO\_3\_4\_IS\_SET bit in INT\_SOURCE register and bit LDOx\_SCG in INT\_LDO\_1\_2 register respectively INT\_LDO\_3\_4 register. The affected rail is disabled immediately. The device sequences down all outputs and transitions into INTIALIZE state.

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SCG-detection is not maskable.

If a rail gets enabled, the device blanks SCG detection initially to allow the rail to ramp above the SCG-threshold.

- The TPS6521905 detects residual voltage (RV) faults on the LDO-outputs. The reaction to the detection of an RV event is to set INT\_RV\_IS\_SET bit in INT\_SOURCE register and bit LDOx\_RV in INT\_RV register. The RV-detection is not maskable, but the nINT-reaction can be configured globally for all rails by MASK\_INT\_FOR\_RV in INT\_MASK\_WARM register. The device sets the LDOx\_RV-flag regardless of masking, INT\_RV\_IS\_SET bit is only set if nINT is asserted. The fault-reaction time and potential state-transition depends on the situation when the faults are detected:
  - If the device detects residual voltage during an ON-request in the INITIALIZE state, the PMIC gates power-up and the device remains in INITIALIZE state. If the RV-condition is detected for more than 4 ms to 5 ms, the device sets the LDOx\_RV-bit but remains in INITIALIZE state as long as the RV-condition exists. If the RV-condition is not present any more, the device transitions to ACTIVE state, provided the ON-request is still valid.
  - If the device detects residual voltage during power-up, ACTIVE\_TO\_STANDBY, or STANDBY TO ACTIVE sequences, the sequence is aborted and the device powers down.
  - If the device detects residual voltage for more than 80 ms on any rail that was disabled during STBY state during a request to leave STBY state, the device transitions into INITIALIZE state. The device sets the LDOx\_RV-bit if the condition persists for 4 ms to 5 ms, but less than 80 ms.
  - If the device detects residual voltage during power-up, ACTIVE\_TO\_STANDBY, or STANDBY TO ACTIVE sequences, the sequence is aborted and the device powers down.
  - If the device detects residual voltage during an EN-command of the rail by I2C, the LDOx\_RV-bit is set immediately, but no state transition occurs.
- The LDOs have a local over-temperature sensor. The reaction to a temperature warning is dependent on the configuration of the respective SENSOR\_x\_WARM\_MASK bit in and the MASK\_EFFECT bit in INT\_MASK\_BUCKS register. If the temperature at the sensor exceeds T<sub>WARM\_Rising</sub> and is not masked, the device sets INT\_SYSTEM\_IS\_SET bit in INT\_SOURCE register and SENSOR\_x\_WARM bit in INT\_SYSTEM register. In case the sensor detects a temperature exceeding T<sub>HOT\_Rising</sub>, the converters power dissipation and junction temperature exceeds safe operating value. The device powers down all active outputs immediately and sets INT\_SYSTEM\_IS\_SET bit in INT\_SOURCE register and SENSOR\_x\_HOT bit in INT\_SYSTEM register. The TPS6521905 automatically recovers once the temperature drops below the T<sub>WARM\_FAlling</sub> threshold value (or below the T<sub>HOT\_FAlling</sub> threshold value in case T\_WARM is masked). The \_HOT bit remains set and needs to be cleared by writing '1'. The HOT-detection is not maskable.

表 6-2. LDO output voltage settings

LDOx_ VSET [decimal]	LDOx_VSET [binary]	LDOx_ VSET [hexadecimal]	VOUT (LDO1 and LDO2, LDO mode) [V]	VOUT (LDO1 and LDO2, bypass- mode) [V]	VOUT (LDO3 and LDO4, LDO mode) [V]
0	000000	00	0.60	reserved	1.20
1	000001	01	0.65	reserved	1.20
2	000010	02	0.70	reserved	1.20
3	000011	03	0.75	reserved	1.20
4	000100	04	0.80	reserved	1.20
5	000101	05	0.85	reserved	1.20
6	000110	06	0.90	reserved	1.20
7	000111	07	0.95	reserved	1.20
8	001000	08	1.00	reserved	1.20
9	001001	09	1.05	reserved	1.20
10	001010	0A	1.10	reserved	1.20
11	001011	0B	1.15	reserved	1.20

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# 表 6-2. LDO output voltage settings (続き)

LDOx_VSET [decimal]	LDOx_VSET [binary]	LDOx_ VSET [hexadecimal]	VOUT (LDO1 and LDO2, LDO mode) [V]	VOUT (LDO1 and LDO2, bypass- mode) [V]	VOUT (LDO3 and LDO4, LDO mode) [V]
12	001100	0C	1.20	reserved	1.20
13	001101	0D	1.25	reserved	1.25
14	001110	0E	1.30	reserved	1.30
15	001111	0F	1.35	reserved	1.35
16	010000	10	1.40	reserved	1.40
17	010001	11	1.45	reserved	1.45
18	010010	12	1.50	1.50	1.50
19	010011	13	1.55	1.55	1.55
20	010100	14	1.60	1.60	1.60
21	010101	15	1.65	1.65	1.65
22	010110	16	1.70	1.70	1.70
23	010111	17	1.75	1.75	1.75
24	011000	18	1.80	1.80	1.80
25	011001	19	1.85	1.85	1.85
26	011010	1A	1.90	1.90	1.90
27	011011	1B	1.95	1.95	1.95
28	011100	1C	2.00	2.00	2.00
29	011101	1D	2.05	2.05	2.05
30	011110	1E	2.10	2.10	2.10
31	011111	1F	2.15	2.15	2.15
32	100000	20	2.20	2.20	2.20
33	100001	21	2.25	2.25	2.25
34	100010	22	2.30	2.30	2.30
35	100011	23	2.35	2.35	2.35
36	100100	24	2.40	2.40	2.40
37	100101	25	2.45	2.45	2.45
38	100110	26	2.50	2.50	2.50
39	100111	27	2.55	2.55	2.55
40	101000	28	2.60	2.60	2.60
41	101001	29	2.65	2.65	2.65
42	101010	2A	2.70	2.70	2.70
43	101011	2B	2.75	2.75	2.75
44	101100	2C	2.80	2.80	2.80
45	101101	2D	2.85	2.85	2.85
46	101110	2E	2.90	2.90	2.90
47	101111	2F	2.95	2.95	2.95
48	110000	30	3.00	3.00	3.00

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### 表 6-2. LDO output voltage settings (続き)

LDOx_VSET [decimal]	LDOx_VSET [binary]	LDOx_ VSET [hexadecimal]	VOUT (LDO1 and LDO2, LDO mode) [V]	VOUT (LDO1 and LDO2, bypass- mode) [V]	VOUT (LDO3 and LDO4, LDO mode) [V]
49	110001	31	3.05	3.05	3.05
50	110010	32	3.10	3.10	3.10
51	110011	33	3.15	3.15	3.15
52	110100	34	3.20	3.20	3.20
53	110101	35	3.25	3.25	3.25
54	110110	36	3.30	3.30	3.30
55	110111	37	3.35	3.35	3.30
56	111000	38	3.40	3.40	3.30
57	111001	39	3.40	3.40	3.30
58	111010	ЗА	3.40	3.40	3.30
59	111011	3B	3.40	3.40	3.30
60	111100	3C	3.40	3.40	3.30
61	111101	3D	3.40	3.40	3.30
62	111110	3E	3.40	3.40	3.30
63	111111	3F	3.40	3.40	3.30

## 6.3.7 Interrupt Pin (nINT)

During power-up, the output of the nINT pin does depend on whether any INT\_SOURCE flags are set and the configuration of the MASK\_EFFECT bit in INT\_MASK\_BUCKS register-. If one or more flags are set, then nINT pin is pulled low and is only released high after those flags have been cleared by writing '1' to them. Note, the nINT-pin can only transition 'high' if a VIO-voltage for the pull-up is available.

In ACTIVE or STBY state, the nINT pin signals any event or fault condition to the host processor. Whenever a fault or event occurs in the IC, the corresponding interrupt bit is set in the INT register, and the open-drain output is driven low. In case the device transitions to INITIALIZE state, the nINT pin is pulled low as well, regardless if the transition is triggered by an OFF-request or a fault.

If the fault is no longer present, a W1C (write '1' to clear) needs to be performed on the failure bits. This command also allows the nINT-pin to release (return to Hi-Z state).

If a failure persists, the corresponding bit remains set and the INT pin remains low.

The UV-faults can be individually masked per rail in INT\_MASK\_UV registers. The thermal sensors can individually be masked by SENSOR\_x\_WARM\_MASK in the MASK\_CONFIG register. The effect of the masking for UV and WARM is defined globally by MASK\_EFFECT bits in MASK\_CONFIG register.

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The nINT reaction for RV-faults is defined globally by MASK\_INT\_FOR\_RV bits in MASK\_CONFIG register.

- 00b = no state change, no nINT reaction, no bit set
- 01b = no state change, no nINT reaction, bit set
- 10b = no state change, nINT reaction, bit set (same as 11b)
- 11b = no state change, nINT reaction, bit set (same as 10b)

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#### 注意

Masking poses a risk to the device or the system. In case the masking is performed by I2C-command, the masking bits do get reset to EEPROM-based default after transitioning to INITIALIZE state. Bits corresponding to faults newly configured via I2C as SD-faults do not get cleared.

It is strongly discouraged to mask OC- and UV-detection on the same rail.

## 6.3.8 PWM/PFM and Low Power Modes (MODE/STBY)

The TPS6521905 supports low power modes through the I2C-control or through the MODE/STBY pin. The configuration of the pin is selected by MODE\_STBY\_CONFIG in MFP\_2\_CONFIG register. The polarity of this pin can be configured by writing to MODE\_STBY\_POLARITY in MFP\_1\_CONFIG register. The polarity-configuration must not change after power-up. Only either MODE/RESET or MODE/STBY must be configured as MODE. If both are configured as MODE, MODE/RESET takes priority and MODE/STBY is ignored.

## MODE/STBY configured as 'MODE':

- If configured as 'MODE', the pin-status determines the switching-mode of the buck-converters.
- Forcing this pin for longer than t<sub>DEGLITCH\_MFP</sub> forces the buck-regulators into PWM-mode (irrespective of load current). De-asserting this pin low allows the buck regulators to enter PFM-mode. The entry into PFM and exit from PFM is governed by the load current. Only one pin, either MODE/STBY or MODE/RESET must be configured as 'MODE'.
- The selection of auto-PFM/forced-PWM can also be controlled by writing to the bit MODE\_I2C\_CTRL in MFP\_1\_CONFIG register.
- A change of the MODE does not cause a state-transition.
- During power-up of any one of the three bucks, a MODE change is blanked on this rail and only takes effect after the ramp completed.

### MODE/STBY configured as 'STBY':

- Forcing this pin for longer than t<sub>DEGLITCH\_MFP</sub> sequences down the rails selected to turn off in the STBY\_1\_CONFIG respectively the STBY\_2\_CONFIG register. De-asserting this pin sequences the selected rails on again.
- A transition into and out of STBY state can also be controlled by writing to the bit STBY\_I2C\_CTRL in MFP\_CTRL register, provided I2C communication is supported during STBY state.
- A change of the MODE/STBY pin configured as 'STBY' does cause a state-transition by definition.
- Regardless of the pin-setting, the device always powers up into ACTIVE state. The device reacts to the STBY-pin-state or I2C-commands only after entering ACTIVE state.

### MODE/STBY configured as 'MODE & STBY':

- The pin can be configured to perform both functions, MODE and STBY simultaneously
- Forcing this pin for longer than t<sub>DEGLITCH\_MFP</sub> sequences down the rails selected to turn off in the STBY\_1\_CONFIG respectively the STBY\_2\_CONFIG register and allows auto-PFM entry (only applicable in quasi-fixed-frequency mode). De-asserting this pin sequences the selected rails on again and forces the buck-regulators to forced-PWM. Polarity settings need to be harmonized for this configuration.
- If a transition into and out of STBY state is commanded by writing to the bit STBY\_I2C\_CTRL in MFP\_CTRL
  register (provided I2C communication is supported during STBY state), a separate command for the MODEchange is required by writing to the bit MODE\_I2C\_CTRL in MFP\_1\_CONFIG register.
- A change of the MODE/STBY pin configured as 'MODE&STBY' does cause a state-transition by definition.
- By default STBY is deasserted and the pin is ignored until the device completed the power-up-sequence. During power-up of any one of the three bucks, a MODE-change is blanked on this rail and only takes effect after the ramp completed. A state-change commanded by STBY-pin is reacted to even during the ramp of rails (except during INITIALIZE-to-ACTIVE transition).

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Please see below truth-table for pin- and I2C-commands.

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## 表 6-3. MODE/STBY configuration

Pin Name	Pin Configuration (MODE_STBY_CON FIG)	Pin Polarity (MODE_STBY_POL ARITY)	Pin state (schematic)	I2C control (MODE_I2C_CTRL)	Resulting Function
MODE/STBY	MODE	x	x	1h	forced PWM
MODE/STBY	MODE	0h	L	0h	auto-PFM
MODE/STBY	MODE	0h	Н	0h	forced PWM
MODE/STBY	MODE	1h	L	0h	forced PWM
MODE/STBY	MODE	1h	Н	0h	auto-PFM
MODE/STBY	STBY	0	L	х	STBY
MODE/STBY	STBY	0	Н	х	ACTIVE
MODE/STBY	STBY	1	L	х	ACTIVE
MODE/STBY	STBY	1	Н	х	STBY

### 6.3.9 PWM/PFM and Reset (MODE/RESET)

This pin can be configured as an alternative MODE pin (in case MODE/STBY is configured for STBY-function) or as a RESET pin. The configuration of the pin is selected by MODE\_RESET\_CONFIG in MFP\_2\_CONFIG register. The polarity of this pin can be configured by writing to MODE\_RESET\_POLARITY in MFP\_1\_CONFIG register. The polarity-configuration must not change after power-up. Only MODE/RESET or MODE/STBY must be configured as MODE. If both are configured as MODE, MODE/RESET takes priority and MODE/STBY is ignored.

### MODE/RESET configured as 'MODE':

- If configured as 'MODE', the pin-status determines the switching-mode of the buck-converters.
- Forcing this pin for longer than t<sub>DEGLITCH\_MFP</sub> forces the buck-regulators into PWM-mode (irrespective of load current). De-asserting this pin low allows the buck regulators to enter PFM-mode. The entry into PFM and exit from PFM is governed by the load current. Only one pin, either MODE/STBY or MODE/RESET must be configured as 'MODE'.
- The selection of auto-PFM/forced-PWM can also be controlled by writing to the bit MODE\_I2C\_CTRL in MFP 1 CONFIG register.
- A change of the MODE does not cause a state-transition.
- During power-up of any one of the three bucks, a MODE-change is blanked on this rail and only takes effect after the ramp completed.

### MODE/RESET configured as 'RESET':

- In RESET configuration, this pin is edge sensitive, but still applies the deglitch time. Consequently, toggling
  this pin and holding the pin for longer than t<sub>DEGLITCH</sub> RESET causes a reset.
- By default, RESET is deasserted and RESET requests, via pin or I2C, are only serviced if the device is in ACTIVE state, STBY state, or transitions between these 2 states.
- The TPS6521905 supports WARM or COLD reset. The configuration is made by bit WARM\_COLD\_RESET\_CONFIG in MFP\_2\_CONFIG register.
  - If configured for COLD reset, the device executes the power down sequence and transitions to INITIALIZE state. Then, EEPROM is reloaded and rails power-up again in normal power-up-sequence, provided there are no faults and no OFF-request. The execution of a COLD-reset sets the bit COLD\_RESET\_ISSUED in POWER\_UP\_STATUS\_REG register. The read-out of this bit allows to track if a COLD-reset was performed. The bit gets set regardless if the reset was commanded by I2C or by the pin. The nINT-pin does not toggle based on this bit. Write W1C to clear the bit.

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 If configured for WARM reset, all enabled rails remain on, but the output voltage of rails that support dynamic voltage change is reset to the boot-voltage. Specifically, following configurations get reset to their boot-value: BUCK1 VSET, BUCK2 VSET, BUCK3 VSET, LDO1 VSET, LDO2 VSET, LDO1 BYP CONFIG, LDO2 BYP CONFIG and VSEL SD I2C CTRL.

All other bits, even in the same register, remain at their current state. For example, LDOx LSW CONFIG, BUCKx BW SEL, BUCKx UV THR SEL and the MFP 1 CONFIG register bits do NOT get reset during a WARM-reset.

WARM Reset cannot override the VSEL SD-pin command. In other words: even if a WARM Reset occurs, if the VSEL SD pin is commanding 1.8V-LDO mode, that remain in effect.

A reset can also be triggered by writing to the bit WARM RESET I2C CTRL respectively the bit COLD\_RESET\_I2C\_CTRL in MFP\_CTRL register.

注

Shut-down-faults and OFF-requests take priority over a RESET-request. If a RESET-requests occurs simultaneously with one of those, the device enters INITIALIZE state and requires a new ON-request to start up.

Reset requests, via pin or I2c, are only serviced in ACTIVE state, STBY state, or a transition between these two states.

Please see below truth-table for pin- and I2C-commands.

表 6-4. MODE/RESET configuration

Pin Name	Pin Configuration (MODE_RESET_CO NFIG)	Pin Polarity (MODE_RESET_POL ARIT Y)	Pin state (schematic)	I2C control (MODE_I2C_CTRL)	Resulting Function
MODE/RESET	MODE*	x	х	1h	forced PWM
MODE/RESET	MODE*	0h	L	0h	auto-PFM
MODE/RESET	MODE*	0h	Н	0h	forced PWM
MODE/RESET	MODE*	1h	L	0h	forced PWM
MODE/RESET	MODE*	1h	Н	0h	auto-PFM
MODE/RESET	RESET	0	L	х	RESET
MODE/RESET	RESET	0	Н	х	normal operation
MODE/RESET	RESET	1	L	х	normal operation
MODE/RESET	RESET	1	Н	х	RESET

The \* for MODE indicates that the MODE/RESET pin takes priority in case both, MODE/RESET and MODE/ STBY are configured as 'MODE', and thus the respective pin to be observed is MODE/RESET.

## 6.3.10 Voltage Select pin (VSEL\_SD/VSEL\_DDR)

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The function of this pin is configured by VSEL DDR SD in MFP 1 CONFIG.

When configured as VSEL SD, the bit VSEL RAIL in MFP 1 CONFIG register selects LDO1 or LDO2 to be controlled by the pin. The configuration must not change after power-up.

## VSEL\_SD/VSEL\_DDR configured as 'VSEL\_SD': SD-card-IO-select:

The polarity of this pin can be configured by writing to VSEL SD POLARITY in MFP 1 CONFIG register. Toggling the pin changes the output voltage of the selected LDO between hard-coded 1.8 V and the voltage

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configured in LDOx\_VOUT. For the SD-card-IO-supply, LDOx\_VOUT must be configured for 3.3 V. A change of the VSEL\_SD status does not cause a state-transition.

#### 注意

In SD-card-configuration, customer must configure the pin-polarity and drive the pin so that the LDO delivers 3.3 V at start-up.

### VSEL SD/VSEL DDR configured as 'VSEL DDR':

Pulling this pin high sets the output voltage of Buck3 to 1.35 V (DDR3LV), leaving the pin floating sets the output voltage of Buck3 to 1.2 V (DDR4, LP-DDR3, some LP-DDR2), pulling the pin low sets the output voltage of the Buck3 voltage configured in BUCK3\_VOUT. For LP-DDR4, BUCK3\_VOUT must be configured to 1.1 V.

### 注意

This function needs to be hard-wired and must not change during operation.

#### 注意

The VSEL\_RAIL still needs to be configured for the LDO that supplies the SD-card-IO-voltage, as an I2C-command toggles the selected LDO-rail for the SD-card. The VSEL\_SD\_POLARITY bit has no effect if the pin is configured as VSEL\_DDR.

The Table below shows the various combinations.

表 6-5. VSEL\_SD/VSEL\_DDR configuration options

Pin Configuration (VSEL_DDR_SD)	Pin Polarity (VSEL_SD_POLARITY)	Rail selection (VSEL_RAIL)	PIN state (schematic)	I2C control (VSEL_SD_I2C_ CTRL)	Resulting Function
DDR	n/a	0 = LDO1 1 = LDO2 (needed for I2C control)	L	0h: LDOx = 1.8V 1h: LDOx = LDOx_VSET	BUCK3 = Buck3_VSET
DDR	n/a	0 = LDO1 1= LDO2 (needed for I2C control)	open	0h: LDOx = 1.8V 1h: LDOx = LDOx_VSET	BUCK3 = 1.2V
DDR	n/a	0 = LDO1 1 = LDO2 (needed for I2C control)	Н	0h: LDOx = 1.8V 1h: LDOx = LDOx_VSET	BUCK3 = 1.35
SD	0	0 = LDO1	L	х	LDO1 = 1.8 V
SD	0	0 = LDO1	Н	х	LDO1 = LDO1_VSET
SD	1	0 = LDO1	L	х	LDO1 = LDO1_VSET
SD	1	0 = LDO1	Н	х	LDO1 = 1.8 V
SD	0	1 = LDO2	L	х	LDO2 = 1.8 V
SD	0	1 = LDO2	Н	х	LDO2 = LDO2_VSET
SD	1	1 = LDO2	L	х	LDO2 = LDO2_VSET
SD	1	1 = LDO2	Н	х	LDO2 = 1.8 V

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## 6.3.11 General Purpose Inputs or Outputs (GPO1, GPO2, and GPIO)

GPO1 and GPO2 pins are always configured as an output.



The GPIO-pin is an input/output, however, the input-functionality is only used in multi-PMIC configuration. In single-PMIC configuration, the pin can be used as an output. The state can be read by polling the bit GPIO STATUS bit in MFP CTRL register.

The I/O-configuration of the GPIO-pin is done by the MULTI DEVICE ENABLE bit in MFP 1 CONFIG register.

If configured as outputs, these pins can be used to sequence external rails. The GP(I)Os can be included in the sequence or be controlled via I2C-interface, writing to GPOx\_EN respectively GPIO\_EN bit in GENERAL CONFIG register. The GPO is released high if activated.

The GPIO function is to be used if multiple TPS6521905 need to be synchronized, in case more rails need to be supplied. See application section on usage. See section "Multi-PMIC operation" for details.

The polarity of these pins is not changeable.

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## 6.3.12 I<sup>2</sup>C-Compatible Interface

The default I<sup>2</sup>C1 7-bit device address of the TPS6521905 is set to 0x30 (0b0110000 in binary), but can be changed if needed, for example for multi-PMIC-operation.

The I<sup>2</sup>C-compatible synchronous serial interface provides access to the configurable functions and registers on the device. This protocol uses a two-wire interface for bidirectional communications between the devices connected to the bus. The two interface lines are the serial data line (SDA), and the serial clock line (SCL). Every device on the bus is assigned a unique address and acts as either a controller or a target depending on whether it generates or receives the serial clock SCL. The SCL and SDA lines must each have a pullup resistor placed somewhere on the line and remain HIGH even when the bus is idle. The TPS6521905 supports standard mode (100 kHz), fast mode (400 kHz), and fast mode plus (1 MHz) when VIO is 3.3 V or 1.8 V.

## 6.3.12.1 Data Validity

The data on the SDA line must be stable during the HIGH period of the clock signal (SCL). In other words, the state of the data line can only be changed when clock signal is LOW.

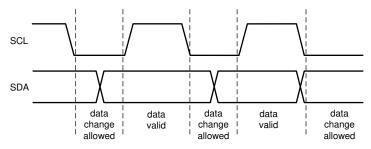


図 6-4. Data Validity Diagram

#### 6.3.12.2 Start and Stop Conditions

The device is controlled through an I<sup>2</sup>C-compatible interface. START and STOP conditions classify the beginning and end of the I<sup>2</sup>C session. A START condition is defined as the SDA signal going from HIGH to LOW while the SCL signal is HIGH. A STOP condition is defined as the SDA signal going from LOW to HIGH while the SCL signal is HIGH. The I<sup>2</sup>C controller device always generates the START and STOP conditions.

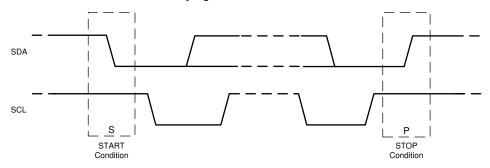


図 6-5. Start and Stop Sequences

The I<sup>2</sup>C bus is considered busy after a START condition and free after a STOP condition. The I<sup>2</sup>C controller device can generate repeated START conditions during data transmission. A START and a repeated START condition are equivalent function-wise. Z 6-6 shows the SDA and SCL signal timing for the I<sup>2</sup>C-compatible bus. For timing values, see the Specification section.

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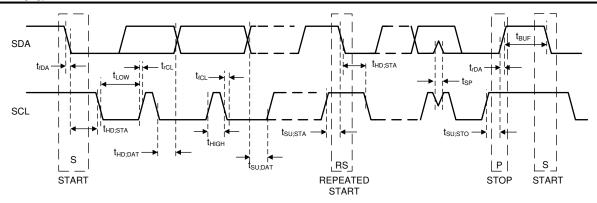


図 6-6. I<sup>2</sup>C-Compatible Timing

### 6.3.12.3 Transferring Data

Every byte put on the SDA line must be eight bits long, with the most significant bit (MSB) being transferred first. Each byte of data has to be followed by an acknowledge bit. The acknowledge related clock pulse is generated by the controller device. The controller device releases the SDA line (HIGH) during the acknowledge clock pulse. The device pulls down the SDA line during the 9th clock pulse, signifying an acknowledge. The device generates an acknowledge after each byte has been received.

There is one exception to the acknowledge after every byte rule. When the controller device is the receiver, it must indicate to the transmitter an end of data by not-acknowledging (negative acknowledge) the last byte clocked out of the target device. This negative acknowledge still includes the acknowledge clock pulse (generated by the controller device), but the SDA line is not pulled down.

After the START condition, the bus controller device sends a chip address. This address is seven bits long followed by an eighth bit which is a data direction bit (READ or WRITE). For the eighth bit, a 0 indicates a WRITE and a 1 indicates a READ. The second byte selects the register to which the data is written. The third byte contains data to write to the selected register.  $\boxtimes$  6-7 shows an example bit format of device address 110000-Bin = 60Hex.

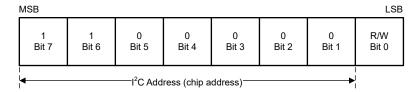


図 6-7. Example Device Address

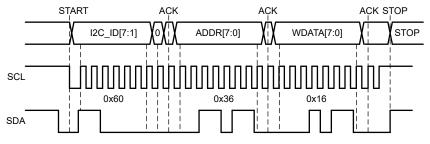
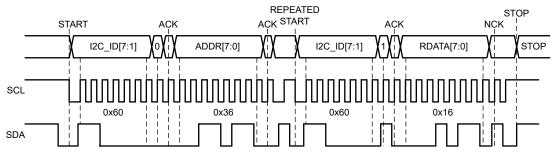


図 6-8. I<sup>2</sup>C Write Cycle without CRC

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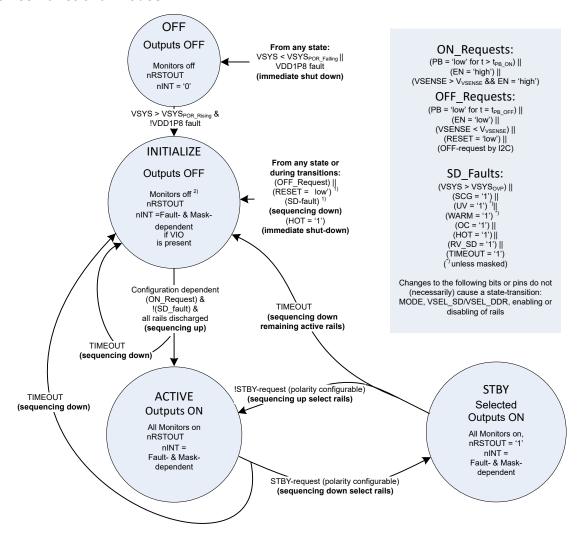




When READ function is to be accomplished, a WRITE function must precede the READ function as shown above.

## 図 6-9. I<sup>2</sup>C Read Cycle without CRC

#### 6.4 Device Functional Modes



- 1) in case of a RESET or a SD-fault, the device transitions from INITIALIZE state to the ACTIVE state without a new Push-button-ON\_Request. In EN or VSENSE configuration, the ON-request must still be valid to transition to ACTIVE state.
- 2) If INITIALIZE state was entered due to a Thermal-Shut-Down, the temperature monitors remain active until the temperature on all sensors fell below T<sub>WARM</sub> threshold. Thermal-Shut-Down causes immediate shut-shutdown, no sequencing down

#### 図 6-10. State diagram

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## 6.4.1 Modes of Operation

#### 6.4.1.1 OFF State

In OFF state, the PMIC is insufficiently supplied. Neither internal logic nor external rails are available. If VSYS exceeds VSYS\_POR voltage and the internal 1.8V-rail (VDD1P8) is in regulation, the device enters the INITIALIZE state.

#### 6.4.1.2 INITIALIZE State

In INITIALIZE state, the device is completely shut down with the exception of a few circuits to monitor the EN/PB/VSENSE input. Whenever entering the INITIALIZE state, the PMIC reads the memory and loads the registers to their EEPROM-default values. The I<sup>2</sup>C communication interface is turned off.

Entry to INITIALIZE state is gated if any one of the thermal sensors is above the  $T_{WARM\_Rising}$  threshold and WARM-detection is not masked.

The EEPROM loading takes approximately 2.3 ms. The power-up sequence can only execute after the EEPROM-load and if all rails are discharged below the  $V_{BUCKx\ SCG\ TH}$  respectively  $V_{LDOx\ SCG\ TH}$  threshold.

If INITIALIZE state was entered from OFF state, bit POWER\_UP\_FROM\_OFF in POWER\_UP\_STATUS\_REG register is set and remains set until a write-1-clear is issued. Read-out of this bit allows to determine if INITIALZE state was entered from OFF state or due to a Shut-down-fault or OFF-request.

In INITIALIZE state, the nINT pin status is dependent if faults are and masking thereof. If no faults are present or nINT-reaction for those are masked, nINT-pin is pulled high, provided a VIO-voltage for the pull-up is available.

To transition from the INITIALIZE state to the ACTIVE state, one of the ON-requests must occur:

- The EN input is 'high' (if EN/PB/VSENSE is configured as 'EN' or 'VSENSE')
- The PB input is pulled low for at least t<sub>PB\_ON\_SLOW</sub> respectively t<sub>PB\_ON\_FAST</sub> (if EN/PB/VSENSE is configured as 'PB')

注

The DISCHARGE\_CONFIG register is purposefully omitted from RESET when entering INITIALIZE state from ACTIVE or STBY state. When entering INITIALIZE state from OFF state, the EEPROM content is loaded. If the discharge configuration changed after power-up, a different start-up behavior can occur, depending if the INITIALIZE state was entered from OFF state or from ACTIVE/STBY.

## 6.4.1.3 ACTIVE State

The ACTIVE state is the normal mode of operation when the system is up and running. All enabled buck converters and LDOs are operational and can be controlled through the I2C interface. After a wake-up event, the PMIC discharges potential residual voltages on the outputs, regardless of the discharge-configuration. ACTIVE state can also be directly entered from STBY state by de-asserting the STBY pin high or by an I2C command. See STBY state description for details. To transition to STBY, the STBY pin must be forced or an I2C command to STBY I2C CTRL in MFP CTRL register must be issued.

To transition to INITIALIZE state, one of the following OFF\_Requests must occur:

- . The EN input is 'low' (if EN/PB/VSENSE is configured as 'EN' or 'VSENSE')
- The PB input is pulled low for at least t<sub>PB\_OFF</sub> (if EN/PB/VSENSE is configured as 'PB')
- An I2C OFF-request is issued

If a shut-down-fault (SD\_Fault) occurs while in the ACTIVE state, TPS6521905 sequences down the active outputs and transition to the INITIALIZE state. The device does transition to ACTIVE state without a new Push-button-ON\_Request. In EN or VSENSE configuration, the ON-request must still be valid to transition to ACTIVE state.

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#### 6.4.1.4 STBY State

STBY state is a low-power mode of operation intended to support system standby. The mode can be entered by the MODE/STBY pin, if configured as 'STBY' or by an I2C-command to STBY\_I2C\_CTRL in MFP\_CTRL register. Typically, the majority of power rails are turned off with the exception of rails required by the SoC during this state. Which rails power down in STBY state can be configured in STBY\_1\_CONFIG and STBY\_2\_CONFIG register.

The monitoring functions are all available: Under-voltage- (UV), Short-to-GND- (SCG) and Over-current- (OC) detection, thermal warning (WARM) and thermal-shutdown (TSD/HOT) remain active.

The device enters ACTIVE state if STBY is de-asserted or an I2C command is received (provided VIO-supply remained active). Before starting the STBY to ACTIVE sequence, disabled rails are discharged. In case this fails to complete within 80 ms, the device also runs into a timeout-condition and transitions to INITIALIZE state. The device sets bit TIMEOUT in the INT\_TIMEOUT\_RV\_SD register and the fault flags for the rail that caused the shut-down.

The sequence into and out of STBY state is the same as for power-down respectively for power-up. Rails that remain on in STBY are skipped, but their respective slots are still executed.

### 注意

The device cannot transition from INITIALIZE state to STBY state directly, it must first enter ACTIVE state.

#### 注意

Only rails that were enabled in ACTIVE state can remain enabled in STBY. Previously disabled rails cannot be turned on in STBY-state. Activity in STBY-state requires a AND-combination of LDOx EN / BUCKx EN and LDOx STBY EN/BUCKx STBY EN.

#### 注意

Do not change the registers related to an ongoing sequence by I2C-command!

Non-NVM-bits are not accessible for ~80 us after starting a transition into INITIALIZE state.

#### 6.4.1.5 Fault Handling

#### **Detectable Faults**

The TPS6521905 offers various fault-detections. Per default, all of them lead to a sequenced shut-down. Some of them are maskable and the reaction to masked faults is configurable.

The device provides the following fault-detections on the supply voltage (VSYS) and internal voltage supply (VDD1P8):

- · Undervoltage on VSYS, resulting in transition to OFF state or gating start-up
- Overvoltage-protection on VSYS, resulting in transition to OFF state
- Under- or Overvoltage on internal 1.8V-supply (VDD1P8), resulting in transition to OFF state or gating startup.

None of these faults are maskable.

The TPS6521905 provides the following fault-detections on the buck- and LDO-outputs:

- Undervoltage detection (UV)
- Over Current detection (OC), triggering on positive as well as (for buck-converters) negative current-limit

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- Short-to-GND detection (SCG)
- Temperature warning (WARM) and Thermal Shut Down (TSD / HOT)

- Residual Voltage (RV) and Residual Voltage Shutdown (RV SD)
- Timeout (TO)

SCG, OC, HOT, RV\_SD and TO are not maskable. If any one of those occurs, the device powers down. Positive and negative current limit share the same mask-bit per regulator.

The reaction to UV, RV and WARM faults is configurable. If not masked, a fault triggers a sequenced shut-down. UV, RV and WARM can be masked individually per regulator in INT\_MASK\_BUCKS, INT\_MASK\_LDOS and INT\_MASK\_WARM registers. No state-transition occurs in case of a masked fault. Whether bits are set and if nINT is pulled low can be configured globally by MASK\_EFFECT bits in MASK\_CONFIG register. Positive and negative current limit share the same mask-bit per regulator.

- 00b = no state change, no nINT reaction, no bit set
- 01b = no state change, no nINT reaction, bit set
- 10b = no state change, nINT reaction, bit set (same as 11b)
- 11b = no state change, nINT reaction, bit set (same as 10b)

For any fault that corresponds to a shut-down condition, the fault-bit remains asserted until a W1C (write-one-clear) operation is performed via I2C (assuming the fault is not present any more). In case of a shut-down fault, no renewed on-request is required. The device automatically executes the power up sequence if the fault is no longer present as long as EN/VSENSE is still high and no PB-press is required for a restart.

For any fault that is not a shut-down condition (for example because the fault is masked), the bit is cleared when going to the INITIALIZE state.

### Thermal Warning and Shutdown

There are two thermal thresholds: Thermal-warning (WARM) and Thermal Shutdown (TSD / HOT).

- Thermal Warning, WARM-threshold:
- if the temperature exceeds T<sub>WARM\_Rising</sub> threshold, the SENSOR\_x\_WARM-bit is set and the PMIC sequences down (unless masked).
- if the temperature fell below T<sub>WARM\_Falling</sub> threshold, the device powers up again, without a new Push-button-ON\_Request. In EN or VSENSE configuration, the ON-request must still be valid to transition to ACTIVE state.
- if the temperature exceeds T<sub>WARM\_Rising</sub> threshold, but SENSOR\_x\_WARM\_MASK bit is /bits are set, the
  PMIC remains in ACTIVE state. Fault-reporting occurs as configured by MASK\_EFFECT bits. The processor
  makes the decision to either sequence the power down or throttles back on the running applications to
  reduce the power consumption and hopefully avoiding a Thermal Shutdown situation.
- Thermal Shutdown, HOT-threshold, applicable if WARM-threshold is masked:
- if the temperature exceeds T<sub>HOT\_Rising</sub> threshold, the SENSOR\_x\_HOT-bit is set and the PMIC powers off all rails immediately. This power down is simultaneously and not sequenced.
- in case ALL sensors are masked for WARM-detection (all SENSOR\_x\_WARM\_MASK bits are set), the PMIC
  does power back up once the temperature drops below the T<sub>HOT\_Falling</sub> threshold, provided a valid ONrequest is present.
- in case any one of the sensors is unmasked for WARM-detection, the PMIC does power back up once the
  temperature drops below the T<sub>WARM\_Falling</sub> threshold, without a new
  Push-button-ON\_Request. In EN or VSENSE configuration, the ON-request must still be valid to transition to
  ACTIVE state.

## **Residual Voltage**

Residual voltage checks are performed at various occasions: before starting the INITIALIZE- to ACTIVE-transition and any time before a rail is enabled, regardless if during the sequence, by I2C-command or during the STBY- to ACTIVE-transition. RV-checks are also performed during the sequences, to detect if a rail that is supposed to be disabled is pulled up by another rail. The treatment of RV-faults depends on the situation when the fault occurs:

INITIALIZE to ACTIVE:

*信* 55



- if residual voltage is detected for more than 4 ms to 5 ms prior to the execution of the sequence, the
  respective INT\_RV\_IS\_SET bit in INT\_SOURCE register and LDOx\_RV respectively BUCKx\_RV bit in
  INT\_RV register is set and remains set, even if the discharge is successful at a later time and the ONrequest is executed.
- if the residual voltage is detected during the sequence, this constitutes a shutdown-fault: the device initiates the power-down-sequence at the end of the slot-duration. The device sets the respective INT\_TIMEOUT\_RV\_SD\_IS\_SET bit in INT\_SOURCE register, LDOx\_RV\_SD respectively BUCKx\_RV\_SD bit and bit TIMEOUT in INT\_TIMEOUT\_RV\_SD register.

#### ACTIVE to STBY:

- if active discharge is enabled and residual voltage is detected after eight times the power-down slot-duration, this constitutes a shutdown-fault: the device sequences down at the end of the slot. The device sets INT\_TIMEOUT\_RV\_SD\_IS\_SET bit in INT\_SOURCE register, the LDOx\_RV\_SD respectively BUCKx\_RV\_SD bit and the bit TIMEOUT in INT\_TIMEOUT\_RV\_SD register.
- if the residual voltage is detected during the sequence, this constitutes a shutdown-fault: the device sequences down at the end of the slot-duration and sets bit INT\_TIMEOUT\_RV\_SD\_IS\_SET in INT\_SOURCE register and LDOx\_RV\_SD respectively BUCKx\_RV\_SD bit in INT\_TIMEOUT\_RV\_SD register.

#### STBY to ACTIVE:

- if residual voltage is detected prior to the execution of the sequence for more than 4 ms to 5 ms, the
  device sets INT\_RV\_IS\_SET bit in INT\_SOURCE register and LDOx\_RV respectively BUCKx\_RV bit in
  INT\_RV register. The bit remains set, even if the discharge is successful before timeout expires and the
  STBY-to-ACTIVE-sequence is executed.
- if residual voltage is detected for more than 80 ms prior to the execution of the sequence, this constitutes
  a shutdown-fault: the device sequences down and sets the bit INT\_TIMEOUT\_RV\_SD\_IS\_SET in
  INT\_SOURCE register and LDOx\_RV\_SD respectively BUCKx\_RV\_SD bit in INT\_TIMEOUT\_RV\_SD
  register. In addition, the device sets the bit TIMEOUT in INT\_TIMEOUT\_RV\_SD register.
- if the residual voltage is detected during the sequence, this constitutes a shutdown-fault: the device sequences down at the end of the slot-duration and sets the INT\_TIMEOUT\_RV\_SD\_IS\_SET bit in INT\_SOURCE register and LDOx\_RV\_SD respectively BUCKx\_RV\_SD bit in INT\_TIMEOUT\_RV\_SD register. The TIMEOUT bit is not set in this case.

#### ACTIVE to INITIALIZE or STBY to INITIALIZE

if the residual voltage is detected at the end of the power-down slot-duration of the respective rail, this
gates the disabling of the subsequent rail for up to eight times the slot-duration, but then the powersequence continues regardless of the residual voltage. No bit is set in this case.

## · MASKING of RV-bits

- the reaction of the nINT-pin reaction in case of residual voltage detection is maskable for LDOx\_RV respectively BUCKx RV bits by MASK INT FOR RV bit in MASK CONFIG register.
- neither the bit nor the shutdown-fault-reaction in case of residual voltage detection is maskable for LDOx\_RV\_SD respectively BUCKx\_RV\_SD bits.

#### Timeout

 Timeout occurs if residual voltage cannot be discharged in time. The bit TIMEOUT in INT\_TIMEOUT\_RV\_SD register is set. See details above.

注

In case active discharge on a rail is disabled, the unsuccessful discharge of that rail within the slot duration does not gate the disable of the subsequent rail.

During power-down, the device sets neither RV-bits nor RV\_SD-bits for rails with disabled discharge.

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## 注意

For every detected Shut-Down fault, irrespective if prior to the sequence due to unsuccessful discharge, during the power-up-sequence or in ACTIVE or STBY state, the retry counter (RETRY\_COUNT in POWER\_UP\_STATUS\_REG register) is incremented. The device attempts two retries to power-up. If both fail, a power-cycle on VSYS is required to reset the retry counter. Any successful power-up also resets the retry counter.

If faults are masked and do not cause a shut-down, the retry counter does not increment.

To disable the retry-counter, set bit MASK\_RETRY\_COUNT in INT\_MASK\_UV register. When set, the device attempts to retry infinitely.

Below table gives an overview of the fault-behavior in ACTIVE and STBY states if unmasked and whether a fault is maskable.

### 注意

Masking of faults can pose a risk to the device or the system, including but not limited to starting into a pre-biased output.

It is strongly discouraged to mask OC- and UV-detection on the same rail.

## 表 6-6. Fault Handling

Block	Fault	ACTIVE or STBY state (if fault NOT masked)	ACTIVE or STBY state (if fault IS masked)
BUCK & LDO	Residual voltage - shutdown- Fault - RV_SD *)	Fault triggers a sequenced shut- down to INITIALIZE state	Not maskable
BUCK & LDO	Residual voltage - RV	Fault does not trigger state- change	Fault does not trigger state-change
BUCK & LDO	Timeout - TO *)	Fault triggers a sequenced shut- down to INITIALIZE state	Fault does not trigger state-change
BUCK & LDO	Undervoltage - UV	Fault triggers a sequenced shut- down to INITIALIZE state	Fault does not trigger state-change
BUCK & LDO	Overcurrent - OC	Fault triggers a sequenced shut- down to INITIALIZE state	Not maskable
BUCK & LDO	Short-to-GND - SCG	Fault triggers a sequenced shut- down to INITIALIZE state	Not maskable
BUCK & LDO	Temperature warning - WARM	Fault triggers a sequenced shut- down to INITIALIZE state	Yes
BUCK & LDO	Temperature shut-down - HOT	Fault triggers an immediate shut-down to INITIALIZE state (not sequenced)	Not maskable
VSYS	Undervoltage - UV	Fault triggers an immediate shut-down to OFF state (not sequenced)	Not maskable
VSYS	Overvoltage - OV	Fault triggers an immediate shut-down to OFF state (not sequenced)	Not maskable

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### 表 6-6. Fault Handling (続き)

Block		ACTIVE or STBY state (if fault NOT masked)	ACTIVE or STBY state (if fault IS masked)
VDD1P8	Undervoltage or Overvoltage -	Fault triggers an immediate	Not maskable
	UV or OV	shut-down to OFF state (not	
		sequenced)	

\*) RV SD and TIMEOUT faults can only occur during a sequence

## 6.5 Multi-PMIC Operation

The GPIO (pin#16) is an input/output digital pin, however, the input-functionality is only used in multi-PMIC configuration. This pin behaves as GPO (general purpose output) when configured for single PMIC and behaves as GPIO (general purpose input-output) when configured for multi-device. This configuration can be made on register field MULTI\_DEVICE\_ENABLE (address 0x1F). When configured for "multi-device", GPIO allows to synchronize the power-up and power-down sequence of multiple TPS6521905 devices for applications requiring additional rails. The GPIO pin is used to indicate the status of each PMIC so they are always in the same state and same sequence slot. At the beginning of each sequence slot, all the TPS6521905 PMICs drive GPIO pin low. After the sequence slot duration finishes, and all rails for that slot have reached the UV threshold, device releases the GPIO pin. Once both devices release the GPIO high, they advance to the next sequence slot together. Since both PMICs are always in the same power-up or power-down slot, multiple rails from each PMIC can be assigned to the same sequence slot.  $\boxtimes$  6-11 shows an example PDN of two TPS6521905 devices sharing the same input supply (VSYS), EN pin and GPIO for multi-PMIC operation.

### Requirements when synchronizing multiple TPS6521905 PMICs

- The GPIO from each PMIC must be tied together, sharing the same pull-up resistor. The pull-up resistance
  needs to be chosen to meet the maximum allowable rise-time t<sub>RISE\_GPIO</sub> in combination with the capacitance
  on the GPIO-line to allow for synchronization.
- The EN/PB/VSENSE pin must be tied together sharing the same external ON request. This pin must have the same configuration (same pin config, deglitch, FSD).
- All the TPS6521905 PMICs must share the same VSYS supply.
- Each of the TPS6521905 PMICs must have a different I2C address if they are connected to the same I2C bus. The I2C address for the second PMIC can be changed on register field I2C\_ADDRESS. Once the address is changed, the new value must be stored permanently into the NVM. Refer to NVM Programming for programming instructions.

### 図 6-11. Multi-PMIC Configuration Example

注

- The synchronization-times between the PMICs add to the slot-duration-timeout described in the Power-up and Power-Down sections: If power-up fails, the timeout tTIMEOUT\_UV\_SLOT occurs 3ms to 4ms later in multi-PMIC-configurations. If power-down fails due to discharge failing, the timeout occurs 20 ms to 26 ms later in multi-PMIC configurations.
- GPIO\_EN and GPIO\_STBY\_EN bits are ignored in multi-PMIC configuration.

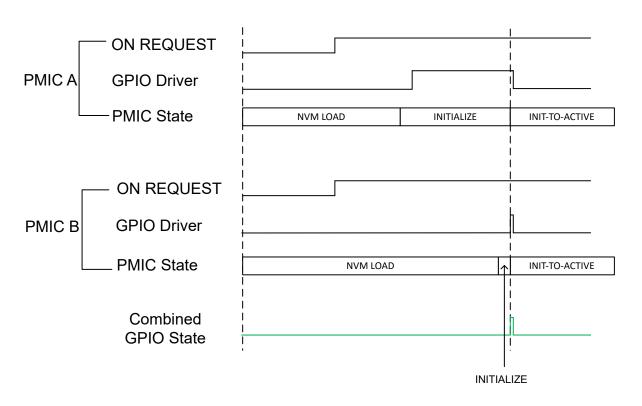
⊠ 6-12 shows the synchronization between two PMICs in Initialize state, before the power-up sequence is executed. While in INITIALIZE state, before the ON request is received, devices hold GPIO low. GPIO is only released when the ON request is received. The external signal driving the ON request must be connected to EN/PB/VSENSE pin of both devices. The PMICs proceed to execute the power-up sequence once both devices are in INITIALIZE state and both devices have received the ON request. This technique ensures both devices start the power-up sequence at the same time, even if they have different internal boot-up times.

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## On request before devices are in INITIALIZE:



## On request after devices are in INITIALIZE:

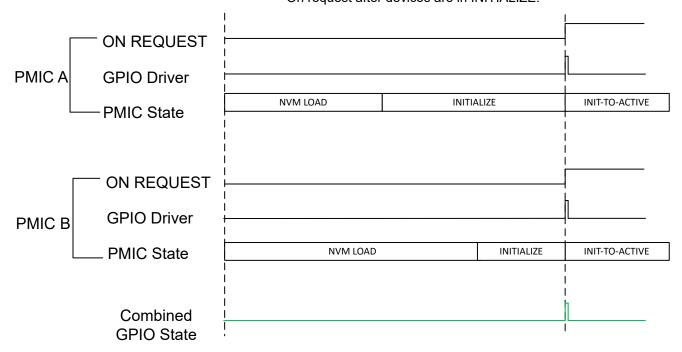


図 6-12. Synchronization before Power-up

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⊠ 6-13 shows the synchronization between two PMICs during the power-up sequence. An open-drain GPIO is connected between both PMICs, and used as an indicator that the sequence slot has finished for the device. At the beginning of each sequence slot, both PMICs pull down this GPIO. After the device slot timer has expired, and all rails for that slot have reach UV threshold, the GPIO is released high. The combined GPIO goes high when both PMICs have released the GPIO. Once both devices release the GPIO high, both PMICs advance to the next sequence slot. Both PMICs are always in the same sequence slot at the same time.

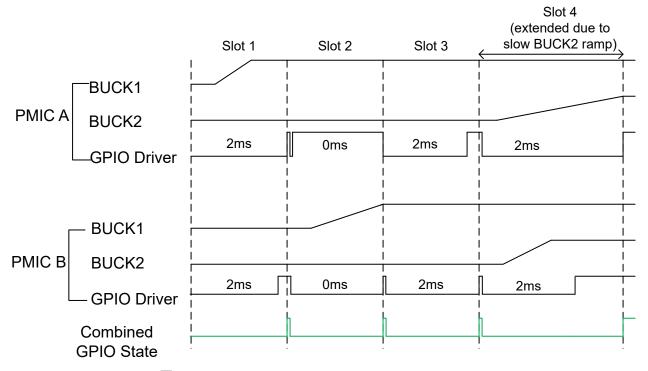


図 6-13. Synchronization during power-up sequence

⊠ 6-14 shows the synchronization between two PMICs when transitioning from Active to Standby. In active or standby, GPIO default state is high. When a device wants to change states, it sets the GPIO low for a specific low duration. The low duration determines the type of request. For STANDBY/ACTIVE request, GPIO is set low approximately 38-52us and for OFF request approximately 180-243us. Times are chosen such that devices always see the same state transition, accounting for clock variation and requests happening right after each other. While GPIO is low, devices are counting the time it is low. On GPIO rising edge, devices start the state transition based on low duration. If GPIO stays low longer than the timeout duration, it indicates a GPIO fault and devices transition to INITIALIZE state.

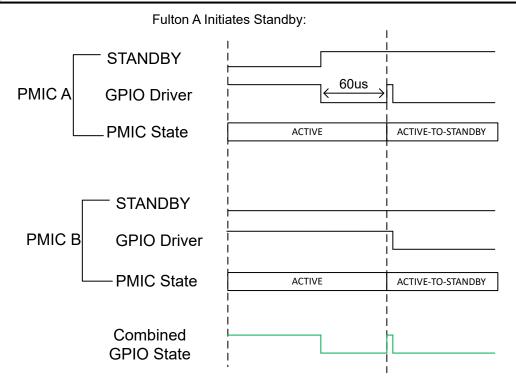


図 6-14. Synchronization before transitioning to Standby/OFF request/COLD RESET

⊠ 6-15 shows the synchronization between two PMICs during power-down sequence. Power-down sequence works similarly. If active discharge is enabled for a rail, the sequence slot is extended until rail is discharged below SCG threshold, unless the slot timeout occurs or register field BYPASS\_RAILS\_DISCHA RGED\_CHECK is set. If discharge is disabled for all rails in current slot, the actual slot time is only based on selected slot duration. Once the slot duration expires and rails with active discharge are discharged, devices release the GPIO high. Once all devices release GPIO high, they advance to the next power-down step.

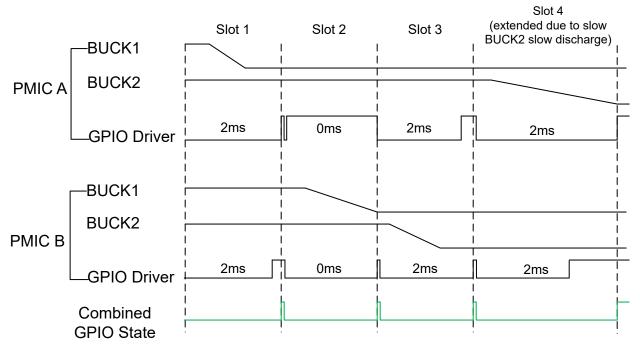


図 6-15. Synchronization during power-down sequence

⊠ 6-16 shows the timeout synchronization between two PMICs. In case of a fault on an output rail, GPIO is not released. After a timeout, device goes to "timeout synchronization" state, and wait for 3ms before setting GPIO high. Once the combined GPIO goes high, both devices start the power-down sequence. For example: If BUCK1 from PMIC A is shorted to GND, after the slot duration expires, the regulator does not have hit UV and GPIO is not released. If Slot#1 duration is 10ms and PMIC A is 10% fast, it only takes 9ms to timeout. After timeout, device goes to timeout-sync state, at which point GPIO is set high after 3ms. PMIC B rails ramp up properly, but a high state on GPIO from PMIC A is initially not detected due to the fault on BUCK1. PMIC B also goes to timeout-sync state and sets GPIO high after 3ms. After the timeout sync of PMIC B, the combined GPIO is high and both PMICs start power-down together.

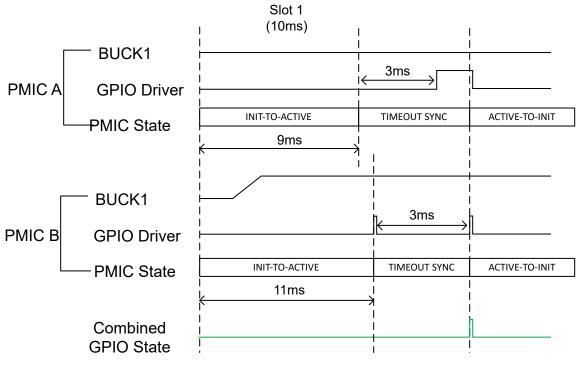


図 6-16. Timeout Synchronization

## 6.6 NVM Programming

The TPS6521905 is part of Texas Instruments user-programmable PMICs. This device integrates a NVM memory that provides the ability to configure the power and digital resources. The NVM programming feature makes the TPS6521905 PMIC a flexible power solution to meet the requirements from different processors and SoCs. Programmable NVM fields include output voltages, sequencing, monitoring thresholds, GPIO control among others. OTA (Over The Air) programming, where EEPROM can be change directly without changing register settings, is not supported. Re-programming the NVM is done by first writing to the register map through the serial interface (I2C) and then saving the register settings into the NVM. The EEPROM of a device can only be programmed up to 1000 times. EEPROM values can only be changed if the input voltage (VSYS) is equal or greater than 3.3 V. The I2C pins must be pulled up to a 3.3V supply. At a high level, the programming flow can be described in three steps: determine your system requirements, update the register settings, save the new values into the NVM memory. Detailed information regarding the programming of the non-volatile memory is available in the NVM Programming Guide located under Technical documentation in the TPS6521905 product page on ti.com.

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注

Writing 0x0A to register address 0x34 commits the current register settings to NVM memory so they become the new power-up defaults. Customer programmable registers correspond to addresses 0x0 to 0x27. Only bits marked with (X) in the reset column of the register map have EEPROM programmable default settings. All other bits keep the factory settings listed in the register map.

## 6.6.1 TPS6521905 default NVM settings

The user-programmable variant comes with all Bucks, LDOs and GPIOs disabled by default and the corresponding output voltage registers set to the lowest values. All the NVM register settings are configured as 0h except the ones listed in the table below.

表 6-7. TPS6521905 registers NOT configured as 0h

<b>2,</b>				
Register Address	Bits	Field Name	Value	
0x01	7-0	TI_NVM_ID	0x05	
0x04	7	LDO4_SLOW_PU_RAMP	0x1	
0x05	7	LDO3_SLOW_PU_RAMP	0x1	
0x08	7	BUCK3_BW_SEL	0x1	
0x09	7	BUCK2_BW_SEL	0x1	
0x0A	7	BUCK1_BW_SEL	0x1	
0x20	5-4	EN_PB_VSENSE_CONFIG	0x1	
0x25	7	MASK_INT_FOR_PB	0x1	
0x26	6-0	I2C_ADDRESS	0x30	

#### 6.6.2 NVM programming in Initialize State

NVM programming can be done in Initialize or Active state. The current state can be read from STATE bits (bits 4-3) in POWER\_UP\_STATUS\_REG register. After a valid supply is connected to VSYS, the device goes to Initialize state and loads the default NVM content into the register map. Loading the NVM content takes approximately 2.3ms. Once register map is loaded with the default settings, PMIC is ready for NVM programming. 

6-17 shows the steps required to reprogram the NVM in Initialize state while the PMIC rails are OFF. The process starts with enabling the oscillator for I2C communication. This command also disables the rails active discharge. Then, update the NVM register fields and save the new settings into the memory. Several register settings are available to indicate the status of an I2C command. For example, Register field CUST\_PROG\_DONE (bit 5, address 0x34) indicates the status of the NVM programming after CUST\_PROG\_CMD is executed. Similarly, register field CUST\_NVM\_VERIFY\_DONE (bit 6, address 0x34) indicates the status (not the result) of the NVM verification after CUST\_NVM\_VERIFY\_CMD is executed.

注

For in-circuit programming, it is recommended to temporarily disconnect the PMIC rail from the I2C lines while using an external 3.3V to re-program the NVM. Since regulators are disabled in Initialize state, their active discharge is enabled. This active discharge feature can dissipate power from the external 3.3V supply if it is sharing the same voltage node with a PMIC rail. If disconnecting the PMIC rail is not an option, then the EN\_OSC\_DIY command must be send immediately (within ~10 seconds) after the 3.3V VIO is supplied in Initialize state. Discharge is disabled after the EN\_OSC\_DIY command is received.



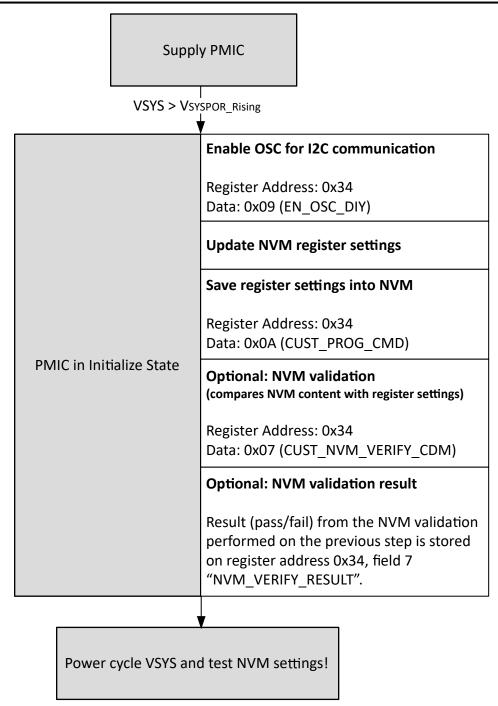


図 6-17. NVM Programming steps

## 6.6.3 NVM Programming in Active State

It is recommended to re-program the NVM in Initialize state. However, programming can also be done in Active state. Programming in ACTIVE state poses some risk, as changes take effect immediately. The expected PMIC behavior and the effects at the system level must be evaluated before making changes like the I2C address, function of digital pins, polarity among others. NVM changes like the rails output voltages, UV monitoring, enable settings and MASK can be done in Active state.

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注

Programming in Active state does not require sending an I2C command (EN\_OSC\_DIY) to enable the internal oscillator for I2C communication. The reason is because I2c communication is enabled by default in Initialize state.

## 6.7 User Registers

The registers up to register 27h, USER\_GENERAL\_NVM\_STORAGE\_REG are backed up by EEPROM. The reset value corresponds to the configuration of the orderable part number and is signified by an 'X' herein. Please refer to the Technical Reference Manual (TRM) of the respective orderable part-number.

The registers 28h through 37h are not EEPROM-backed and reset to the value shown in the register map.

Registers 00h, TI\_DEV\_ID, 01h, NVM\_ID, 28h, MANUFACTURING\_VER and 41h, FACTORY\_CONFIG\_2 are hard-wired and cannot be changed by the user.

## 6.8 Device Registers

表 6-8 lists the memory-mapped registers for the Device registers. All register offset addresses not listed in 表 6-8 should be considered as reserved locations and the register contents should not be modified.

表 6-8. DEVICE Registers

Offset	Acronym	Register Name	Section
0h	TI_DEV_ID	Device ID	Go
1h	NVM_ID	NVM configuration ID	Go
2h	ENABLE_CTRL	Enable/Push-Button/Vsense Control	Go
3h	BUCKS_CONFIG	Generic Buck Configuration	Go
4h	LDO4_VOUT	LDO4 Configuration	Go
5h	LDO3_VOUT	LDO3 Configuration	Go
6h	LDO2_VOUT	LDO2 Configuration	Go
7h	LDO1_VOUT	LDO1 Configuration	Go
8h	BUCK3_VOUT	Buck3 Configuration	Go
9h	BUCK2_VOUT	Buck2 Configuration	Go
Ah	BUCK1_VOUT	Buck1 Configuration	Go
Bh	LDO4_SEQUENCE_SLOT	Power-up and -down slot for LDO4	Go
Ch	LDO3_SEQUENCE_SLOT	Power-up and -down slot for LDO3	Go
Dh	LDO2_SEQUENCE_SLOT	Power-up and -down slot for LDO2	Go
Eh	LDO1_SEQUENCE_SLOT	Power-up and -down slot for LDO10	Go
Fh	BUCK3_SEQUENCE_SLOT	Power-up and -down slot for Buck3	Go
10h	BUCK2_SEQUENCE_SLOT	Power-up and -down slot for Buck2	Go
11h	BUCK1_SEQUENCE_SLOT	Power-up and -down slot for Buck1	Go
12h	nRST_SEQUENCE_SLOT	Power-up and -down slot for nRSTOUT	Go
13h	GPIO_SEQUENCE_SLOT	Power-up and -down slot for GPIO	Go
14h	GPO2_SEQUENCE_SLOT	Power-up and -down slot for GPO2	Go
15h	GPO1_SEQUENCE_SLOT	Power-up and -down slot for GPO1	Go
16h	POWER_UP_SLOT_DURATION _1	Slot-duration at power-up for slot0-3	Go
17h	POWER_UP_SLOT_DURATION _2	Slot-duration at power-up for slot4-7	Go
18h	POWER_UP_SLOT_DURATION _3	Slot-duration at power-up for slot8-11	Go

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表 6-8. DEVICE Registers (続き)

19h POWER_UP_SLOT_DURATION Stot-duration at power-up for stot12-15 Go _4  1Ah POWER_DOWN_SLOT_DURATI Stot-duration at power-down for stot0-3 ON_1  1Bh POWER_DOWN_SLOT_DURATI Stot-duration at power-down for stot0-3 ON_2  1ch POWER_DOWN_SLOT_DURATI Stot-duration at power-down for stot0-17 ON_3  1ch POWER_DOWN_SLOT_DURATI Stot-duration at power-down for stot0-11 ON_3  1ch POWER_DOWN_SLOT_DURATI Stot-duration at power-down for stot0-11 ON_3  1ch POWER_DOWN_SLOT_DURATI Stot-duration at power-down for stot12-15 ON_4  1ch GENERAL_CONFIG LDO-undervoltage and GPO-enable Go ON_1  1ch GENERAL_CONFIG Multi-Function pin configuration 1 Go ON_4  1ch GENERAL_CONFIG Multi-Function pin configuration 1 Go ON_4  1ch STBY_1_CONFIG Multi-Function pin configuration 2 Go ON_1  1ch STBY_1_CONFIG STBY configuration LDOs and Bucks Go ON_1  1ch STBY_1_CONFIG STBY configuration LDOs and Bucks Go ON_2  1ch STBY_1_CONFIG STBY configuration DPIO and GPO Go ON_2  1ch STBY_1_CONFIG Overcurrent deglitch time per rail Go ON_2  1ch INT_MASK_UV Undervoltage fault-masking Go ON_2  1ch INT_BUCK_12 OC, UV, SCG for Buck1 and Buck2  1ch INT_BUCK_12 OC, UV, SCG for Buck1 and Buck2  1ch INT_BUCK_12 OC, UV, SCG for Buck1 and Buck2  1ch INT_BUCK_12 OC, UV, SCG for Buck1 and Buck2  1ch INT_BU			及 0-0. DEVICE Registers (税と)	
1	Offset	Acronym	Register Name	Section
ON_1	19h		Slot-duration at power-up for slot12-15	Go
ON_2	1Ah		Slot-duration at power-down for slot0-3	Go
ON_3	1Bh		Slot-duration at power-down for slot4-7	Go
ON_4	1Ch		Slot-duration at power-down for slot8-11	Go
1Fh         MFP_1_CONFIG         Multi-Function pin configuration1         Go           20h         MFP_2_CONFIG         Multi-Function pin configuration2         Go           21h         STBY_1_CONFIG         STBY configuration LDOs and Bucks         Go           22h         STBY_2_CONFIG         STBY configuration GPIO and GPO         Go           23h         OC_DEGL_CONFIG         Overcurrent degithen time per rail         Go           24h         INT_MASK_UV         Undervoltage fault-masking         Go           25h         MASK_CONFIG         WARM-masking and mask-effect         Go           26h         I2C_ADDRESS_REG         I2C-address         Go           27h         USER_GENERAL_NVM_STORA         User-configurable register (NVM-backed)         Go           28h         MANUFACTURING_VER         Silicon-revision (read-only)         Go           29h         MFP_CTRL         I2C-control for RESET, STBY, OFF         Go           28h         INT_SOURCE         Interrupt source         Go           2bh         INT_LDO_3_4         OC, UV, SCG for LDO3 and LDO4         Go           2ch         INT_LDO_1_2         OC, UV, SCG for Buck1         Go           2fh         INT_BUCK_1_2         OC, UV, SCG for Buck1 and Buck2         Go <td>1Dh</td> <td></td> <td>Slot-duration at power-down for slot12-15</td> <td>Go</td>	1Dh		Slot-duration at power-down for slot12-15	Go
20h         MFP_2_CONFIG         Multi-Function pin configuration 2         Go           21h         STBY_1_CONFIG         STBY configuration LDOs and Bucks         Go           22h         STBY_2_CONFIG         STBY configuration GPIO and GPO         Go           23h         OC_DEGL_CONFIG         Overcurrent deglitch time per rall         Go           24h         INT_MASK_UV         Undervoltage fault-masking         Go           25h         MASK_CONFIG         WARM-masking and mask-effect         Go           26h         I2C_ADDRESS_REG         I2C-address         Go           27h         USER_GENERAL_NVM_STORA         User-configurable register (NVM-backed)         Go           27h         USER_GENERAL_NVM_STORA         User-configuration per jester (NVM-backed)         Go           28h         MANUFACTURING_VER         Silicon-revision (read-only)         Go           29h         MFP_CTRL         I2C-control for RESET, STBY, OFF         Go           29h         MFP_CTRL         I2C-control for RESET, STBY, OFF         Go           20h         INT_SOURCE         Interrupt source         Go           20h         INT_LDO_3_4         OC, UV, SCG for LDO3 and LDO4         Go           20h         INT_LDO_1_2         OC, UV, SCG for Buck3	1Eh	GENERAL_CONFIG	LDO-undervoltage and GPO-enable	Go
21h         STBY_1_CONFIG         STBY configuration LDOs and Bucks         Go           22h         STBY_2_CONFIG         STBY configuration GPIO and GPO         Go           23h         OC_DEGL_CONFIG         Overcurrent deglitch time per rail         Go           24h         INT_MASK_UV         Undervoltage fault-masking         Go           25h         MASK_CONFIG         WARM-masking and mask-effect         Go           26h         I2C_ADDRESS_REG         I2C-address         Go           27h         USER_GENERAL_NVM_STORA         User-configurable register (NVM-backed)         Go           28h         MANUFACTURING_VER         Silicon-revision (read-only)         Go           29h         MFP_CTRL         12C-control for RESET, STBY, OFF         Go           28h         INT_SOURCE         Interrupt source         Go           20h         INT_LDO_3_4         OC, UV, SCG for LDO3 and LDO4         Go           20h         INT_LDO_1_2         OC, UV, SCG for Buck3         Go           22h         INT_BUCK_3         OC, UV, SCG for Buck3         Go           25h         INT_BUCK_1_2         OC, UV, SCG for Buck1 and Buck2         Go           30h         INT_SYSTEM         WARM and HOT fault flags         Go	1Fh	MFP_1_CONFIG	Multi-Function pin configuration1	Go
22h         STBY_2_CONFIG         STBY configuration GPIO and GPO         Go           23h         OC_DEGL_CONFIG         Overcurrent deglitch time per rail         Go           24h         INT_MASK_UV         Undervoltage fault-masking         Go           25h         MASK_CONFIG         WARM-masking and mask-effect         Go           26h         I2C_ADDRESS_REG         I2C-address         Go           27h         USER_GENERAL_NVM_STORA GE_REG         User-configurable register (NVM-backed)         Go           28h         MANUFACTURING_VER         Silicon-revision (read-only)         Go           28h         MANUFACTURING_VER         Silicon-revision (read-only)         Go           29h         MFP_CTRL         I2C-control for RESET, STBY, OFF         Go           20h         DISCHARGE_CONFIG         Discharge configuration per rail         Go           2bh         INT_SOURCE         Interrupt source         Go           2ch         INT_LDO_3_4         OC, UV, SCG for LDO3 and LDO4         Go           2ch         INT_LDO_1_2         OC, UV, SCG for Buck3         Go           2fh         INT_BUCK_3         OC, UV, SCG for Buck1         Go           3ch         INT_SYSTEM         WARM and HOT fault flags         Go	20h	MFP_2_CONFIG	Multi-Function pin configuration2	Go
23h         OC_DEGL_CONFIG         Overcurrent deglitch time per rail         Go           24h         INT_MASK_UV         Undervoltage fault-masking         Go           25h         MASK_CONFIG         WARM-masking and mask-effect         Go           26h         I2C_ADDRESS_REG         I2C-address         Go           27h         USER_GENERAL_NVM_STORA User-configurable register (NVM-backed)         Go           28h         MANUFACTURING_VER         Silicon-revision (read-only)         Go           28h         MAPL_CTRL         I2C-control for RESET, STBY, OFF         Go           29h         MFP_CTRL         I2C-control for RESET, STBY, OFF         Go           29h         INT_SOURCE         Interrupt source         Go           20h         INT_LDO_3_4         OC, UV, SCG for LDO3 and LDO4         Go           20h         INT_LDO_1_2         OC, UV, SCG for Buck3         Go           22h         INT_BUCK_3         OC, UV, SCG for Buck3         Go           25h         INT_BUCK_1_2         OC, UV, SCG for Buck1 and Buck2         Go           30h         INT_SYSTEM         WARM and HOT fault flags         Go           31h         INT_RV         RV (residual voltage) per rail         Go           32h	21h	STBY_1_CONFIG	STBY configuration LDOs and Bucks	Go
24h     INT_MASK_UV     Undervoltage fault-masking     Go       25h     MASK_CONFIG     WARM-masking and mask-effect     Go       26h     I2C_ADDRESS_REG     I2C-address     Go       27h     USER_GENERAL_NVM_STORA     User-configurable register (NVM-backed)     Go       28h     MANUFACTURING_VER     Silicon-revision (read-only)     Go       29h     MFP_CTRL     I2C-control for RESET, STBY, OFF     Go       29h     MFP_CTRL     I2C-control for RESET, STBY, OFF     Go       20h     DISCHARGE_CONFIG     Discharge configuration per rail     Go       28h     INT_SOURCE     Interrupt source     Go       20h     INT_LDO_3_4     OC, UV, SCG for LDO3 and LDO4     Go       20h     INT_LDO_1_2     OC, UV, SCG for Buck3     Go       20h     INT_BUCK_3     OC, UV, SCG for Buck3     Go       27h     INT_BUCK_1_2     OC, UV, SCG for Buck1 and Buck2     Go       30h     INT_SYSTEM     WARM and HOT fault flags     Go       31h     INT_RV     RV (residual voltage) per rail     Go       32h     INT_TIMEOUT_RV_SD     RV (residual voltage) per rail causing shut-down     Go       33h     INT_PB     PushButton status and edge-detection     Go       34h     USER_NVM_CMD_REG     DIY -	22h	STBY_2_CONFIG	STBY configuration GPIO and GPO	Go
25h     MASK_CONFIG     WARM-masking and mask-effect     Go       26h     I2C_ADDRESS_REG     I2C-address     Go       27h     USER_GENERAL_NVM_STORA     User-configurable register (NVM-backed)     Go       28h     MANUFACTURING_VER     Silicon-revision (read-only)     Go       29h     MFP_CTRL     I2C-control for RESET, STBY, OFF     Go       2Ah     DISCHARGE_CONFIG     Discharge configuration per rail     Go       2Bh     INT_SOURCE     Interrupt source     Go       2Ch     INT_LDO_3_4     OC, UV, SCG for LDO3 and LDO4     Go       2Dh     INT_LDO_1_2     OC, UV, SCG for Buck3     Go       2Eh     INT_BUCK_3     OC, UV, SCG for Buck3     Go       2Fh     INT_BUCK_1_2     OC, UV, SCG for Buck1 and Buck2     Go       30h     INT_SYSTEM     WARM and HOT fault flags     Go       31h     INT_RV     RV (residual voltage) per rail     Go       32h     INT_TIMEOUT_RV_SD     RV (residual voltage) per rail causing shut-down     Go       33h     INT_PB     PushButton status and edge-detection     Go       34h     USER_NVM_CMD_REG     DIY - user programming commands     Go       36h     SPARE_2Spare register (not NVM-backed)     Go       37h     SPARE_3Spare register (	23h	OC_DEGL_CONFIG	Overcurrent deglitch time per rail	Go
26h       I2C_ADDRESS_REG       I2C-address       Go         27h       USER_GENERAL_NVM_STORA GE_REG       User-configurable register (NVM-backed)       Go         28h       MANUFACTURING_VER       Silicon-revision (read-only)       Go         29h       MFP_CTRL       I2C-control for RESET, STBY, OFF       Go         2Ah       DISCHARGE_CONFIG       Discharge configuration per rail       Go         2Bh       INT_SOURCE       Interrupt source       Go         2Ch       INT_LDO_3_4       OC, UV, SCG for LDO3 and LDO4       Go         2Dh       INT_LDO_1_2       OC, UV, SCG for Buck3       Go         2Eh       INT_BUCK_3       OC, UV, SCG for Buck3       Go         2Fh       INT_BUCK_1_2       OC, UV, SCG for Buck1 and Buck2       Go         30h       INT_SYSTEM       WARM and HOT fault flags       Go         31h       INT_RV       RV (residual voltage) per rail       Go         32h       INT_TIMEOUT_RV_SD       RV (residual voltage) per rail causing shut-down       Go         33h       INT_PB       PushButton status and edge-detection       Go         34h       USER_NVM_CMD_REG       DIY - user programming commands       Go         35h       POWER_UP_STATUS_REG       Power-up status an	24h	INT_MASK_UV	Undervoltage fault-masking	Go
27h USER_GENERAL_NVM_STORA User-configurable register (NVM-backed) GE_REG  28h MANUFACTURING_VER Silicon-revision (read-only) Go 29h MFP_CTRL I2C-control for RESET, STBY, OFF Go 2Ah DISCHARGE_CONFIG Discharge configuration per rail Go 2Bh INT_SOURCE Interrupt source Go 2Ch INT_LDO_3_4 OC, UV, SCG for LDO3 and LDO4 Go 2Dh INT_LDO_1_2 OC, UV, SCG for LDO1 and LDO2 Go 2Eh INT_BUCK_3 OC, UV, SCG for Buck3 Go 2Fh INT_BUCK_1_2 OC, UV, SCG for Buck1 and Buck2 Go 30h INT_SYSTEM WARM and HOT fault flags Go 31h INT_RV RV (residual voltage) per rail Go 32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut-down 33h INT_PB PushButton status and edge-detection Go 34h USER_NVM_CMD_REG DIY - user programming commands Go 35h POWER_UP_STATUS_REG Power-up status and STATE Go 37h SPARE_2 Spare register (not NVM-backed) Go	25h	MASK_CONFIG	WARM-masking and mask-effect	Go
GE_REG  28h MANUFACTURING_VER Silicon-revision (read-only) Go  29h MFP_CTRL I2C-control for RESET, STBY, OFF Go  2Ah DISCHARGE_CONFIG Discharge configuration per rail Go  2Bh INT_SOURCE Interrupt source Go  2Ch INT_LDO_3_4 OC, UV, SCG for LDO3 and LDO4 Go  2Dh INT_LDO_1_2 OC, UV, SCG for LDO1 and LDO2 Go  2Eh INT_BUCK_3 OC, UV, SCG for Buck3 Go  2Fh INT_BUCK_1_2 OC, UV, SCG for Buck1 and Buck2 Go  30h INT_SYSTEM WARM and HOT fault flags Go  31h INT_RV RV (residual voltage) per rail Go  32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut-down  33h INT_PB PushButton status and edge-detection Go  34h USER_NVM_CMD_REG DIY - user programming commands Go  35h POWER_UP_STATUS_REG Power-up status and STATE Go  36h SPARE_2 Spare register (not NVM-backed) Go	26h	I2C_ADDRESS_REG	I2C-address	Go
29h MFP_CTRL I2C-control for RESET, STBY, OFF Go 2Ah DISCHARGE_CONFIG Discharge configuration per rail Go 2Bh INT_SOURCE Interrupt source Go 2Ch INT_LDO_3_4 OC, UV, SCG for LDO3 and LDO4 Go 2Dh INT_LDO_1_2 OC, UV, SCG for LDO1 and LDO2 Go 2Eh INT_BUCK_3 OC, UV, SCG for Buck3 Go 2Fh INT_BUCK_1_2 OC, UV, SCG for Buck1 and Buck2 Go 30h INT_SYSTEM WARM and HOT fault flags Go 31h INT_RV RV (residual voltage) per rail Go 32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut-down 33h INT_PB PushButton status and edge-detection Go 34h USER_NVM_CMD_REG DIY - user programming commands Go 35h POWER_UP_STATUS_REG Power-up status and STATE Go 36h SPARE_2 Spare register (not NVM-backed) Go	27h	USER_GENERAL_NVM_STORA GE_REG	User-configurable register (NVM-backed)	Go
2Ah DISCHARGE_CONFIG Discharge configuration per rail Go 2Bh INT_SOURCE Interrupt source Go 2Ch INT_LDO_3_4 OC, UV, SCG for LDO3 and LDO4 Go 2Dh INT_LDO_1_2 OC, UV, SCG for LDO1 and LDO2 Go 2Eh INT_BUCK_3 OC, UV, SCG for Buck3 Go 2Fh INT_BUCK_1_2 OC, UV, SCG for Buck1 and Buck2 Go 30h INT_SYSTEM WARM and HOT fault flags Go 31h INT_RV RV (residual voltage) per rail Go 32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut-down 33h INT_PB PushButton status and edge-detection Go 34h USER_NVM_CMD_REG DIY - user programming commands Go 35h POWER_UP_STATUS_REG Power-up status and STATE Go 36h SPARE_2 Spare register (not NVM-backed) Go 37h SPARE_3 Spare register (not NVM-backed)	28h	MANUFACTURING_VER	Silicon-revision (read-only)	Go
2Bh INT_SOURCE Interrupt source Go 2Ch INT_LDO_3_4 OC, UV, SCG for LDO3 and LDO4 Go 2Dh INT_LDO_1_2 OC, UV, SCG for LDO1 and LDO2 Go 2Eh INT_BUCK_3 OC, UV, SCG for Buck3 Go 2Fh INT_BUCK_1_2 OC, UV, SCG for Buck1 and Buck2 Go 30h INT_SYSTEM WARM and HOT fault flags Go 31h INT_RV RV (residual voltage) per rail Go 32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut-down 33h INT_PB PushButton status and edge-detection Go 34h USER_NVM_CMD_REG DIY - user programming commands Go 35h POWER_UP_STATUS_REG Power-up status and STATE Go 36h SPARE_2 Spare register (not NVM-backed) Go 37h SPARE_3 Spare register (not NVM-backed) Go	29h	MFP_CTRL	I2C-control for RESET, STBY, OFF	Go
2Ch INT_LDO_3_4 OC, UV, SCG for LDO3 and LDO4 Go 2Dh INT_LDO_1_2 OC, UV, SCG for LDO1 and LDO2 Go 2Eh INT_BUCK_3 OC, UV, SCG for Buck3 Go 2Fh INT_BUCK_1_2 OC, UV, SCG for Buck1 and Buck2 Go 30h INT_SYSTEM WARM and HOT fault flags Go 31h INT_RV RV (residual voltage) per rail Go 32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut-down Go 33h USER_NVM_CMD_REG DIY - user programming commands Go 35h POWER_UP_STATUS_REG Power-up status and STATE Go 36h SPARE_2 Spare register (not NVM-backed) Go 37h SPARE_3 Spare register (not NVM-backed) Go	2Ah	DISCHARGE_CONFIG	Discharge configuration per rail	Go
2Dh INT_LDO_1_2 OC, UV, SCG for LDO1 and LDO2 Go  2Eh INT_BUCK_3 OC, UV, SCG for Buck3 Go  2Fh INT_BUCK_1_2 OC, UV, SCG for Buck1 and Buck2 Go  30h INT_SYSTEM WARM and HOT fault flags Go  31h INT_RV RV (residual voltage) per rail Go  32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut-down Go  33h INT_PB PushButton status and edge-detection Go  34h USER_NVM_CMD_REG DIY - user programming commands Go  35h POWER_UP_STATUS_REG Power-up status and STATE Go  36h SPARE_2 Spare register (not NVM-backed) Go  37h SPARE_3 Spare register (not NVM-backed) Go	2Bh	INT_SOURCE	Interrupt source	Go
2Eh INT_BUCK_3 OC, UV, SCG for Buck3 Go 2Fh INT_BUCK_1_2 OC, UV, SCG for Buck1 and Buck2 Go 30h INT_SYSTEM WARM and HOT fault flags Go 31h INT_RV RV (residual voltage) per rail Go 32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut-down Go 33h INT_PB PushButton status and edge-detection Go 34h USER_NVM_CMD_REG DIY - user programming commands Go 35h POWER_UP_STATUS_REG Power-up status and STATE Go 36h SPARE_2 Spare register (not NVM-backed) Go 37h SPARE_3 Spare register (not NVM-backed) Go	2Ch	INT_LDO_3_4	OC, UV, SCG for LDO3 and LDO4	Go
2Fh INT_BUCK_1_2 OC, UV, SCG for Buck1 and Buck2 Go 30h INT_SYSTEM WARM and HOT fault flags Go 31h INT_RV RV (residual voltage) per rail Go 32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut- down Go 33h INT_PB PushButton status and edge-detection Go 34h USER_NVM_CMD_REG DIY - user programming commands Go 35h POWER_UP_STATUS_REG Power-up status and STATE Go 36h SPARE_2 Spare register (not NVM-backed) Go 37h SPARE_3 Spare register (not NVM-backed) Go	2Dh	INT_LDO_1_2	OC, UV, SCG for LDO1 and LDO2	Go
30h INT_SYSTEM WARM and HOT fault flags Go 31h INT_RV RV (residual voltage) per rail Go 32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut- down Go 33h INT_PB PushButton status and edge-detection Go 34h USER_NVM_CMD_REG DIY - user programming commands Go 35h POWER_UP_STATUS_REG Power-up status and STATE Go 36h SPARE_2 Spare register (not NVM-backed) Go 37h SPARE_3 Spare register (not NVM-backed) Go	2Eh	INT_BUCK_3	OC, UV, SCG for Buck3	Go
31h INT_RV RV (residual voltage) per rail Go  32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shut- down Go  33h INT_PB PushButton status and edge-detection Go  34h USER_NVM_CMD_REG DIY - user programming commands Go  35h POWER_UP_STATUS_REG Power-up status and STATE Go  36h SPARE_2 Spare register (not NVM-backed) Go  37h SPARE_3 Spare register (not NVM-backed) Go	2Fh	INT_BUCK_1_2	OC, UV, SCG for Buck1 and Buck2	Go
32h INT_TIMEOUT_RV_SD RV (residual voltage) per rail causing shutdown  33h INT_PB PushButton status and edge-detection Go  34h USER_NVM_CMD_REG DIY - user programming commands Go  35h POWER_UP_STATUS_REG Power-up status and STATE Go  36h SPARE_2 Spare register (not NVM-backed) Go  37h SPARE_3 Spare register (not NVM-backed) Go	30h	INT_SYSTEM	WARM and HOT fault flags	Go
down           33h         INT_PB         PushButton status and edge-detection         Go           34h         USER_NVM_CMD_REG         DIY - user programming commands         Go           35h         POWER_UP_STATUS_REG         Power-up status and STATE         Go           36h         SPARE_2         Spare register (not NVM-backed)         Go           37h         SPARE_3         Spare register (not NVM-backed)         Go	31h	INT_RV	RV (residual voltage) per rail	Go
34h USER_NVM_CMD_REG DIY - user programming commands Go 35h POWER_UP_STATUS_REG Power-up status and STATE Go 36h SPARE_2 Spare register (not NVM-backed) Go 37h SPARE_3 Spare register (not NVM-backed) Go	32h	INT_TIMEOUT_RV_SD		Go
35h POWER_UP_STATUS_REG Power-up status and STATE Go 36h SPARE_2 Spare register (not NVM-backed) Go 37h SPARE_3 Spare register (not NVM-backed) Go	33h	INT_PB	PushButton status and edge-detection	Go
36h SPARE_2 Spare register (not NVM-backed) Go 37h SPARE_3 Spare register (not NVM-backed) Go	34h	USER_NVM_CMD_REG	DIY - user programming commands	Go
37h SPARE_3 Spare register (not NVM-backed) Go	35h	POWER_UP_STATUS_REG	Power-up status and STATE	Go
	36h	SPARE_2	Spare register (not NVM-backed)	Go
41h FACTORY CONFIG 2 Revision of NVM-configuration (read only) Go	37h	SPARE_3	Spare register (not NVM-backed)	Go
	41h	FACTORY_CONFIG_2	Revision of NVM-configuration (read only)	Go

Complex bit access types are encoded to fit into small table cells.  $\frac{1}{2}$  6-9 shows the codes that are used for access types in this section.

表 6-9. Device Access Type Codes

Access Type	Code	Description
Read Type		
R	R	Read
Write Type		

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# 表 6-9. Device Access Type Codes (続き)

Access Type	Code	Description			
W	w	Write			
W1C	W 1C	Write 1 to clear			
WSelfClrF	W	Write			
Reset or Defaul	Reset or Default Value				
-n		Value after reset or the default value			

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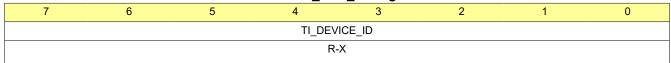
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## 6.8.1 TI\_DEV\_ID Register (Offset = 0h) [Reset = X]

TI\_DEV\_ID is shown in 図 6-18 and described in 表 6-10.

Return to the Summary Table.

## 図 6-18. TI\_DEV\_ID Register



## 表 6-10. TI\_DEV\_ID Register Field Descriptions

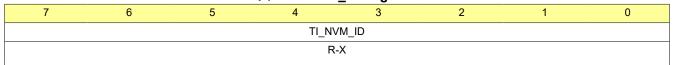
Bit	Field	Туре	Reset	Description
7-0	TI_DEVICE_ID	R	X	TI_DEVICE_ID[7:6]: 0h = TA: -40°C to 105°C, TJ: -40°C to 125°C 2h = TA: -40°C to 125°C, TJ: -40°C to 150°C 3h = TA: -55°C to 125°C, TJ: -55°C to 150°C TI_DEVICE_ID[5:0]: Device GPN Note: This register can be programmed only by the manufacturer! Refer to Technical Reference Manual / User's Guide for specific numbering and associated configuration. (Default from NVM memory)

## 6.8.2 NVM\_ID Register (Offset = 1h) [Reset = X]

NVM\_ID is shown in 図 6-19 and described in 表 6-11.

Return to the Summary Table.

## 図 6-19. NVM\_ID Register



# 表 6-11. NVM\_ID Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	TI_NVM_ID	R		NVM ID of the IC Note: This register can be programmed only by the manufacturer! Refer to Technical Reference Manual / User's Guide for specific numbering and associated configuration. (Default from NVM memory)

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## 6.8.3 ENABLE\_CTRL Register (Offset = 2h) [Reset = X]

ENABLE\_CTRL is shown in 図 6-20 and described in 表 6-12.

Return to the Summary Table.

## 図 6-20. ENABLE\_CTRL Register

7	6	5	4	3	2	1	0
RESERVED	LDO4_EN	LDO3_EN	LDO2_EN	LDO1_EN	BUCK3_EN	BUCK2_EN	BUCK1_EN
R-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X

## 表 6-12. ENABLE\_CTRL Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	LDO4_EN	R/W	Х	Enable LDO4 regulator (Default from NVM memory) 0h = Disabled 1h = Enabled
5	LDO3_EN	R/W	Х	Enable LDO3 regulator (Default from NVM memory) 0h = Disabled 1h = Enabled
4	LDO2_EN	R/W	Х	Enable LDO2 regulator (Default from NVM memory) 0h = Disabled 1h = Enabled
3	LDO1_EN	R/W	X	Enable LDO1 regulator (Default from NVM memory) 0h = Disabled 1h = Enabled
2	BUCK3_EN	R/W	Х	Enable BUCK3 regulator (Default from NVM memory) 0h = Disabled 1h = Enabled
1	BUCK2_EN	R/W	Х	Enable BUCK2 regulator (Default from NVM memory) 0h = Disabled 1h = Enabled
0	BUCK1_EN	R/W	Х	Enable BUCK1 regulator (Default from NVM memory) 0h = Disabled 1h = Enabled

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## 6.8.4 BUCKS\_CONFIG Register (Offset = 3h) [Reset = X]

BUCKS\_CONFIG is shown in 図 6-21 and described in 表 6-13.

Return to the Summary Table.

## 図 6-21. BUCKS\_CONFIG Register

7	6	5	4	3	2	1	0
USER_NVM_S PARE_2	USER_NVM_S PARE_1	BUCK_SS_EN ABLE	BUCK_FF_ENA BLE	BUCK3_PHA	SE_CONFIG	BUCK2_PHAS	SE_CONFIG
R/W-X	R/W-X	R/W-X	R/W-X	R/V	V-X	R/W	/-X

## 表 6-13. BUCKS\_CONFIG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	USER_NVM_SPARE_2	R/W	Х	Spare bit in user NVM space (Default from NVM memory)
6	USER_NVM_SPARE_1	R/W	X	Spare bit in user NVM space (Default from NVM memory)
5	BUCK_SS_ENABLE	R/W	Х	Spread spectrum enabled on Bucks (only applicable in FF-mode) (Default from NVM memory) 0h = Spread spectrum disabled 1h = Spread spectrum enabled
4	BUCK_FF_ENABLE	R	X	All Bucks set into fixed frequency mode NOTE: MUST NOT CHANGE AT ANY TIME! (Default from NVM memory)  0h = Quasi-fixed frequency mode  1h = Fixed frequency mode
3-2	BUCK3_PHASE_CONFIG	R/W	X	Phase of BUCK3 clock. Applicable if Bucks are configured for fixed frequency. NOTE: ONLY CHANGE WHILE RAIL IS DISABLED! (Default from NVM memory)  0h = 0 degrees 1h = 90 degrees 2h = 180 degrees 3h = 270 degrees
1-0	BUCK2_PHASE_CONFIG	R/W	X	Phase of BUCK2 clock. Applicable if Bucks are configured for fixed frequency. NOTE: ONLY CHANGE WHILE RAIL IS DISABLED! (Default from NVM memory)  0h = 0 degrees 1h = 90 degrees 2h = 180 degrees 3h = 270 degrees

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## 6.8.5 LDO4\_VOUT Register (Offset = 4h) [Reset = X]

LDO4\_VOUT is shown in 図 6-22 and described in 表 6-14.

Return to the Summary Table.

# 図 6-22. LDO4\_VOUT Register



## 表 6-14. LDO4 VOUT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	LDO4_SLOW_PU_RAMP	R/W	X	LDO4 Power-up ramp When set high, slows down the power-up ramp to ~3ms. Cout max 30uF When set low, ramp time is ~660us. Cout max 15uF (Default from NVM memory)  0h = Fast ramp for power-up (~660us)  1h = Slow ramp for power-up (~3ms)
6	LDO4_LSW_CONFIG	R/W	Х	LDO4 LDO or LSW Mode. NOTE: ONLY CHANGE WHILE RAIL IS DISABLED! (Default from NVM memory) 0h = LDO Mode 1h = LSW Mode

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# 表 6-14. LDO4\_VOUT Register Field Descriptions (続き)

Bit	Field		Reset	ter Field Descriptions (続き) Description
		Туре		-
5-0	LDO4_VSET	R/W	X	Voltage selection for LDO4. The output voltage range is from 1.2V to 3.3V. (Default from NVM memory)
				0h = 1.200V
				1h = 1.200V
				2h = 1.200V
				3h = 1.200V
				4h = 1.200V
				5h = 1.200V 6h = 1.200V
				7h = 1.200V
				8h = 1.200V
				9h = 1.200V
				Ah = 1.200V
				Bh = 1.200V
				Ch = 1.200V
				Dh = 1.250V Eh = 1.300V
				Fh = 1.350V
				10h = 1.400V
				11h = 1.450V
				12h = 1.500V
				13h = 1.550V
				14h = 1.600V
				15h = 1.650V   16h = 1.700V
				17h = 1.750V
				18h = 1.800V
				19h = 1.850V
				1Ah = 1.900V
				1Bh = 1.950V
				1Ch = 2.000V
				1Dh = 2.050V
				1Eh = 2.100V 1Fh = 2.150V
				20h = 2.200V
				21h = 2.250V
				22h = 2.300V
				23h = 2.350V
				24h = 2.400V
				25h = 2.450V
				26h = 2.500V 27h = 2.550V
				28h = 2.600V
				29h = 2.650V
				2Ah = 2.700V
				2Bh = 2.750V
				2Ch = 2.800V
				2Dh = 2.850V 2Eh = 2.900V
				2Eh = 2.900V 2Fh = 2.950V
				30h = 3.000V
				31h = 3.050V
				32h = 3.100V
				33h = 3.150V
				34h = 3.200V
				35h = 3.250V
				36h = 3.300V   37h = 3.300V
				38h = 3.300V
				39h = 3.300V
				3Ah = 3.300V
				3Bh = 3.300V
				3Ch = 3.300V
				3Dh = 3.300V
				3Eh = 3.300V

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# 表 6-14. LDO4\_VOUT Register Field Descriptions (続き)

Bit	Field	Туре	Reset	Description
				3Fh = 3.300V

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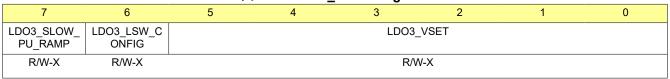
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### 6.8.6 LDO3\_VOUT Register (Offset = 5h) [Reset = X]

LDO3\_VOUT is shown in 図 6-23 and described in 表 6-15.

Return to the Summary Table.

### 図 6-23. LDO3\_VOUT Register



### 表 6-15. LDO3\_VOUT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	LDO3_SLOW_PU_RAMP	R/W	X	LDO3 Power-up ramp When set high, slows down the power-up ramp to ~3ms. Cout max 30uF When set low, ramp time is ~660us. Cout max 15uF (Default from NVM memory)  0h = Fast ramp for power-up (~660us)  1h = Slow ramp for power-up (~3ms)
6	LDO3_LSW_CONFIG	R/W	Х	LDO3 LDO or LSW Mode. NOTE: ONLY CHANGE WHILE RAIL IS DISABLED! (Default from NVM memory) 0h = LDO Mode 1h = LSW Mode

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# 表 6-15. LDO3\_VOUT Register Field Descriptions (続き)

Bit	Field	Type	Reset	ter Field Descriptions (続き) Description
5-0	LDO3_VSET	R/W	X	Voltage selection for LDO3. The output voltage range is from 1.2V to
				3.3V. (Default from NVM memory)
				0h = 1.200V
				1h = 1.200V
				2h = 1.200V
				3h = 1.200V
				4h = 1.200V 5h = 1.200V
				6h = 1.200V
				7h = 1.200V
				8h = 1.200V
				9h = 1.200V
				Ah = 1.200V
				Bh = 1.200V
				Ch = 1.200V Dh = 1.250V
				Eh = 1.300V
				Fh = 1.350V
				10h = 1.400V
				11h = 1.450V
				12h = 1.500V
				13h = 1.550V
				14h = 1.600V   15h = 1.650V
				16h = 1.700V
				17h = 1.750V
				18h = 1.800V
				19h = 1.850V
				1Ah = 1.900V
				1Bh = 1.950V
				1Ch = 2.000V
				1Dh = 2.050V  1Eh = 2.100V
				1Fh = 2.150V
				20h = 2.200V
				21h = 2.250V
				22h = 2.300V
				23h = 2.350V
				24h = 2.400V
				25h = 2.450V
				26h = 2.500V 27h = 2.550V
				28h = 2.600V
				29h = 2.650V
				2Ah = 2.700V
				2Bh = 2.750V
				2Ch = 2.800V
				2Dh = 2.850V
				2Eh = 2.900V 2Fh = 2.950V
				30h = 3.000V
				31h = 3.050V
				32h = 3.100V
				33h = 3.150V
				34h = 3.200V
				35h = 3.250V
				36h = 3.300V
				37h = 3.300V   38h = 3.300V
				39h = 3.300V
				3Ah = 3.300V
				3Bh = 3.300V
				3Ch = 3.300V
				3Dh = 3.300V
				3Eh = 3.300V

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# 表 6-15. LDO3\_VOUT Register Field Descriptions (続き)

Bit	Field	Туре	Reset	Description
				3Fh = 3.300V

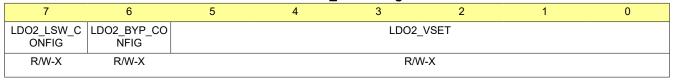
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### 6.8.7 LDO2\_VOUT Register (Offset = 6h) [Reset = X]

LDO2\_VOUT is shown in 図 6-24 and described in 表 6-16.

Return to the Summary Table.

### 図 6-24. LDO2\_VOUT Register



### 表 6-16. LDO2\_VOUT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	LDO2_LSW_CONFIG	R/W	Х	LDO2 LDO/Bypass or LSW Mode. NOTE: ONLY CHANGE WHILE RAIL IS DISABLED! (Default from NVM memory) 0h = Not Applicable (LDO2 not configured as load-switch) 1h = LDO1 configured as Load-switch
6	LDO2_BYP_CONFIG	R/W	X	LDO2 LDO or Bypass Mode. (Default from NVM memory)  0h = LDO2 configured as LDO (only applicable if LDO2_LSW_CONFIG 0x0)  1h = LDO2 configured as Bypass (only applicable if LDO2_LSW_CONFIG 0x0)

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# 表 6-16. LDO2\_VOUT Register Field Descriptions (続き)

<b>Bit</b> 5-0	Field	Туре	Reset	Description
0.0	LDO2_VSET	R/W	X	Voltage selection for LDO2. The output voltage range is from 0.6V to
		1000		3.4V in LDO mode and 1.5V to 3.4V in bypass-mode. (Default from
				NVM memory)
				0h = 0.600V
				1h = 0.650V
				2h = 0.700V
				3h = 0.750V
				4h = 0.800V
				5h = 0.850V
				6h = 0.900V
				7h = 0.950V
				8h = 1.000V
				9h = 1.050V
				Ah = 1.100V
				Bh = 1.150V
				Ch = 1.200V
				Dh = 1.250V
				Eh = 1.300V
				Fh = 1.350V
				10h = 1.400V
				11h = 1.450V
				12h = 1.500V
				13h = 1.550V
				14h = 1.600V
				15h = 1.650V
				16h = 1.700V 17h = 1.750V
				18h = 1.800V
				19h = 1.850V
				1Ah = 1.900V
				1Bh = 1.950V
				1Ch = 2.000V
				1Dh = 2.050V
				1Eh = 2.100V
				1Fh = 2.150V
				20h = 2.200V
				21h = 2.250V
				22h = 2.300V
				23h = 2.350V
				24h = 2.400V
				25h = 2.450V
				26h = 2.500V
				27h = 2.550V
				28h = 2.600V
				29h = 2.650V
				2Ah = 2.700V
				2Bh = 2.750V
				2Ch = 2.800V
				2Dh = 2.850V
				2Eh = 2.900V
				2Fh = 2.950V
				30h = 3.000V
				31h = 3.050V
				32h = 3.100V
				33h = 3.150V
				34h = 3.200V
				35h = 3.250V
				36h = 3.300V
				37h = 3.350V
				38h = 3.400V
				39h = 3.400V
				3Ah = 3.400V
				3Bh = 3.400V
				3Ch = 3.400V
				3Dh = 3.400V



表 6-16. LDO2\_VOUT Register Field Descriptions (続き)

Bit	Field	Туре	Reset	Description
				3Eh = 3.400V 3Fh = 3.400V

### 6.8.8 LDO1\_VOUT Register (Offset = 7h) [Reset = X]

LDO1\_VOUT is shown in 図 6-25 and described in 表 6-17.

Return to the Summary Table.

### 図 6-25. LDO1\_VOUT Register



### 表 6-17. LDO1\_VOUT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	LDO1_LSW_CONFIG	R/W	X	LDO1 LDO/Bypass or LSW Mode. NOTE: ONLY CHANGE WHILE RAIL IS DISABLED! (Default from NVM memory) 0h = Not Applicable (LDO1 not configured as load-switch) 1h = LDO1 configured as Load-switch
6	LDO1_BYP_CONFIG	R/W	X	LDO1 LDO or Bypass Mode. (Default from NVM memory) 0h = LDO1 configured as LDO (only applicable if LDO1_LSW_CONFIG 0x0) 1h = LDO1 configured as Bypass (only applicable if LDO1_LSW_CONFIG 0x0)



表 6-17. LDO1\_VOUT Register Field Descriptions (続き)

Bit	Field	Type	Reset	ter Field Descriptions (続き) Description
5-0	LDO1_VSET	R/W	X	Voltage selection for LDO1. The output voltage range is from 0.6V to
	_			3.4V in LDO-mode and 1.5V to 3.4V in bypass-mode. (Default from
				NVM memory)
				0h = 0.600V
				1h = 0.650V
				2h = 0.700V
				3h = 0.750V 4h = 0.800V
				5h = 0.850V
				6h = 0.900V
				7h = 0.950V
				8h = 1.000V
				9h = 1.050V
				Ah = 1.100V
				Bh = 1.150V
				Ch = 1.200V Dh = 1.250V
				Eh = 1.300V
				Fh = 1.350V
				10h = 1.400V
				11h = 1.450V
				12h = 1.500V
				13h = 1.550V
				14h = 1.600V
				15h = 1.650V
				16h = 1.700V 17h = 1.750V
				18h = 1.800V
				19h = 1.850V
				1Ah = 1.900V
				1Bh = 1.950V
				1Ch = 2.000V
				1Dh = 2.050V
				1Eh = 2.100V 1Fh = 2.150V
				20h = 2.200V
				21h = 2.250V
				22h = 2.300V
				23h = 2.350V
				24h = 2.400V
				25h = 2.450V
				26h = 2.500V
				27h = 2.550V 28h = 2.600V
				29h = 2.650V
				2Ah = 2.700V
				2Bh = 2.750V
				2Ch = 2.800V
				2Dh = 2.850V
				2Eh = 2.900V
				2Fh = 2.950V
				30h = 3.000V 31h = 3.050V
				32h = 3.100V
				33h = 3.150V
				34h = 3.200V
				35h = 3.250V
				36h = 3.300V
				37h = 3.350V
				38h = 3.400V
				39h = 3.400V
				3Ah = 3.400V
				3Bh = 3.400V 3Ch = 3.400V
				3Dh = 3.400V



# 表 6-17. LDO1 VOUT Register Field Descriptions (続き)

Bit	Field	Туре	Reset	Description
				3Eh = 3.400V
				3Fh = 3.400V

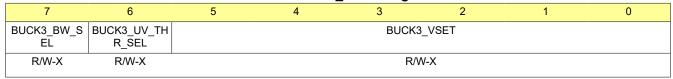
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### 6.8.9 BUCK3\_VOUT Register (Offset = 8h) [Reset = X]

BUCK3\_VOUT is shown in 図 6-26 and described in 表 6-18.

Return to the Summary Table.

### 図 6-26. BUCK3\_VOUT Register



### 表 6-18. BUCK3\_VOUT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	BUCK3_BW_SEL	R/W	X	BUCK3 Bandwidth selection. NOTE: ONLY CHANGE WHILE RAIL IS DISABLED! (Default from NVM memory) 0h = low bandwidth 1h = high bandwidth
6	BUCK3_UV_THR_SEL	R/W	X	UV threshold selection for BUCK3. (Default from NVM memory) 0h = -5% UV detection 1h = -10% UV detection

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# 表 6-18. BUCK3\_VOUT Register Field Descriptions (続き)

P.				gister Field Descriptions (続き)
<b>Bit</b> 5-0	Field BUCK3_VSET	Type R/W	Reset X	Description
				2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.800V 2Fh = 2.900V
				39h = 3.400V 39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V 3Eh = 3.400V



# 表 6-18. BUCK3\_VOUT Register Field Descriptions (続き)

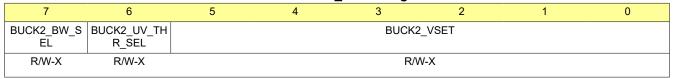
	2 C 101 20 Cite_100 1 Regioter 1 lota 20001.ptions (Apac)						
Bit	Field	Туре	Reset	Description			
				3Fh = 3.400V			

## 6.8.10 BUCK2\_VOUT Register (Offset = 9h) [Reset = X]

BUCK2\_VOUT is shown in 図 6-27 and described in 表 6-19.

Return to the Summary Table.

### 図 6-27. BUCK2\_VOUT Register



### 表 6-19. BUCK2\_VOUT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	BUCK2_BW_SEL	R/W	X	BUCK2 Bandwidth selection. NOTE: ONLY CHANGE WHILE RAIL IS DISABLED! (Default from NVM memory) 0h = low bandwidth 1h = high bandwidth
6	BUCK2_UV_THR_SEL	R/W	X	UV threshold selection for BUCK2. (Default from NVM memory) 0h = -5% UV detection 1h = -10% UV detection



# 表 6-19. BUCK2\_VOUT Register Field Descriptions (続き)

Bit	Field	Type	Reset	Ster Field Descriptions (統立) Description
5-0	BUCK2_VSET	R/W	X	Voltage selection for BUCK2. The output voltage range is from 0.6V
3-0	BOCKZ_VSE1	IX/VV	^	to 3.4V. (Default from NVM memory)
				0h = 0.600V
				1h = 0.625V
				2h = 0.650V
				3h = 0.675V
				4h = 0.700V 5h = 0.725V
				6h = 0.750V
				7h = 0.775V
				8h = 0.800V
				9h = 0.825V
				Ah = 0.850V
				Bh = 0.875V
				Ch = 0.900V   Dh = 0.925V
				Eh = 0.950V
				Fh = 0.975V
				10h = 1.000V
				11h = 1.025V
				12h = 1.050V
				13h = 1.075V
				14h = 1.100V   15h = 1.125V
				16h = 1.150V
				17h = 1.175V
				18h = 1.200V
				19h = 1.225V
				1Ah = 1.250V
				1Bh = 1.275V   1Ch = 1.300V
				1Dh = 1.325V
				1Eh = 1.350V
				1Fh = 1.375V
				20h = 1.400V
				21h = 1.500V
				22h = 1.600V
				23h = 1.700V   24h = 1.800V
				25h = 1.900V
				26h = 2.000V
				27h = 2.100V
				28h = 2.200V
				29h = 2.300V
				2Ah = 2.400V 2Bh = 2.500V
				2Ch = 2.600V
				2Dh = 2.700V
				2Eh = 2.800V
				2Fh = 2.900V
				30h = 3.000V
				31h = 3.100V  32h = 3.200V
				33h = 3.300V
				34h = 3.400V
				35h = 3.400V
				36h = 3.400V
				37h = 3.400V
				38h = 3.400V
				39h = 3.400V   3Ah = 3.400V
				3Ah = 3.400V 3Bh = 3.400V
				3Ch = 3.400V
				3Dh = 3.400V
				3Eh = 3.400V
1	Ţ	1	I	



表 6-19. BUCK2\_VOUT Register Field Descriptions (続き)

Bit	Field	Туре	Reset	Description
				3Fh = 3.400V

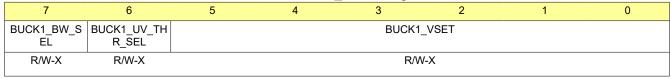
89

### 6.8.11 BUCK1\_VOUT Register (Offset = Ah) [Reset = X]

BUCK1\_VOUT is shown in 図 6-28 and described in 表 6-20.

Return to the Summary Table.

### 図 6-28. BUCK1\_VOUT Register



### 表 6-20. BUCK1\_VOUT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	BUCK1_BW_SEL	R/W	X	BUCK1 Bandwidth selection. NOTE: ONLY CHANGE WHILE RAIL IS DISABLED! (Default from NVM memory) 0h = low bandwidth 1h = high bandwidth
6	BUCK1_UV_THR_SEL	R/W	X	UV threshold selection for BUCK1. (Default from NVM memory) 0h = -5% UV detection 1h = -10% UV detection



# 表 6-20. BUCK1\_VOUT Register Field Descriptions (続き)

Second	Bit	Field	Type	Reset	pister Field Descriptions (統さ) Description
to 3.4V, (Default from NVM memory) 0h = 0.600V 1h = 0.625V 2h = 0.656V 3h = 0.675V 4h = 0.700V 8h = 0.728V 9h = 0.728V 9h = 0.775V 8h = 0.800V 9h = 0.825V Ah = 0.850V Ah = 0.					
Oh = 0.600V  1h = 0.625V  2h = 0.650V  3h = 0.675V  4h = 0.700V  8h = 0.726V  6h = 0.736V  7h = 0.776V  8h = 0.825V  Ah = 1.000V  Ah = 1.000V  Ah = 1.000V  Ah = 1.000V  Ah = 1.125V  Ah = 1.125V  Ah = 1.125V  Ah = 1.250V  Ah = 1.350V  Ah = 2.200V  Ah = 2.000V  Ah = 3.000V  Ah = 3.00V  Ah = 3.400V	3-0	POCKI_VSEI	TV VV	^	
1h = 0.625V 2h = 0.6550V 3h = 0.675V 4h = 0.700V 5h = 0.725V 6h = 0.725V 6h = 0.775V 8h = 0.800V 9h = 0.825V Ah = 0.800V 9h = 0.825V Ah = 0.800V Bh = 0.875V Ch = 0.900V Dh = 0.950V Fh = 0.975V 10h = 1.000V 11h = 1.002V 11h = 1.025V 12h = 1.050V 13h = 1.175V 14h = 1.175V 14h = 1.175V 14h = 1.175V 14h = 1.175V 16h = 1.125V 16h = 1.150V 17h = 1.175V 18h = 1.200V 18h = 1.200V 18h = 1.200V 18h = 1.200V 19h = 1.200V 19h = 1.200V 10h = 1.300V 10h = 1.200V 10h = 2.200V 10h = 3.300V 10h = 3.400V					
2h = 0.650V 3h = 0.675V 4h = 0.700V 6h = 0.725V 6h = 0.725V 6h = 0.750V 7h = 0.776V 8h = 0.800V 9h = 0.825V Ah = 0.850V Bh = 0.850V Ch = 0.900V Dh = 0.925V Eh = 0.950V Fh = 0.975V Ch = 0.900V Th = 1.000V Th = 1.150V Th = 1.175V Th = 1.250V Th = 1					
3h = 0.675V 4h = 0.700V 5h = 0.725V 6h = 0.725V 6h = 0.756V 7h = 0.775V 8h = 0.800V 9h = 0.825V Ah = 0.800V 9h = 0.825V Ah = 0.800V 9h = 0.825V Ah = 0.800V 10h = 0.920V 10h = 0.920V 11h = 1.000V 11h = 1.000V 11h = 1.000V 11h = 1.000V 11h = 1.105V 14h = 1.105V 14h = 1.175V 14h = 1.175V 16h = 1.125V 16h = 1.126V 17h = 1.175V 18h = 1.200V 19h = 1.300V 19h = 1.300V 10h = 1.300V					
Sh = 0.725V 6h = 0.750V 7h = 0.75V 8h = 0.800V 9h = 0.826V Ah = 0.856V Bh = 0.875V Ch = 0.950V Dh = 0.925V Eh = 0.950V Fh = 0.975V 10h = 1.000V 11h = 1.025V 12h = 1.106V 13h = 1.105V 14h = 1.1100V 15h = 1.125V 16h = 1.125V 17h = 1.175V 18h = 1.200V 19h = 1.225V 12h = 1.000V 19h = 1.225V 12h = 1.000V 12h = 1.350V 15h = 1.350V 15h = 1.350V 15h = 1.350V 15h = 1.100V 22h = 1.000V 22h = 1.000V 22h = 1.000V 22h = 1.000V 22h = 2.000V 22h = 2.000V 22h = 2.000V 22h = 2.200V 23h = 3.200V 23h = 3.200V 33h = 3.300V 33h = 3.300V 33h = 3.300V 33h = 3.300V 33h = 3.400V 38h = 3.400V					
(h = 0.750V 7h = 0.775V 8h = 0.800V 9h = 0.825V Ah = 0.857V Ch = 0.950V Eh = 0.950V Fh = 0.950V 10h = 1.025V 12h = 1.055V 13h = 1.075V 14h = 1.105V 15h = 1.125V 16h = 1.155V 16h = 1.155V 17h = 1.175V 18h = 1.225V 18h = 1.225V 18h = 1.225V 18h = 1.225V 18h = 1.255V 18h = 1.255V 18h = 1.355V 18h = 1.355V 18h = 1.355V 18h = 1.355V 18h = 1.355V 18h = 1.350V 18h = 1.3175V 20h = 1.400V 22h = 1.900V 22h = 1.900V 22h = 1.900V 23h = 1.700V 24h = 1.900V 25h = 2.900V 26h = 2.900V 27h = 2.100V 28h = 2.500V 28h = 2.500V 28h = 2.500V 28h = 2.900V 28h = 2.900V 28h = 2.900V 28h = 2.900V 28h = 2.900V 38h = 3.400V 38h = 3.400V					4h = 0.700V
Th = 0.775V 8h = 0.800V 9h = 0.825V Ah = 0.855V Bh = 0.875V Ch = 0.900V Dh = 0.925V Eh = 0.956V Fh = 0.975V 10h = 1.000V 11h = 1.025V 12h = 1.05DV 13h = 1.175V 14h = 1.100V 15h = 1.125V 16h = 1.15DV 17h = 1.175V 18h = 1.220V 18h = 1.225V 14h = 1.100V 19h = 1.225V 14h = 1.100V 19h = 1.225V 14h = 1.150DV 19h = 1.225V 14h = 1.175V 16h = 1.150V 17h = 1.175V 20h = 1.250V 18h = 1.275V 20h = 1.250V 20h = 1.350V 20h = 1.400V 21h = 1.350V 22h = 1.500V 22h = 2.500V 23h = 2.400V 25h = 2.500V 26h = 2.500V 27h = 2.500V 28h = 2.500V 28h = 2.500V 28h = 2.500V 28h = 2.500V 39h = 3.400V 38h = 3.400V					
8h = 0.800V 9h = 0.825V Ah = 0.850V Bh = 0.875V Ch = 0.950V Ch = 0.950V Eh = 0.950V Fh = 0.950V Fh = 0.950V 10h = 1.026V 12h = 1.056V 13h = 1.075V 14h = 1.105V 14h = 1.105V 15h = 1.155V 16h = 1.355V 16h = 1.350V 16h = 1.350V 17h = 1.1560V 22h = 1.800V 22h = 2.900V 22h = 2.900V 28h = 2.200V 28h = 2.200V 28h = 2.200V 28h = 2.200V 28h = 2.500V 28h = 2.900V 38h = 3.300V 31h = 3.100V 31h = 3.300V 31h = 3.300V 33h = 3.300V 33h = 3.300V 33h = 3.300V 33h = 3.400V 33h = 3.400V 33h = 3.400V 38h = 3.400V					
Sh = 0.825V Ah = 0.850V Bh = 0.875V Ch = 0.900V Dh = 0.925V Eh = 0.975V 10h = 1.000V 11h = 1.025V 12h = 1.050V 13h = 1.075V 14h = 1.105V 15h = 1.125V 16h = 1.125V 16h = 1.125V 16h = 1.125V 17h = 1.125					
Ah = 0.850V Bh = 0.875V Ch = 0.900V Dh = 0.925V Eh = 0.950V Fh = 0.975V 10h = 1.000V 11h = 1.025V 12h = 1.050V 13h = 1.075V 14h = 1.10V 15h = 1.125V 16h = 1.120V 17h = 1.120V 18h = 1.200V 19h = 1.225V 14h = 1.200V 19h = 1.225V 14h = 1.200V 19h = 1.225V 14h = 1.300V 16h = 1.325V 16h = 1.350V 16h = 1.355V 16h = 1.350V 16h = 1.355V 16h = 1.350V 16h = 1.350V 16h = 1.350V 16h = 1.350V 20h = 1.400V 21h = 1.600V 22h = 1.600V 22h = 1.600V 22h = 1.600V 22h = 1.800V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 26h = 2.400V 26h = 2.400V 26h = 2.500V 26h = 3.400V 36h = 3.400V					
Bh = 0.875V Ch = 0.900V Dh = 0.925V Eh = 0.95f0V Fh = 0.975V 10h = 1.000V 11h = 1.025V 12h = 1.050V 13h = 1.075V 14h = 1.100V 15h = 1.125V 16h = 1.150V 17h = 1.175V 18h = 1.200V 19h = 1.225V 18h = 1.225V 18h = 1.255V 18h = 1.275V 18h = 1.500V 18h = 2.200V 18h = 2.500V 18h = 3.300V 18h = 3.400V					
Ch = 0.900V Dh = 0.926V Eh = 0.950V Fh = 0.976V 10h = 1.050V 11h = 1.025V 12h = 1.050V 13h = 1.1075V 14h = 1.1075V 14h = 1.120V 16h = 1.150V 17h = 1.175V 18h = 1.225V 18h = 1.226V 18h = 1.250V 18h = 1.350V 18h = 1.355V 18h = 1.350V 18h = 1.350V 20h = 1.400V 21h = 1.600V 22h = 1.800V 22h = 2.000V 23h = 2.000V 23h = 2.000V 23h = 2.000V 24h = 2.500V 26h = 3.400V 36h = 3.400V 36h = 3.400V 38h = 3.400V					
Dh = 0.955V Eh = 0.955V Fh = 0.975V 10h = 1.000V 11h = 1.025V 12h = 1.056V 13h = 1.075V 13h = 1.175V 14h = 1.100V 15h = 1.125V 16h = 1.150V 17h = 1.175V 18h = 1.250V 18h = 1.350V 17h = 1.375V 20h = 1.400V 21h = 1.500V 22h = 2.500V 23h = 3.500V 23h = 3.500V 33h = 3.500V					
Eh = 0.950V Fh = 0.975V 10h = 1.000V 11h = 1.025V 12h = 1.050V 13h = 1.075V 14h = 1.100V 15h = 1.155V 16h = 1.155V 17h = 1.155V 17h = 1.175V 18h = 1.250V 18h = 1.350V 19h = 1.325V 12h = 1.350V 12h = 1.350V 12h = 1.375V 20h = 1.400V 21h = 1.375V 20h = 1.600V 22h = 1.600V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.200V 28h = 2.200V 28h = 2.200V 28h = 2.200V 28h = 2.500V 26h = 2.600V 26h = 2.600V 26h = 2.600V 27h = 2.500V 28h = 3.000V 38h = 3.000V 31h = 3.100V 32h = 3.000V 33h = 3.000V 33h = 3.000V 33h = 3.400V 36h = 3.400V 36h = 3.400V 36h = 3.400V 38h = 3.400V					
10h = 1.000V     11h = 1.025V     12h = 1.056V     13h = 1.075V     14h = 1.100V     15h = 1.128V     16h = 1.156V     17h = 1.175V     18h = 1.200V     19h = 1.225V     14h = 1.250V     18h = 1.276V     12h = 1.326V     12h = 1.226V     12h					
11h = 1.025V 12h = 1.050V 13h = 1.075V 14h = 1.100V 15h = 1.125V 16h = 1.150V 17h = 1.175V 18h = 1.200V 19h = 1.225V 14h = 1.250V 18h = 1.250V 18h = 1.250V 18h = 1.25V 16h = 3.30V 17h = 1.355V 16h = 1.350V 17h = 1.375V 20h = 1.400V 21h = 1.500V 22h = 1.400V 22h = 1.500V 22h = 1.900V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.200V 27h = 2.100V 28h = 2.200V 28h = 2.200V 29h = 2.300V 22h = 2.800V 22h = 2.800V 22h = 2.800V 22h = 2.800V 23h = 3.400V 33h = 3.300V 33h = 3.300V 33h = 3.300V 33h = 3.400V 38h = 3.400V					Fh = 0.975V
12h = 1.050V 13h = 1.075V 14h = 1.120V 15h = 1.128V 16h = 1.150V 17h = 1.176V 18h = 1.225V 18h = 1.225V 18h = 1.225V 18h = 1.275V 10h = 1.325V 16h = 1.350V 17h = 1.175V 16h = 1.350V 17h = 1.176V 17h = 1.176V 18h = 1.275V 18h = 1.275V 18h = 1.275V 18h = 1.275V 18h = 1.350V 18h = 1.350V 18h = 1.350V 18h = 1.350V 18h = 1.1700V 28h = 2.200V 28h = 2.300V 28h = 2.400V 28h = 2.500V 28h = 2.500V 28h = 2.300V 28h = 2.300V 38h = 3.400V					
13h = 1.076V 14h = 1.100V 15h = 1.125V 16h = 1.150V 17h = 1.175V 18h = 1.200V 19h = 1.225V 1Ah = 1.256V 1Ah = 1.256V 1Ah = 1.256V 1Bh = 1.275V 1Ch = 1.300V 1Dh = 1.325V 1Eh = 1.350V 1Fh = 1.375V 20h = 1.400V 21h = 1.500V 22h = 1.600V 23h = 1.700V 24h = 1.800V 24h = 1.800V 25h = 1.900V 26h = 2.200V 27h = 2.100V 28h = 2.200V 28h = 2.200V 28h = 2.300V 2Ah = 2.400V 28h = 2.500V 28h = 3.400V 38h = 3.400V					
14h = 1.100V 15h = 1.125V 16h = 1.150V 17h = 1.175V 18h = 1.200V 19h = 1.225V 14h = 1.250V 18h = 1.275V 16h = 1.350V 18h = 1.275V 16h = 1.350V 17h = 1.350V 18h = 1.350V 20h = 1.400V 21h = 1.500V 22h = 1.600V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 29h = 2.300V 20h = 2.700V 28h = 2.500V 20h = 2.700V 21h = 2.500V 21h = 3.500V 31h = 3.400V					
15h = 1.125V 16h = 1.150V 17h = 1.175V 18h = 1.200V 19h = 1.225V 1Ah = 1.250V 18h = 1.250V 18h = 1.275V 1Ch = 1.300V 1Bh = 1.325V 1Ch = 1.300V 1Dh = 1.325V 1Eh = 1.375V 20h = 1.400V 21h = 1.500V 22h = 1.600V 22h = 1.600V 22h = 1.600V 22h = 1.000V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 29h = 2.300V 20h = 2.400V 20h = 2.400V 20h = 2.400V 20h = 2.800V 20h = 3.800V 30h = 3.800V 33h = 3.800V 33h = 3.400V 38h = 3.400V					
16h = 1.150V 17h = 1.175V 18h = 1.200V 19h = 1.225V 14h = 1.250V 18h = 1.275V 1Ch = 1.300V 1Dh = 1.325V 1Eh = 1.350V 1Fh = 1.35TV 20h = 1.400V 21h = 1.500V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 24h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 22h = 2.600V 20h = 2.600V 20h = 2.600V 20h = 2.500V 20h = 3.500V 30h = 3.500V 30h = 3.500V 33h = 3.500V 33h = 3.500V 33h = 3.500V 35h = 3.400V 35h = 3.400V 36h = 3.400V					
17h = 1.175V 18h = 1.200V 19h = 1.225V 1Ah = 1.250V 18h = 1.275V 1Ch = 1.300V 1Dh = 1.325V 1Eh = 1.355V 1Eh = 1.355V 2Dh = 1.400V 21h = 1.500V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 29h = 2.300V 29h = 2.300V 20h = 2.500V 20h = 2.500V 20h = 2.500V 20h = 2.500V 20h = 2.700V 20h = 2.700V 20h = 2.700V 20h = 2.300V 20h = 3.300V 30h = 3.000V 31h = 3.100V 32h = 3.400V 33h = 3.300V 33h = 3.400V					
18h = 1.200V 19h = 1.225V 1Ah = 1.250V 18h = 1.275V 1Ch = 1.300V 1Dh = 1.325V 1Eh = 1.375V 2Dh = 1.400V 21h = 1.500V 22h = 1.600V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 2Ah = 2.400V 28h = 2.200V 29h = 2.500V 2Ch = 2.600V 2Ch = 2.600V 2Ch = 2.600V 2Ch = 2.500V 2Ch =					
19h = 1.225V 1Ah = 1.25V 1Bh = 1.275V 1Ch = 1.300V 1Dh = 1.325V 1Eh = 1.350V 1Fh = 1.375V 20h = 1.400V 21h = 1.500V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 29h = 2.300V 24h = 2.400V 28h = 2.200V 29h = 2.700V 29h = 2.700V 26h = 2.900V 37h = 3.400V 36h = 3.200V 37h = 3.400V 33h = 3.400V					
1Ah = 1.250V 1Bh = 1.275V 1Ch = 1.300V 1Dh = 1.325V 1Eh = 1.355V 1Fh = 1.375V 20h = 1.400V 21h = 1.500V 22h = 1.600V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 2Ah = 2.400V 28h = 2.200V 29h = 2.300V 2Ah = 2.400V 29h = 2.500V 20h = 2.500V 20h = 2.500V 20h = 2.700V 21h = 2.700V 21h = 2.700V 21h = 2.300V 22h = 3.300V 31h = 3.100V 31h = 3.100V 33h = 3.300V 33h = 3.400V					
18h = 1.275V 1Ch = 1.300V 1Dh = 1.325V 1Eh = 1.350V 1Fh = 1.375V 20h = 1.400V 21h = 1.500V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 29h = 2.300V 29h = 2.300V 20h = 2.700V 20h = 3.300V 30h = 3.00V 31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V					
1Ch = 1,300V 1Dh = 1,325V 1Eh = 1,350V 1Fh = 1,375V 20h = 1,400V 21h = 1,500V 22h = 1,600V 23h = 1,700V 24h = 1,800V 25h = 2,000V 26h = 2,000V 26h = 2,200V 26h = 2,200V 28h = 2,200V 28h = 2,200V 28h = 2,500V 26h = 2,500V 26h = 2,600V 26h = 2,600V 26h = 2,700V 26h = 2,600V 27h = 2,900V 30h = 3,000V 31h = 3,100V 33h = 3,400V 35h = 3,400V 36h = 3,400V 36h = 3,400V 36h = 3,400V 37h = 3,400V 38h = 3,400V					
1Dh = 1.325V 1Eh = 1.350V 1Fh = 1.375V 20h = 1.400V 21h = 1.500V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 29h = 2.300V 20h = 2.400V 20h = 2.500V 20h = 2.600V 20h = 2.600V 20h = 2.700V 20h = 2.800V 20h = 2.800V 20h = 2.800V 30h = 3.000V 31h = 3.100V 33h = 3.00V 33h = 3.400V					
1Fh = 1.375V 20h = 1.400V 21h = 1.500V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 2Ah = 2.400V 2Bh = 2.500V 2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.400V 36h = 3.400V 36h = 3.400V 38h = 3.400V					1Dh = 1.325V
20h = 1.400V 21h = 1.500V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 20h = 2.300V 20h = 2.500V 20h = 2.500V 20h = 2.500V 20h = 2.500V 20h = 2.700V 21h = 2.800V 21h = 2.800V 22h = 2.800V 21h = 2.800V 22h = 2.800V 25h = 2.800V 27h = 2.900V 30h = 3.000V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V					
21h = 1.500V 22h = 1.600V 23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 24h = 2.400V 28h = 2.500V 20h = 2.500V 20h = 2.700V 20h = 2.700V 20h = 2.700V 21h = 2.800V 20h = 2.800V 20h = 2.300V 30h = 3.000V 31h = 3.100V 33h = 3.300V 33h = 3.300V 34h = 3.400V 35h = 3.400V 36h = 3.400V					
22h = 1.600V 23h = 1.700V 24h = 1.800V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 22h = 2.400V 28h = 2.500V 20h = 2.700V 22h = 2.600V 20h = 2.700V 22h = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 36h = 3.400V 36h = 3.400V 38h = 3.400V					
23h = 1.700V 24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 2Ah = 2.400V 2Bh = 2.500V 2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.800V 2Fh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 38h = 3.400V 39h = 3.400V 39h = 3.400V 36h = 3.400V 36h = 3.400V					
24h = 1.800V 25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 29h = 2.500V 2Ch = 2.600V 2Ch = 2.600V 2Ch = 2.600V 2Eh = 2.800V 30h = 3.100V 30h = 3.100V 31h = 3.100V 33h = 3.200V 33h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V					
25h = 1.900V 26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 2Ah = 2.400V 2Bh = 2.500V 2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.800V 2Fh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V					
26h = 2.000V 27h = 2.100V 28h = 2.200V 29h = 2.300V 2Ah = 2.400V 2Bh = 2.500V 2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.800V 2Fh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.400V 34h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V					
27h = 2.100V 28h = 2.200V 29h = 2.300V 2Ah = 2.400V 2Bh = 2.500V 2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.800V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.300V 33h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 39h = 3.400V 30h = 3.400V					
28h = 2.200V 29h = 2.300V 2Ah = 2.400V 2Bh = 2.500V 2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.800V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 36h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 38h = 3.400V 39h = 3.400V 38h = 3.400V					
29h = 2.300V 2Ah = 2.400V 2Bh = 2.500V 2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.800V 2Fh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 36h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 30h = 3.400V 30h = 3.400V					
2Bh = 2.500V 2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.800V 2Fh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 38h = 3.400V 38h = 3.400V 39h = 3.400V 30h = 3.400V 30h = 3.400V 30h = 3.400V					29h = 2.300V
2Ch = 2.600V 2Dh = 2.700V 2Eh = 2.800V 2Fh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 38h = 3.400V 38h = 3.400V 39h = 3.400V 30h = 3.400V 30h = 3.400V 30h = 3.400V					
2Dh = 2.700V 2Eh = 2.800V 2Fh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 38h = 3.400V 39h = 3.400V 30h = 3.400V 30h = 3.400V 30h = 3.400V					
2Eh = 2.800V 2Fh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 39h = 3.400V 30h = 3.400V 30h = 3.400V 30h = 3.400V					
2Fh = 2.900V 30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.400V 34h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 39h = 3.400V 3h = 3.400V 3h = 3.400V 3h = 3.400V 3h = 3.400V 3h = 3.400V					
30h = 3.000V 31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 39h = 3.400V 31h = 3.400V 31h = 3.400V 31h = 3.400V 31h = 3.400V 31h = 3.400V					
31h = 3.100V 32h = 3.200V 33h = 3.300V 34h = 3.400V 35h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
32h = 3.200V 33h = 3.300V 34h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
33h = 3.300V 34h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
34h = 3.400V 35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
35h = 3.400V 36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
36h = 3.400V 37h = 3.400V 38h = 3.400V 39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
37h = 3.400V 38h = 3.400V 39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
39h = 3.400V 3Ah = 3.400V 3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
3Bh = 3.400V 3Ch = 3.400V 3Dh = 3.400V					
3Ch = 3.400V 3Dh = 3.400V					
3Dh = 3.400V					
3Eh = 3.400V					
					3En = 3.400V

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# 表 6-20. BUCK1\_VOUT Register Field Descriptions (続き)

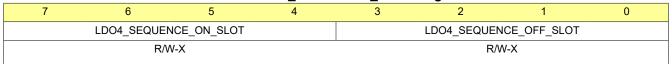
Bit	Field	Туре	Reset	Description
				3Fh = 3.400V

## 6.8.12 LDO4\_SEQUENCE\_SLOT Register (Offset = Bh) [Reset = X]

LDO4\_SEQUENCE\_SLOT is shown in 図 6-29 and described in 表 6-21.

Return to the Summary Table.

### 図 6-29. LDO4\_SEQUENCE\_SLOT Register



### 表 6-21. LDO4\_SEQUENCE\_SLOT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	LDO4_SEQUENCE_ON_ SLOT	R/W	X	LDO4 slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	LDO4_SEQUENCE_OFF_ SLOT	R/W	X	LDO4 slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

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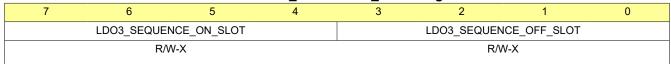


### 6.8.13 LDO3\_SEQUENCE\_SLOT Register (Offset = Ch) [Reset = X]

LDO3\_SEQUENCE\_SLOT is shown in 図 6-30 and described in 表 6-22.

Return to the Summary Table.

### 図 6-30. LDO3\_SEQUENCE\_SLOT Register



### 表 6-22. LDO3\_SEQUENCE\_SLOT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	LDO3_SEQUENCE_ON_ SLOT	R/W	X	LDO3 slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	LDO3_SEQUENCE_OFF_ SLOT	R/W	X	LDO3 slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

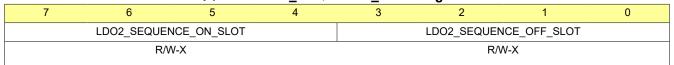
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### 6.8.14 LDO2\_SEQUENCE\_SLOT Register (Offset = Dh) [Reset = X]

LDO2\_SEQUENCE\_SLOT is shown in 🗵 6-31 and described in 表 6-23.

Return to the Summary Table.

### 図 6-31. LDO2\_SEQUENCE\_SLOT Register



### 表 6-23. LDO2\_SEQUENCE\_SLOT Register Field Descriptions

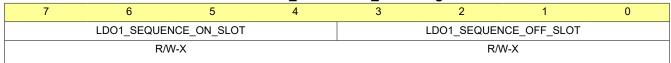
Bit	Field	Туре	Reset	Description
7-4	LDO2_SEQUENCE_ON_ SLOT	R/W	X	LDO2 slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	LDO2_SEQUENCE_OFF_ SLOT	R/W	X	LDO2 slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

## 6.8.15 LDO1\_SEQUENCE\_SLOT Register (Offset = Eh) [Reset = X]

LDO1\_SEQUENCE\_SLOT is shown in 🗵 6-32 and described in 表 6-24.

Return to the Summary Table.

### 図 6-32. LDO1\_SEQUENCE\_SLOT Register



### 表 6-24. LDO1\_SEQUENCE\_SLOT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	LDO1_SEQUENCE_ON_ SLOT	R/W	X	LDO1 slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	LDO1_SEQUENCE_OFF_ SLOT	R/W	X	LDO1 slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

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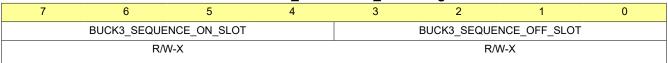


### 6.8.16 BUCK3\_SEQUENCE\_SLOT Register (Offset = Fh) [Reset = X]

BUCK3\_SEQUENCE\_SLOT is shown in 図 6-33 and described in 表 6-25.

Return to the Summary Table.

### 図 6-33. BUCK3\_SEQUENCE\_SLOT Register



#### 表 6-25. BUCK3\_SEQUENCE\_SLOT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	BUCK3_SEQUENCE_ON _SLOT	R/W	X	BUCK3 slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	BUCK3_SEQUENCE_OF F_SLOT	R/W	X	BUCK3 slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

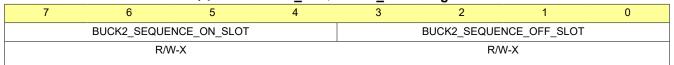


### 6.8.17 BUCK2\_SEQUENCE\_SLOT Register (Offset = 10h) [Reset = X]

BUCK2\_SEQUENCE\_SLOT is shown in 図 6-34 and described in 表 6-26.

Return to the Summary Table.

### 図 6-34. BUCK2\_SEQUENCE\_SLOT Register



### 表 6-26. BUCK2\_SEQUENCE\_SLOT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	BUCK2_SEQUENCE_ON _SLOT	R/W	X	BUCK2 Slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	BUCK2_SEQUENCE_OF F_SLOT	R/W	X	BUCK2 slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

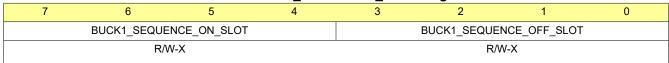
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## 6.8.18 BUCK1\_SEQUENCE\_SLOT Register (Offset = 11h) [Reset = X]

BUCK1\_SEQUENCE\_SLOT is shown in 図 6-35 and described in 表 6-27.

Return to the Summary Table.

### 図 6-35. BUCK1\_SEQUENCE\_SLOT Register



#### 表 6-27. BUCK1\_SEQUENCE\_SLOT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	BUCK1_SEQUENCE_ON _SLOT	R/W	X	BUCK1 Slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	BUCK1_SEQUENCE_OF F_SLOT	R/W	X	BUCK1 slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

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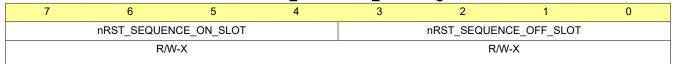


### 6.8.19 nRST\_SEQUENCE\_SLOT Register (Offset = 12h) [Reset = X]

nRST\_SEQUENCE\_SLOT is shown in  $oxed{id}$  6-36 and described in 表 6-28.

Return to the Summary Table.

#### 図 6-36. nRST\_SEQUENCE\_SLOT Register



### 表 6-28. nRST\_SEQUENCE\_SLOT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	nRST_SEQUENCE_ON_ SLOT	R/W	X	nRST slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	nRST_SEQUENCE_OFF_ SLOT	R/W	X	nRST slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

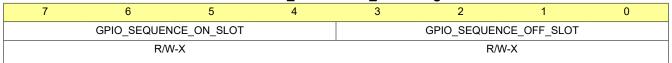
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## 6.8.20 GPIO\_SEQUENCE\_SLOT Register (Offset = 13h) [Reset = X]

GPIO\_SEQUENCE\_SLOT is shown in 🗵 6-37 and described in 表 6-29.

Return to the Summary Table.

### 図 6-37. GPIO\_SEQUENCE\_SLOT Register



### 表 6-29. GPIO\_SEQUENCE\_SLOT Register Field Descriptions

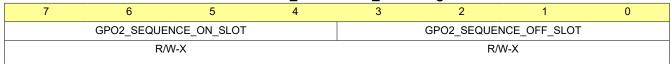
Bit	Field	Туре	Reset	Description
7-4	GPIO_SEQUENCE_ON_ SLOT	R/W	X	GPIO slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	GPIO_SEQUENCE_OFF_ SLOT	R/W	X	GPIO slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

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# 6.8.21 GPO2\_SEQUENCE\_SLOT Register (Offset = 14h) [Reset = X]

Return to the Summary Table.

# 図 6-38. GPO2\_SEQUENCE\_SLOT Register



### 表 6-30. GPO2\_SEQUENCE\_SLOT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	GPO2_SEQUENCE_ON_ SLOT	R/W	X	GPO2 slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	GPO2_SEQUENCE_OFF _SLOT	R/W	X	GPO2 slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

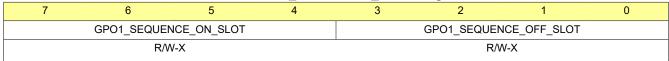
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## 6.8.22 GPO1\_SEQUENCE\_SLOT Register (Offset = 15h) [Reset = X]

GPO1\_SEQUENCE\_SLOT is shown in 図 6-39 and described in 表 6-31.

Return to the Summary Table.

### 図 6-39. GPO1\_SEQUENCE\_SLOT Register



#### 表 6-31. GPO1\_SEQUENCE\_SLOT Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	GPO1_SEQUENCE_ON_ SLOT	R/W	X	GPO1 slot number for power-up (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15
3-0	GPO1_SEQUENCE_OFF _SLOT	R/W	X	GPO1 slot number for power-down (Default from NVM memory) 0h = slot 0 1h = slot 1 2h = slot 2 3h = slot 3 4h = slot 4 5h = slot 5 6h = slot 6 7h = slot 7 8h = slot 8 9h = slot 9 Ah = slot 10 Bh = slot 11 Ch = slot 12 Dh = slot 13 Eh = slot 14 Fh = slot 15

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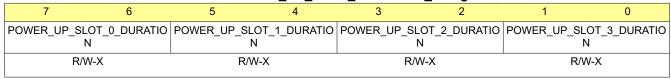


#### 6.8.23 POWER\_UP\_SLOT\_DURATION\_1 Register (Offset = 16h) [Reset = X]

POWER\_UP\_SLOT\_DURATION\_1 is shown in 図 6-40 and described in 表 6-32.

Return to the Summary Table.

#### 図 6-40. POWER\_UP\_SLOT\_DURATION\_1 Register



#### 表 6-32. POWER\_UP\_SLOT\_DURATION\_1 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-6	POWER_UP_SLOT_0_D URATION	R/W	X	Duration of slot 0 during the power-up and standby-to-active sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
5-4	POWER_UP_SLOT_1_D URATION	R/W	x	Duration of slot 1 during the power-up and standby-to-active sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
3-2	POWER_UP_SLOT_2_D URATION	R/W	Х	Duration of slot 2 during the power-up and standby-to-active sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
1-0	POWER_UP_SLOT_3_D URATION	R/W	х	Duration of slot 3 during the power-up and standby-to-active sequences. (Default from NVM memory)  0h = 0ms  1h = 1.5ms  2h = 3ms  3h = 10ms

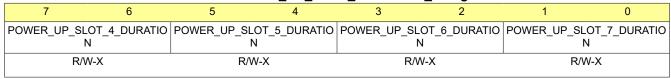
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### 6.8.24 POWER\_UP\_SLOT\_DURATION\_2 Register (Offset = 17h) [Reset = X]

POWER\_UP\_SLOT\_DURATION\_2 is shown in 図 6-41 and described in 表 6-33.

Return to the Summary Table.

#### 図 6-41. POWER\_UP\_SLOT\_DURATION\_2 Register



## 表 6-33. POWER\_UP\_SLOT\_DURATION\_2 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	POWER_UP_SLOT_4_D URATION	R/W	X	Duration of slot 4 during the power-up and standby-to-active sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
5-4	POWER_UP_SLOT_5_D URATION	R/W	X	Duration of slot 5 during the power-up and standby-to-active sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
3-2	POWER_UP_SLOT_6_D URATION	R/W	X	Duration of slot 6 during the power-up and standby-to-active sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
1-0	POWER_UP_SLOT_7_D URATION	R/W	X	Duration of slot 7 during the power-up and standby-to-active sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms

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#### 6.8.25 POWER\_UP\_SLOT\_DURATION\_3 Register (Offset = 18h) [Reset = X]

POWER\_UP\_SLOT\_DURATION\_3 is shown in 図 6-42 and described in 表 6-34.

Return to the Summary Table.

#### 図 6-42. POWER\_UP\_SLOT\_DURATION\_3 Register



#### 表 6-34. POWER\_UP\_SLOT\_DURATION\_3 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	POWER_UP_SLOT_8_D URATION	R/W	X	Duration of slot 8 during the power-up and standby-to-active sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
5-4	POWER_UP_SLOT_9_D URATION	R/W	X	Duration of slot 9 during the power-up and standby-to-active sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
3-2	POWER_UP_SLOT_10_D URATION	R/W	X	Duration of slot 10 during the power-up and standby-to-active sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
1-0	POWER_UP_SLOT_11_D URATION	R/W	X	Duration of slot 11 during the power-up and standby-to-active sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms

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### 6.8.26 POWER\_UP\_SLOT\_DURATION\_4 Register (Offset = 19h) [Reset = X]

POWER\_UP\_SLOT\_DURATION\_4 is shown in 図 6-43 and described in 表 6-35.

Return to the Summary Table.

### 図 6-43. POWER\_UP\_SLOT\_DURATION\_4 Register

7	6	5	4	3	2	1	0
POWER_UP_SLO	T_12_DURATI		SLOT_13_DURATI ON	POWER_UP_	SLOT_14_DURATI ON	POWER_UP_SLO	T_15_DURATI
R/W-	Х	R/W-X		F	R/W-X	R/W-X	

### 表 6-35. POWER\_UP\_SLOT\_DURATION\_4 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	POWER_UP_SLOT_12_D URATION	R/W	X	Duration of slot 12 during the power-up and standby-to-active sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
5-4	POWER_UP_SLOT_13_D URATION	R/W	X	Duration of slot 13 during the power-up and standby-to-active sequences. (Default from NVM memory)  0h = 0ms  1h = 1.5ms  2h = 3ms  3h = 10ms
3-2	POWER_UP_SLOT_14_D URATION	R/W	X	Duration of slot 14 during the power-up and standby-to-active sequences. (Default from NVM memory)  0h = 0ms  1h = 1.5ms  2h = 3ms  3h = 10ms
1-0	POWER_UP_SLOT_15_D URATION	R/W	X	Duration of slot 15 during the power-up and standby-to-active sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms

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# 6.8.27 POWER\_DOWN\_SLOT\_DURATION\_1 Register (Offset = 1Ah) [Reset = X]

POWER\_DOWN\_SLOT\_DURATION\_1 is shown in 図 6-44 and described in 表 6-36.

Return to the Summary Table.

### 図 6-44. POWER\_DOWN\_SLOT\_DURATION\_1 Register

7	6	5	4	3	2	1	0	
POWER_DOWN_S		POWER_DOWN ATI		POWER_D	OOWN_SLOT_2_DUR ATION	_	N_SLOT_3_DUR ON	
R/W-X		R/V	R/W-X		R/W-X		R/W-X	

### 表 6-36. POWER\_DOWN\_SLOT\_DURATION\_1 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	POWER_DOWN_SLOT_0 _DURATION	R/W	X	Duration of slot 0 during the power-down and active-to-standby sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
5-4	POWER_DOWN_SLOT_1 _DURATION	R/W	X	Duration of slot 1 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms  1h = 1.5ms  2h = 3ms  3h = 10ms
3-2	POWER_DOWN_SLOT_2 _DURATION	R/W	X	Duration of slot 2 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms  1h = 1.5ms  2h = 3ms  3h = 10ms
1-0	POWER_DOWN_SLOT_3 _DURATION	R/W	x	Duration of slot 3 during the power-down and active-to-standby sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms

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## 6.8.28 POWER\_DOWN\_SLOT\_DURATION\_2 Register (Offset = 1Bh) [Reset = X]

POWER\_DOWN\_SLOT\_DURATION\_2 is shown in 図 6-45 and described in 表 6-37.

Return to the Summary Table.

## 図 6-45. POWER\_DOWN\_SLOT\_DURATION\_2 Register

7	6	5	4	3	2	1	0
POWER_DOWN_ ATIO		_	N_SLOT_5_DUR TION	_	N_SLOT_6_DUR TON	POWER_DOWN ATIO	
R/W-	-X	R	W-X	R/	W-X	R/W	/-X

## 表 6-37. POWER\_DOWN\_SLOT\_DURATION\_2 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	POWER_DOWN_SLOT_4 _DURATION	R/W	X	Duration of slot 4 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms  1h = 1.5ms  2h = 3ms  3h = 10ms
5-4	POWER_DOWN_SLOT_5 _DURATION	R/W	X	Duration of slot 5 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
3-2	POWER_DOWN_SLOT_6 _DURATION	R/W	X	Duration of slot 6 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
1-0	POWER_DOWN_SLOT_7 _DURATION	R/W	X	Duration of slot 7 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms  1h = 1.5ms  2h = 3ms  3h = 10ms

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## 6.8.29 POWER\_DOWN\_SLOT\_DURATION\_3 Register (Offset = 1Ch) [Reset = X]

POWER\_DOWN\_SLOT\_DURATION\_3 is shown in 図 6-46 and described in 表 6-38.

Return to the Summary Table.

#### 図 6-46. POWER\_DOWN\_SLOT\_DURATION\_3 Register

7	6	5	4	3	2	1	0
POWER_DOWN_ ATIO		_	/N_SLOT_9_DUR TION	POWER_	DOWN_SLOT_10_DU RATION	POWER_DOWN_ ATIO	
R/W-	-X	R	/W-X		R/W-X	R/W	/-X

## 表 6-38. POWER\_DOWN\_SLOT\_DURATION\_3 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	POWER_DOWN_SLOT_8 _DURATION	R/W	X	Duration of slot 8 during the power-down and active-to-standby sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
5-4	POWER_DOWN_SLOT_9 _DURATION	R/W	x	Duration of slot 9 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms  1h = 1.5ms  2h = 3ms  3h = 10ms
3-2	POWER_DOWN_SLOT_1 0_DURATION	R/W	x	Duration of slot 10 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
1-0	POWER_DOWN_SLOT_1 1_DURATION	R/W	X	Duration of slot 11 during the power-down and active-to-standby sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms

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## 6.8.30 POWER\_DOWN\_SLOT\_DURATION\_4 Register (Offset = 1Dh) [Reset = X]

POWER\_DOWN\_SLOT\_DURATION\_4 is shown in 図 6-47 and described in 表 6-39.

Return to the Summary Table.

## 図 6-47. POWER\_DOWN\_SLOT\_DURATION\_4 Register

7	6	5	4	3	2	1	0
POWER_DOWN_ RATIO		POWER_DOWN RAT			WN_SLOT_14_DU RATION	POWER_DOWN RATI	_
R/W	-X	R/V	V-X	ı	R/W-X	R/W	/-X

## 表 6-39. POWER\_DOWN\_SLOT\_DURATION\_4 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	POWER_DOWN_SLOT_1 2_DURATION	R/W	X	Duration of slot 12 during the power-down and active-to-standby sequences. (Default from NVM memory) 0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
5-4	POWER_DOWN_SLOT_1 3_DURATION	R/W	X	Duration of slot 13 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
3-2	POWER_DOWN_SLOT_1 4_DURATION	R/W	X	Duration of slot 14 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms 1h = 1.5ms 2h = 3ms 3h = 10ms
1-0	POWER_DOWN_SLOT_1 5_DURATION	R/W	X	Duration of slot 15 during the power-down and active-to-standby sequences. (Default from NVM memory)  0h = 0ms  1h = 1.5ms  2h = 3ms  3h = 10ms

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## 6.8.31 GENERAL\_CONFIG Register (Offset = 1Eh) [Reset = X]

GENERAL\_CONFIG is shown in 図 6-48 and described in 表 6-40.

Return to the Summary Table.

## 図 6-48. GENERAL\_CONFIG Register

7	6	5	4	3	2	1	0
BYPASS_RAIL S_DISCHARGE D_CHECK	LDO4_UV_THR	LDO3_UV_THR	LDO2_UV_THR	LDO1_UV_THR	GPIO_EN	GPO2_EN	GPO1_EN
R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X

#### 表 6-40. GENERAL\_CONFIG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	BYPASS_RAILS_DISCHA RGED_CHECK	ACTIVE state, and each slot during a the check for RV(F (Default from NVM 0h = Discharged c		Bypass the all-rails discharged check to commence a transition to ACTIVE state, and the rails-in-slot discharged check executed in each slot during a power-down to INITIALIZE state. Does not bypass the check for RV(Pre-biased) condition prior to enabling a regulator. (Default from NVM memory)  0h = Discharged checks enforced 1h = Discharged checks bypassed
6	LDO4_UV_THR	LDO. (D 0h = -5% 1h = -10		UV threshold selection bit for LDO4. Only applicable if configured as LDO. (Default from NVM memory) 0h = -5% UV detection 1h = -10% UV detection
5	LDO3_UV_THR	R/W	Х	UV threshold selection bit for LDO3. Only applicable if configured as LDO. (Default from NVM memory) 0h = -5% UV detection 1h = -10% UV detection
4	LDO2_UV_THR	R/W	Х	UV threshold selection bit for LDO2. Only applicable if configured as LDO. (Default from NVM memory) 0h = -5% UV detection 1h = -10% UV detection
3	LDO1_UV_THR	R/W	Х	UV threshold selection bit for LDO1. Only applicable if configured as LDO. (Default from NVM memory) 0h = -5% UV detection 1h = -10% UV detection
2	GPIO_EN	R/W	Х	Both an enable and state control of GPIO. This bit enables the GPIO function and also controls the state of the GPIO pin. (Default from NVM memory)  0h = The GPIO function is disabled. The output state is 'low'.  1h = The GPIO function is enabled. The output state is 'high'.
1	GPO2_EN	R/W	Х	Both an enable and state control of GPO2. This bit enables the GPO2 function and also controls the state of the GPO2 pin. (Default from NVM memory)  0h = GPO2 disabled. The output state is low.  1h = GPO2 enabled. The output state is Hi-Z.
0	GPO1_EN	R/W	Х	Both an enable and state control of GPO1. This bit enables the GPO1 function and also controls the state of the GPO1 pin. (Default from NVM memory)  0h = GPO1 disabled. The output state is low.  1h = GPO1 enabled. The output state is Hi-Z.

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## 6.8.32 MFP\_1\_CONFIG Register (Offset = 1Fh) [Reset = X]

MFP\_1\_CONFIG is shown in 図 6-49 and described in 表 6-41.

Return to the Summary Table.

## 図 6-49. MFP\_1\_CONFIG Register

7	6	5	4	3	2	1	0
MODE_I2C_CT RL	VSEL_SD_I2C_ CTRL	MODE_RESET _POLARITY	MODE_STBY_ POLARITY	MULTI_DEVICE _ENABLE	VSEL_RAIL	VSEL_SD_POL ARITY	VSEL_DDR_SD
R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X

## 表 6-41. MFP\_1\_CONFIG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	MODE_I2C_CTRL	R/W	Х	MODE control using I2C. Consolidated with MODE control via MODE/RESET and/or MODE/STBY pins. Refer to table in the data sheet. (Default from NVM memory) 0h = Auto PFM 1h = Forced PWM
6	VSEL_SD_I2C_CTRL	R/W	X	VSEL_SD control using I2C. Applicable only if VSEL_SD/ VSEL_DDR pin is configured as "VSEL_DDR". (Default from NVM memory) 0h = 1.8V 1h = LDOx_VOUT register setting
5	MODE_RESET_POLARIT Y	R/W	X	MODE_RESET Pin Polarity configuration. Note: Ok to change during operation, but consider immediate reaction: MODE-change or RESET-entry! (Default from NVM memory)  0h = [if configured as MODE] LOW - auto-PFM / HIGH - forced PWM. [if configured as RESET] LOW - reset / HIGH - normal operation.  1h = [if configured as MODE] HIGH - auto-PFM / LOW - forced PWM. [if configured as RESET] HIGH - reset / LOW - normal operation.
4	MODE_STBY_POLARITY	R/W	X	MODE_STBY Pin Polarity configuration. Note: Ok to change during operation, but consider immediate reaction: MODE-change or STATE-change! (Default from NVM memory)  0h = [if configured as MODE] LOW - auto-PFM / HIGH - forced PWM. [if configured as a STBY] LOW - STBY state / HIGH - ACTIVE state.  1h = [if configured as MODE] HIGH - auto-PFM / LOW - forced PWM. [if configured as a STBY] HIGH - STBY state / LOW - ACTIVE state.
3	MULTI_DEVICE_ENABLE	R/W	Х	Configures the device as a single device where GPO is used as GPO function, or as a multi-device configuration where GPO is used for synchronization with other devices. NOTE: ONLY CHANGE IN INITIALIZE STATE! (Default from NVM memory)  0h = Single-device configuration, GPIO pin configured as GPO 1h = Multi-device configuration, GPIO pin configured as GPIO
2	VSEL_RAIL	R/W	Х	LDO controlled by VSEL_SD/VSEL_DDR. NOTE: ONLY CHANGE IN INITIALIZE STATE! (Default from NVM memory) 0h = LDO1 1h = LDO2
1	VSEL_SD_POLARITY	R/W	X	SD Card Voltage Select Note: Ok to change during operation, but consider immediate reaction: change of SD-card supply voltage! (Default from NVM memory)  0h = LOW - 1.8V / HIGH - LDOx_VOUT register setting  1h = HIGH - 1.8V / LOW - LDOx_VOUT register setting

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# 表 6-41. MFP\_1\_CONFIG Register Field Descriptions (続き)

Bit	Field	Туре	Reset	Description
0	VSEL_DDR_SD	R/W		VSEL_SD/VSEL_DDR Configuration NOTE: ONLY CHANGE IN INITIALIZE STATE! (Default from NVM memory) 0h = VSEL pin configured as DDR to set the voltage on Buck3 1h = VSEL pin configured as SD to set the voltage on the VSEL_RAIL

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## 6.8.33 MFP\_2\_CONFIG Register (Offset = 20h) [Reset = X]

MFP\_2\_CONFIG is shown in ■ 6-50 and described in ₹ 6-42.

Return to the Summary Table.

## 図 6-50. MFP\_2\_CONFIG Register

7	6	5	4	3	2	1	0
PU_ON_FSD	WARM_COLD_ RESET_CONFI G	EN_PB_VSE	NSE_CONFIG	EN_PB_VSENS E_DEGL	MODE_RESET _CONFIG	MODE_STB	Y_CONFIG
R/W-X	R/W-X	R/	W-X	R/W-X	R/W-X	R/W	/-X

#### 表 6-42. MFP 2 CONFIG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	PU_ON_FSD	R/W	X	Power up upon First Supply Detected (FSD). So when VSYS is applied, device does power up to ACTIVE state even if EN/PB/ VSENSE pin is at OFF_REQ status. (Default from NVM memory) 0h = First Supply Detection (FSD) Disabled. 1h = First Supply Detection (FSD) Enabled.
6	WARM_COLD_RESET_C ONFIG	R/W	X	Selection between WARM or COLD Reset, when a RESET event is triggered via MODE/RESET pin (does not apply to RESET via I2C) (Default from NVM memory) 0h = COLD RESET 1h = WARM RESET
5-4	EN_PB_VSENSE_CONFI	R/W	X	Enable / Push-Button / VSENSE Configuration. Do not change via I2C after NVM load (except as a precursor before programming NVM) (Default from NVM memory) 0h = Device Enable Configuration 1h = Push Button Configuration 2h = VSENSE Configuration 3h = Device Enable Configuration
3	EN_PB_VSENSE_DEGL	R/W	X	Enable / Push-Button / VSENSE Deglitch NOTE: ONLY CHANGE IN INITIALIZE STATE! Consider immediate reaction when changing from EN/VSENSE to PB or vice versa: power-up! (Default from NVM memory)  0h = short (typ: 120us for EN/VSENSE and 200ms for PB)  1h = long (typ: 50ms for EN/VSENSE and 600ms for PB)
2	MODE_RESET_CONFIG	R/W	Х	MODE/RESET Configuration (Default from NVM memory) 0h = MODE 1h = RESET
1-0	MODE_STBY_CONFIG	R/W	X	MODE_STDBY Configuration (Default from NVM memory) 0h = MODE 1h = STBY 2h = MODE and STBY 3h = MODE

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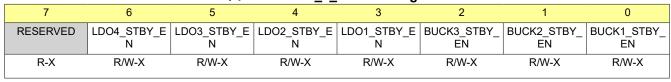


## 6.8.34 STBY\_1\_CONFIG Register (Offset = 21h) [Reset = X]

STBY\_1\_CONFIG is shown in  $\boxtimes$  6-51 and described in  $\textcircled{\pm}$  6-43.

Return to the Summary Table.

#### 図 6-51. STBY\_1\_CONFIG Register



#### 表 6-43. STBY\_1\_CONFIG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	LDO4_STBY_EN	R/W	X	Enable LDO4 in STANDBY state. (Default from NVM memory) 0h = Disabled in STBY Mode 1h = Enabled in STBY Mode
5	LDO3_STBY_EN	R/W	X	Enable LDO3 in STANDBY state. (Default from NVM memory) 0h = Disabled in STBY Mode 1h = Enabled in STBY Mode
4	LDO2_STBY_EN	R/W	Х	Enable LDO2 in STANDBY state. (Default from NVM memory) 0h = Disabled in STBY Mode 1h = Enabled in STBY Mode
3	LDO1_STBY_EN	R/W	Х	Enable LDO1 in STANDBY state. (Default from NVM memory) 0h = Disabled in STBY Mode 1h = Enabled in STBY Mode
2	BUCK3_STBY_EN	R/W	Х	Enable BUCK3 in STANDBY state. (Default from NVM memory) 0h = Disabled in STBY Mode 1h = Enabled in STBY Mode
1	BUCK2_STBY_EN	R/W	X	Enable BUCK2 in STANDBY state. (Default from NVM memory) 0h = Disabled in STBY Mode 1h = Enabled in STBY Mode
0	BUCK1_STBY_EN	R/W	Х	Enable BUCK1 in STANDBY state. (Default from NVM memory) 0h = Disabled in STBY Mode 1h = Enabled in STBY Mode

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## 6.8.35 STBY\_2\_CONFIG Register (Offset = 22h) [Reset = X]

STBY\_2\_CONFIG is shown in 図 6-52 and described in 表 6-44.

Return to the Summary Table.

## 図 6-52. STBY\_2\_CONFIG Register

7	6	5	4	3	2	1	0
RESERVED	RESERVED	RESERVED	RESERVED	RESERVED	GPIO_STBY_E N	GPO2_STBY_E N	GPO1_STBY_E N
R-X	R-X	R-X	R-X	R-X	R/W-X	R/W-X	R/W-X

## 表 6-44. STBY\_2\_CONFIG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	RESERVED	R	Х	Reserved
5	RESERVED	R	Х	Reserved
4	RESERVED	R	Х	Reserved
3	RESERVED	R	Х	Reserved
2	GPIO_STBY_EN	R/W	Х	Enable GPIO in STANDBY state. (Default from NVM memory)  0h = Disabled in STBY Mode  1h = Enabled in STBY Mode
1	GPO2_STBY_EN	R/W	Х	Enable GPO2 in STANDBY state. (Default from NVM memory) 0h = Disabled in STBY Mode 1h = Enabled in STBY Mode
0	GPO1_STBY_EN	R/W	Х	Enable GPO1 in STANDBY state. (Default from NVM memory) 0h = Disabled in STBY Mode 1h = Enabled in STBY Mode

## 6.8.36 OC\_DEGL\_CONFIG Register (Offset = 23h) [Reset = X]

OC\_DEGL\_CONFIG is shown in  $\boxtimes$  6-53 and described in  $\textcircled{\pm}$  6-45.

Return to the Summary Table.

## 図 6-53. OC\_DEGL\_CONFIG Register

7	6	5	4	3	2	1	0
RESERVED	EN_LONG_DE GL_FOR_OC_L DO4	EN_LONG_DE GL_FOR_OC_L DO3		EN_LONG_DE GL_FOR_OC_L DO1	EN_LONG_DE GL_FOR_OC_ BUCK3	EN_LONG_DE GL_FOR_OC_ BUCK2	EN_LONG_DE GL_FOR_OC_ BUCK1
R-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X

## 表 6-45. OC\_DEGL\_CONFIG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	EN_LONG_DEGL_FOR_ OC_LDO4	R/W	X	When set, enables the long-deglitch option for OverCurrent signal of LDO4. When clear, enables the short-deglitch option for OverCurrent signal of LDO4. (Default from NVM memory)  0h = Deglitch duration for OverCurrent signals of LDO4 is ~20us  1h = Deglitch duration for OverCurrent signals of LDO4 is ~2ms
5	EN_LONG_DEGL_FOR_ OC_LDO3	R/W	X	When set, enables the long-deglitch option for OverCurrent signal of LDO3. When clear, enables the short-deglitch option for OverCurrent signal of LDO3. (Default from NVM memory)  0h = Deglitch duration for OverCurrent signals of LDO3 is ~20us  1h = Deglitch duration for OverCurrent signals of LDO3 is ~2ms
4	EN_LONG_DEGL_FOR_ OC_LDO2	R/W	X	When set, enables the long-deglitch option for OverCurrent signal of LDO2. When clear, enables the short-deglitch option for OverCurrent signal of LDO2. (Default from NVM memory)  0h = Deglitch duration for OverCurrent signals of LDO2 is ~20us  1h = Deglitch duration for OverCurrent signals of LDO2 is ~2ms
3	EN_LONG_DEGL_FOR_ OC_LDO1	R/W	X	When set, enables the long-deglitch option for OverCurrent signal of LDO1. When clear, enables the short-deglitch option for OverCurrent signal of LDO1. (Default from NVM memory)  0h = Deglitch duration for OverCurrent signals of LDO1 is ~20us  1h = Deglitch duration for OverCurrent signals of LDO1 is ~2ms
2	EN_LONG_DEGL_FOR_ OC_BUCK3	R/W	X	When set, enables the long-deglitch option for OverCurrent signals of BUCK3. When clear, enables the short-deglitch option for OverCurrent signals of BUCK3. (Default from NVM memory) 0h = Deglitch duration for OverCurrent signals for BUCK3 (High-Side Overcurrent, Low-Side Overcurrent and Low-Side Reverse/Negative OverCurrent) is ~20us 1h = Deglitch duration for OverCurrent signals for BUCK3 (High-Side Overcurrent, Low-Side Overcurrent and Low-Side Reverse/Negative OverCurrent) is ~2ms
1	EN_LONG_DEGL_FOR_ OC_BUCK2	R/W	X	When set, enables the long-deglitch option for OverCurrent signals of BUCK2. When clear, enables the short-deglitch option for OverCurrent signals of BUCK2. (Default from NVM memory) 0h = Deglitch duration for OverCurrent signals for BUCK2 (High-Side Overcurrent, Low-Side Overcurrent and Low-Side Reverse/Negative OverCurrent) is ~20us 1h = Deglitch duration for OverCurrent signals for BUCK2 (High-Side Overcurrent, Low-Side Overcurrent and Low-Side Reverse/Negative OverCurrent) is ~2ms

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# 表 6-45. OC\_DEGL\_CONFIG Register Field Descriptions (続き)

Bit	Field	Туре	Reset	Description
0	EN_LONG_DEGL_FOR_ OC_BUCK1	R/W	X	When set, enables the long-deglitch option for OverCurrent signals of BUCK1. When clear, enables the short-deglitch option for OverCurrent signals of BUCK1. (Default from NVM memory) 0h = Deglitch duration for OverCurrent signals for BUCK1 (High-Side Overcurrent, Low-Side Overcurrent and Low-Side Reverse/Negative OverCurrent) is ~20us 1h = Deglitch duration for OverCurrent signals for BUCK1 (High-Side Overcurrent, Low-Side Overcurrent and Low-Side Reverse/Negative OverCurrent) is ~2ms

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## 6.8.37 INT\_MASK\_UV Register (Offset = 24h) [Reset = X]

INT\_MASK\_UV is shown in 図 6-54 and described in 表 6-46.

Return to the Summary Table.

## 図 6-54. INT\_MASK\_UV Register

7	6	5	4	3	2	1	0
MASK_RETRY _COUNT	BUCK3_UV_M ASK	BUCK2_UV_M ASK	BUCK1_UV_M ASK	LDO4_UV_MA SK	LDO3_UV_MA SK	LDO2_UV_MA SK	LDO1_UV_MA SK
R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X	R/W-X

## 表 6-46. INT\_MASK\_UV Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	MASK_RETRY_COUNT	R/W	X	When set, device can power up even after two retries. (Default from NVM memory) 0h = Device does retry up to 2 times, then stay off 1h = Device does retry infinitely
6	BUCK3_UV_MASK	R/W	X	BUCK3 Undervoltage Mask. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)
5	BUCK2_UV_MASK	R/W	X	BUCK2 Undervoltage Mask. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)
4	BUCK1_UV_MASK	R/W	X	BUCK1 Undervoltage Mask. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)
3	LDO4_UV_MASK	R/W	Х	LDO4 Undervoltage Mask - Always masked in BYP or LSW modes. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)
2	LDO3_UV_MASK	R/W	X	LDO3 Undervoltage Mask - Always masked in BYP or LSW modes. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)
1	LDO2_UV_MASK	R/W	X	LDO2 Undervoltage Mask - Always masked in BYP or LSW modes. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)
0	LDO1_UV_MASK	R/W	X	LDO1 Undervoltage Mask - Always masked in BYP or LSW modes. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)

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## 6.8.38 MASK\_CONFIG Register (Offset = 25h) [Reset = X]

MASK\_CONFIG is shown in 図 6-55 and described in 表 6-47.

Return to the Summary Table.

## 図 6-55. MASK\_CONFIG Register

7	6	5	4	3	2	1	0
MASK_INT_FO R_PB	MASK_EFFECT		MASK_INT_FO R_RV	SENSOR_0_W ARM_MASK	SENSOR_1_W ARM_MASK	SENSOR_2_W ARM_MASK	SENSOR_3_W ARM_MASK
R/W-X	R/W-X		R/W-X	R/W-X	R/W-X	R/W-X	R/W-X

#### 表 6-47. MASK\_CONFIG Register Field Descriptions

Bit	Field	Type	Reset	Description
7	MASK_INT_FOR_PB	R/W	X	Masking bit to control whether nINT pin is sensitive to PushButton (PB) press/release events or not. (Default from NVM memory) 0h = un-masked (nINT pulled low for any PB events) 1h = masked (nINT not sensitive to any PB events)
6-5	MASK_EFFECT	R/W	X	Effect of masking (global) (Default from NVM memory) 0h = no state change, no nINT reaction, no bit set for Faults 1h = no state change, no nINT reaction, bit set for Faults 2h = no state change, nINT reaction, bit set for Faults (same as 11b) 3h = no state change, nINT reaction, bit set for Faults (same as 10b)
4	MASK_INT_FOR_RV	R/W	X	Masking bit to control whether nINT pin is sensitive to RV (Residual Voltage) events or not. (Default from NVM memory) 0h = un-masked (nINT pulled low for any RV events during transition to ACTIVE state or during enabling of rails) 1h = masked (nINT not sensitive to any RV events)
3	SENSOR_0_WARM_MAS K	R/W	X	Die Temperature Warm Fault Mask, Sensor 0. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)
2	SENSOR_1_WARM_MAS K	R/W	X	Die Temperature Warm Fault Mask, Sensor 1. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)
1	SENSOR_2_WARM_MAS K	R/W	X	Die Temperature Warm Fault Mask, Sensor 2. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)
0	SENSOR_3_WARM_MAS K	R/W	X	Die Temperature Warm Fault Mask, Sensor 3. (Default from NVM memory) 0h = un-masked (Faults reported) 1h = masked (Faults not reported)

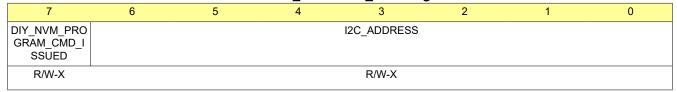
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## 6.8.39 I2C\_ADDRESS\_REG Register (Offset = 26h) [Reset = X]

I2C\_ADDRESS\_REG is shown in 図 6-56 and described in 表 6-48.

Return to the Summary Table.

## 図 6-56. I2C\_ADDRESS\_REG Register



#### 表 6-48. I2C\_ADDRESS\_REG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	DIY_NVM_PROGRAM_C MD_ISSUED	R/W	X	Bit that indicates whether a DIY program command was attempted. Once set, remains always set. (Default from NVM memory) 0h = NVM data not changed 1h = NVM data attempted to be changed via DIY program command
6-0	I2C_ADDRESS	R/W	Х	I2C secondary address. Note: Ok to change during operation, but consider immediate reaction: new address for read/write! (Default from NVM memory)

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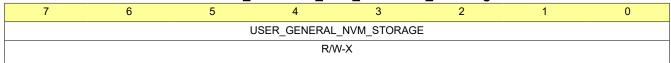
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## 6.8.40 USER\_GENERAL\_NVM\_STORAGE\_REG Register (Offset = 27h) [Reset = X]

USER\_GENERAL\_NVM\_STORAGE\_REG is shown in 図 6-57 and described in 表 6-49. Return to the Summary Table.

#### 図 6-57. USER\_GENERAL\_NVM\_STORAGE\_REG Register



#### 表 6-49. USER\_GENERAL\_NVM\_STORAGE\_REG Register Field Descriptions

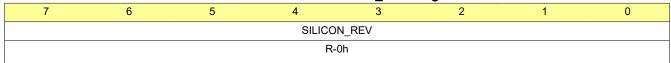
Bit	Field	Туре	Reset	Description
7-0	USER_GENERAL_NVM_ STORAGE	R/W		8-bit NVM-based register available to the user to use to store user- data, for example NVM-ID of customer-modified NVM-version or other purposes. (Default from NVM memory)

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## 6.8.41 MANUFACTURING\_VER Register (Offset = 28h) [Reset = 00h]

Return to the Summary Table.

#### 図 6-58. MANUFACTURING\_VER Register



## 表 6-50. MANUFACTURING\_VER Register Field Descriptions

Bit	Field	Type Reset Description		Description
7-0	SILICON_REV	R		SILICON_REV[7:6] - Reserved SILICON_REV[5:3] - ALR SILICON_REV[2:0] - Metal Silicon Revision - Hard wired (not under NVM control)

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## 6.8.42 MFP\_CTRL Register (Offset = 29h) [Reset = X]

MFP\_CTRL is shown in 図 6-59 and described in 表 6-51.

Return to the Summary Table.

## 図 6-59. MFP\_CTRL Register

7	6	5	4	3	2	1	0
RESERVED	RESERVED	RESERVED	GPIO_STATUS	WARM_RESET _I2C_CTRL	COLD_RESET_ I2C_CTRL	STBY_I2C_CT RL	I2C_OFF_REQ
R-X	R-X	R-X	R-0h	R/WSelfClrF-0h	R/W-0h	R/W-0h	R/WSelfClrF-0h

#### 表 6-51. MFP\_CTRL Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	RESERVED	R	Х	Reserved
5	RESERVED	R	Х	Reserved
4	GPIO_STATUS	R	0h	Indicates the real-time value of GPIO pin 0h = The GPIO pin is currently '0' 1h = The GPIO pin is currently '1'
3	WARM_RESET_I2C_CTR L	R/WSelfClrF	0h	Triggers a WARM RESET when written as '1'. Note: This bit self- clears automatically, so cannot be read as '1' after the write. 0h = normal operation 1h = WARM_RESET
2	COLD_RESET_I2C_CTR L	R/W	0h	Triggers a COLD RESET when set high. Cleared upon entry to INITIALIZE.  0h = normal operation 1h = COLD_RESET
1	STBY_I2C_CTRL	R/W	0h	STBY control using I2C. Consolidated with STBY control via MODE/ STBY pin. Refer to table in spec. 0h = normal operation 1h = STBY mode
0	I2C_OFF_REQ	R/WSelfClrF	0h	When '1' is written to this bit: Trigger OFF request. When '0': No effect. Does self-clear. 0h = No effect 1h = Trigger OFF Request

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## 6.8.43 DISCHARGE\_CONFIG Register (Offset = 2Ah) [Reset = X]

DISCHARGE\_CONFIG is shown in 図 6-60 and described in 表 6-52.

Return to the Summary Table.

#### 図 6-60. DISCHARGE\_CONFIG Register

7	6	5	4	3	2	1	0
RESERVED	LDO4_DISCHA RGE_EN	LDO3_DISCHA RGE_EN	LDO2_DISCHA RGE_EN	LDO1_DISCHA RGE_EN	BUCK3_DISCH ARGE_EN	BUCK2_DISCH ARGE_EN	BUCK1_DISCH ARGE_EN
R-X	R/W-1h	R/W-1h	R/W-1h	R/W-1h	R/W-1h	R/W-1h	R/W-1h

## 表 6-52. DISCHARGE\_CONFIG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	LDO4_DISCHARGE_EN	R/W	1h	Discharge setting for LDO4 $0h = No$ Discharge $1h = 250 \Omega$
5	LDO3_DISCHARGE_EN			Discharge setting for LDO3 $0h = No$ Discharge $1h = 250 \Omega$
4	LDO2_DISCHARGE_EN	R/W	1h	Discharge setting for LDO2 $0h = No$ Discharge $1h = 200 \Omega$
3	LDO1_DISCHARGE_EN	R/W	1h	Discharge setting for LDO1 $0h = No$ Discharge $1h = 200 \Omega$
2	BUCK3_DISCHARGE_EN	R/W	1h	Discharge setting for BUCK3 0h = No Discharge $1h = 125 \Omega$
1	BUCK2_DISCHARGE_EN	R/W	1h	Discharge setting for BUCK2 $0h = No$ Discharge $1h = 125 \Omega$
0	BUCK1_DISCHARGE_EN	R/W	1h	Discharge setting for BUCK1 $0h = No$ Discharge $1h = 125 \Omega$

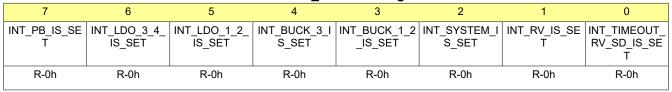
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## 6.8.44 INT\_SOURCE Register (Offset = 2Bh) [Reset = 00h]

INT\_SOURCE is shown in 図 6-61 and described in 表 6-53.

Return to the Summary Table.

#### 図 6-61. INT\_SOURCE Register



#### 表 6-53. INT\_SOURCE Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	INT_PB_IS_SET	R	Oh	One or more sources of the INT present in register INT_PB 0h = No bits set in INT_PB 1h = One or more bits set in INT_PB
6	INT_LDO_3_4_IS_SET	R	0h	One or more sources of the INT present in register INT_LDO_3_4 0h = No bits set in INT_LDO_3_4 1h = One or more bits set in INT_LDO_3_4
5	INT_LDO_1_2_IS_SET	R	0h	One or more sources of the INT present in register INT_LDO_1_2 0h = No bits set in INT_LDO_1_2 1h = One or more bits set in INT_LDO_1_2
4	INT_BUCK_3_IS_SET	R	0h	One or more sources of the INT present in register INT_BUCK_3 0h = No bits set in INT_BUCK_3 1h = One or more bits set in INT_BUCK_3
3	INT_BUCK_1_2_IS_SET	R	0h	One or more sources of the INT present in register INT_BUCK_1_2 0h = No bits set in INT_BUCK_1_2 1h = One or more bits set in INT_BUCK_1_2
2	INT_SYSTEM_IS_SET	R	0h	One or more sources of the INT present in register INT_SYSTEM  0h = No bits set in INT_SYSTEM  1h = One or more bits set in INT_SYSTEM
1	INT_RV_IS_SET	R	Oh	One or more sources of the INT present in register INT_RV 0h = No bits set in INT_RV 1h = One or more bits set in INT_RV
0	INT_TIMEOUT_RV_SD_I S_SET	R	Oh	One or more sources of the INT present in register INT_TIMEOUT_RV_SD 0h = No bits set in INT_TIMEOUT_RV_SD 1h = One or more bits set in INT_TIMEOUT_RV_SD

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## 6.8.45 INT\_LDO\_3\_4 Register (Offset = 2Ch) [Reset = X]

INT\_LDO\_3\_4 is shown in 図 6-62 and described in 表 6-54.

Return to the Summary Table.

## 図 6-62. INT\_LDO\_3\_4 Register

7	6	5	4	3	2	1	0
RESERVED	RESERVED	LDO4_UV	LDO4_OC	LDO4_SCG	LDO3_UV	LDO3_OC	LDO3_SCG
R-X	R-X	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h

## 表 6-54. INT\_LDO\_3\_4 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	RESERVED	R	Х	Reserved
5	LDO4_UV	R/W1C	Oh	LDO4 Undervoltage Fault. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_UV_MASK bit in register INT_MASK_UV is '1' 0h = No Fault detected 1h = Fault detected
4	LDO4_OC	R/W1C	0h	LDO4 Overcurrent Fault. 0h = No Fault detected 1h = Fault detected
3	LDO4_SCG	R/W1C	0h	LDO4 Short Circuit to Ground Fault 0h = No Fault detected 1h = Fault detected
2	LDO3_UV	R/W1C	Oh	LDO3 Undervoltage Fault. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_UV_MASK bit in register INT_MASK_UV is '1' 0h = No Fault detected 1h = Fault detected
1	LDO3_OC	R/W1C	Oh	LDO3 Overcurrent Fault 0h = No Fault detected 1h = Fault detected
0	LDO3_SCG	R/W1C	Oh	LDO3 Short Circuit to Ground Fault 0h = No Fault detected 1h = Fault detected

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## 6.8.46 INT\_LDO\_1\_2 Register (Offset = 2Dh) [Reset = X]

INT\_LDO\_1\_2 is shown in 図 6-63 and described in 表 6-55.

Return to the Summary Table.

## 図 6-63. INT\_LDO\_1\_2 Register

7	6	5	4	3	2	1	0
RESERVED	RESERVED	LDO2_UV	LDO2_OC	LDO2_SCG	LDO1_UV	LDO1_OC	LDO1_SCG
R-X	R-X	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h

## 表 6-55. INT\_LDO\_1\_2 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	RESERVED	R	Х	Reserved
5	LDO2_UV	R/W1C	Oh	LDO2 Undervoltage Fault. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_UV_MASK bit in register INT_MASK_UV is '1' 0h = No Fault detected 1h = Fault detected
4	LDO2_OC	R/W1C	Oh	LDO2 Overcurrent Fault 0h = No Fault detected 1h = Fault detected
3	LDO2_SCG	R/W1C	0h	LDO2 Short Circuit to Ground Fault 0h = No Fault detected 1h = Fault detected
2	LDO1_UV	R/W1C	0h	LDO1 Undervoltage Fault. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_UV_MASK bit in register INT_MASK_UV is '1' 0h = No Fault detected 1h = Fault detected
1	LDO1_OC	R/W1C	Oh	LDO1 Overcurrent Fault 0h = No Fault detected 1h = Fault detected
0	LDO1_SCG	R/W1C	0h	LDO1 Short Circuit to Ground Fault 0h = No Fault detected 1h = Fault detected

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## 6.8.47 INT\_BUCK\_3 Register (Offset = 2Eh) [Reset = X]

INT\_BUCK\_3 is shown in 図 6-64 and described in 表 6-56.

Return to the Summary Table.

## 図 6-64. INT\_BUCK\_3 Register

7	6	5	4	3	2	1	0
RESERVED	RESERVED	RESERVED	RESERVED	BUCK3_UV	BUCK3_NEG_ OC	BUCK3_OC	BUCK3_SCG
R-X	R-X	R-X	R-X	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h

## 表 6-56. INT\_BUCK\_3 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	RESERVED	R	Х	Reserved
5	RESERVED	R	Х	Reserved
4	RESERVED	R	Х	Reserved
3	BUCK3_UV	R/W1C	Oh	BUCK3 Undervoltage Fault. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_UV_MASK bit in register INT_MASK_UV is '1' 0h = No Fault detected 1h = Fault detected
2	BUCK3_NEG_OC	R/W1C	Oh	BUCK3 Negative Overcurrent Fault 0h = No Fault detected 1h = Fault detected
1	BUCK3_OC	R/W1C	Oh	BUCK3 Positive Overcurrent Fault 0h = No Fault detected 1h = Fault detected
0	BUCK3_SCG	R/W1C	Oh	BUCK3 Short Circuit to Ground Fault 0h = No Fault detected 1h = Fault detected

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## 6.8.48 INT\_BUCK\_1\_2 Register (Offset = 2Fh) [Reset = 00h]

INT\_BUCK\_1\_2 is shown in 図 6-65 and described in 表 6-57.

Return to the Summary Table.

## 図 6-65. INT\_BUCK\_1\_2 Register

7	6	5	4	3	2	1	0
BUCK2_UV	BUCK2_NEG_ OC	BUCK2_OC	BUCK2_SCG	BUCK1_UV	BUCK1_NEG_ OC	BUCK1_OC	BUCK1_SCG
R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h

## 表 6-57. INT\_BUCK\_1\_2 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	BUCK2_UV	R/W1C	0h	BUCK2 Undervoltage Fault. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_UV_MASK bit in register INT_MASK_UV is '1'  Oh = No Fault detected  1h = Fault detected
6	BUCK2_NEG_OC	R/W1C	0h	BUCK2 Negative Overcurrent Fault 0h = No Fault detected 1h = Fault detected
5	BUCK2_OC	R/W1C	Oh	BUCK2 Positive Overcurrent Fault 0h = No Fault detected 1h = Fault detected
4	BUCK2_SCG	R/W1C	0h	BUCK2 Short Circuit to Ground Fault 0h = No Fault detected 1h = Fault detected
3	BUCK1_UV	R/W1C	0h	BUCK1 Undervoltage Fault. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_UV_MASK bit in register INT_MASK_UV is '1'  0h = No Fault detected  1h = Fault detected
2	BUCK1_NEG_OC	R/W1C	0h	BUCK1 Negative Overcurrent Fault 0h = No Fault detected 1h = Fault detected
1	BUCK1_OC	R/W1C	0h	BUCK1 Positive Overcurrent Fault 0h = No Fault detected 1h = Fault detected
0	BUCK1_SCG	R/W1C	0h	BUCK1 Short Circuit to Ground Fault  0h = No Fault detected  1h = Fault detected

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## 6.8.49 INT\_SYSTEM Register (Offset = 30h) [Reset = 00h]

INT\_SYSTEM is shown in  $\boxtimes$  6-66 and described in  $\bigstar$  6-58.

Return to the Summary Table.

#### 図 6-66. INT\_SYSTEM Register

7	6	5	4	3	2	1	0
SENSOR_0_H OT	SENSOR_1_H OT	SENSOR_2_H OT	SENSOR_3_H OT	SENSOR_0_W ARM	SENSOR_1_W ARM	SENSOR_2_W ARM	SENSOR_3_W ARM
R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h

## 表 6-58. INT\_SYSTEM Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	SENSOR_0_HOT	R/W1C	0h	TSD Hot detection for sensor 0 0h = No Fault detected 1h = Fault detected
6	SENSOR_1_HOT	R/W1C	0h	TSD Hot detection for sensor 1 0h = No Fault detected 1h = Fault detected
5	SENSOR_2_HOT	R/W1C	0h	TSD Hot detection for sensor 2 0h = No Fault detected 1h = Fault detected
4	SENSOR_3_HOT	R/W1C	Oh	TSD Hot detection for sensor 3 0h = No Fault detected 1h = Fault detected
3	SENSOR_0_WARM	R/W1C	Oh	TSD Warm detection for sensor 0. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_WARM_MASK bit in register MASK_CONFIG is '1' 0h = No Fault detected 1h = Fault detected
2	SENSOR_1_WARM	R/W1C	Oh	TSD Warm detection for sensor 1. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_WARM_MASK bit in register MASK_CONFIG is '1' 0h = No Fault detected 1h = Fault detected
1	SENSOR_2_WARM	R/W1C	Oh	TSD Warm detection for sensor 2. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_WARM_MASK bit in register MASK_CONFIG is '1' 0h = No Fault detected 1h = Fault detected
0	SENSOR_3_WARM	R/W1C	Oh	TSD Warm detection for sensor 3. Is automatically cleared upon a transition to INITIALIZE state, if corresponding *_WARM_MASK bit in register MASK_CONFIG is '1' 0h = No Fault detected 1h = Fault detected

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## 6.8.50 INT\_RV Register (Offset = 31h) [Reset = X]

INT\_RV is shown in  $\boxtimes$  6-67 and described in  $\textcircled{\pm}$  6-59.

Return to the Summary Table.

## 図 6-67. INT\_RV Register

7	6	5	4	3	2	1	0
RESERVED	LDO4_RV	LDO3_RV	LDO2_RV	LDO1_RV	BUCK3_RV	BUCK2_RV	BUCK1_RV
R-X	R/W1C-0h						

#### 表 6-59. INT\_RV Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	LDO4_RV	R/W1C	Oh	RV event detected on LDO4 rail during rail-turn-on, or after 4-5 ms during discharge checks prior to entering power sequence to ACTIVE state  0h = No RV detected  1h = RV detected
5	LDO3_RV	R/W1C	0h	RV event detected on LDO3 rail during rail-turn-on, or after 4-5 ms during discharge checks prior to entering power sequence to ACTIVE state  0h = No RV detected  1h = RV detected
4	LDO2_RV	R/W1C	0h	RV event detected on LDO2 rail during rail-turn-on, or after 4-5 ms during discharge checks prior to entering power sequence to ACTIVE state  0h = No RV detected  1h = RV detected
3	LDO1_RV	R/W1C	Oh	RV event detected on LDO1 rail during rail-turn-on, or after 4-5 ms during discharge checks prior to entering power sequence to ACTIVE state  0h = No RV detected  1h = RV detected
2	BUCK3_RV	R/W1C	Oh	RV event detected on BUCK3 rail during rail-turn-on, or after 4-5 ms during discharge checks prior to entering power sequence to ACTIVE state  0h = No RV detected  1h = RV detected
1	BUCK2_RV	R/W1C	Oh	RV event detected on BUCK2 rail during rail-turn-on, or after 4-5 ms during discharge checks prior to entering power sequence to ACTIVE state  0h = No RV detected  1h = RV detected
0	BUCK1_RV	R/W1C	Oh	RV event detected on BUCK1 rail during rail-turn-on, or after 4-5 ms during discharge checks prior to entering power sequence to ACTIVE state  0h = No RV detected  1h = RV detected

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## 6.8.51 INT\_TIMEOUT\_RV\_SD Register (Offset = 32h) [Reset = 00h]

INT\_TIMEOUT\_RV\_SD is shown in 図 6-68 and described in 表 6-60.

Return to the Summary Table.

#### 図 6-68. INT\_TIMEOUT\_RV\_SD Register

7	6	5	4	3	2	1	0
TIMEOUT	LDO4_RV_SD	LDO3_RV_SD	LDO2_RV_SD	LDO1_RV_SD	BUCK3_RV_SD	BUCK2_RV_SD	BUCK1_RV_SD
R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h	R/W1C-0h

## 表 6-60. INT\_TIMEOUT\_RV\_SD Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	TIMEOUT	R/W1C	Oh	Is set if ShutDown occurred due to a TimeOut while: 1. Transitioning to ACTIVE state, and one or more rails did not rise past the UV level at the end of the assigned slot (and UV on this rail is configured as a SD fault). Which rail(s) is/are indicated by the *_UV bits in the INT_* registers. 2. Transitioning to STANDBY state, and one or more rails did not fall below the SCG level at the end of the assigned slot and discharge is enabled for that rail (which rail(s) is/are indicated by the corresponding RV_SD bit(s) in this register).  Oh = No SD due to TimeOut occurred  1h = SD due to TimeOut occurred
6	LDO4_RV_SD	R/W1C	Oh	RV on LDO4 rail caused a shutdown during: 1. A transition to STANDBY state, this rail did not discharge at the end of the assigned slot and discharge is enabled for this rail 2. A transition to STANDBY state, RV was observed on this rail during the transition after this rail was disabled and discharge was enabled 3. A transition to ACTIVE state, RV was observed on this rail during the transition when this rail was OFF (rails are expected to be discharged before commencing the sequence to ACTIVE) 4. This rail did not discharge and therefore caused a Timeout-SD while attempting to discharge all rails at the start of a transition from STANDBY to ACTIVE (TIMEOUT bit gets also set in this case)  0h = No SD due to RV/DISCHARGE_TIMEOUT on LDO4 occurred 1h = SD due to RV/DISCHARGE_TIMEOUT on LDO4 occurred
5	LDO3_RV_SD	R/W1C	Oh	RV on LDO4 rail caused a shutdown during: 1. A transition to STANDBY state, this rail did not discharge at the end of the assigned slot and discharge is enabled for this rail 2. A transition to STANDBY state, RV was observed on this rail during the transition after this rail was disabled and discharge was enabled 3. A transition to ACTIVE state, RV was observed on this rail during the transition when this rail was OFF (rails are expected to be discharged before commencing the sequence to ACTIVE) 4. This rail did not discharge and therefore caused a Timeout-SD while attempting to discharge all rails at the start of a transition from STANDBY to ACTIVE (TIMEOUT bit gets also set in this case)  0h = No SD due to RV/DISCHARGE_TIMEOUT on LDO3 occurred 1h = SD due to RV/DISCHARGE_TIMEOUT on LDO3 occurred
4	LDO2_RV_SD	R/W1C	Oh	RV on LDO4 rail caused a shutdown during: 1. A transition to STANDBY state, this rail did not discharge at the end of the assigned slot and discharge is enabled for this rail 2. A transition to STANDBY state, RV was observed on this rail during the transition after this rail was disabled and discharge was enabled 3. A transition to ACTIVE state, RV was observed on this rail during the transition when this rail was OFF (rails are expected to be discharged before commencing the sequence to ACTIVE) 4. This rail did not discharge and therefore caused a Timeout-SD while attempting to discharge all rails at the start of a transition from STANDBY to ACTIVE (TIMEOUT bit gets also set in this case)  0h = No SD due to RV/DISCHARGE_TIMEOUT on LDO2 occurred 1h = SD due to RV/DISCHARGE_TIMEOUT on LDO2 occurred

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# 表 6-60, INT TIMEOUT RV SD Register Field Descriptions (続き)

D:4				Register Field Descriptions (続き)
Bit	Field	Туре	Reset	Description
3	LDO1_RV_SD	R/W1C	Oh	RV on LDO4 rail caused a shutdown during: 1. A transition to STANDBY state, this rail did not discharge at the end of the assigned slot and discharge is enabled for this rail 2. A transition to STANDBY state, RV was observed on this rail during the transition after this rail was disabled and discharge was enabled 3. A transition to ACTIVE state, RV was observed on this rail during the transition when this rail was OFF (rails are expected to be discharged before commencing the sequence to ACTIVE) 4. This rail did not discharge and therefore caused a Timeout-SD while attempting to discharge all rails at the start of a transition from STANDBY to ACTIVE (TIMEOUT bit gets also set in this case)  0h = No SD due to RV/DISCHARGE_TIMEOUT on LDO1 occurred 1h = SD due to RV/DISCHARGE_TIMEOUT on LDO1 occurred
2	BUCK3_RV_SD	R/W1C	0h	RV on LDO4 rail caused a shutdown during: 1. A transition to STANDBY state, this rail did not discharge at the end of the assigned slot and discharge is enabled for this rail 2. A transition to STANDBY state, RV was observed on this rail during the transition after this rail was disabled and discharge was enabled 3. A transition to ACTIVE state, RV was observed on this rail during the transition when this rail was OFF (rails are expected to be discharged before commencing the sequence to ACTIVE) 4. This rail did not discharge and therefore caused a Timeout-SD while attempting to discharge all rails at the start of a transition from STANDBY to ACTIVE (TIMEOUT bit gets also set in this case)  0h = No SD due to RV/DISCHARGE_TIMEOUT on BUCK3 occurred 1h = SD due to RV/DISCHARGE_TIMEOUT on BUCK3 occurred
1	BUCK2_RV_SD	R/W1C	Oh	RV on LDO4 rail caused a shutdown during: 1. A transition to STANDBY state, this rail did not discharge at the end of the assigned slot and discharge is enabled for this rail 2. A transition to STANDBY state, RV was observed on this rail during the transition after this rail was disabled and discharge was enabled 3. A transition to ACTIVE state, RV was observed on this rail during the transition when this rail was OFF (rails are expected to be discharged before commencing the sequence to ACTIVE) 4. This rail did not discharge and therefore caused a Timeout-SD while attempting to discharge all rails at the start of a transition from STANDBY to ACTIVE (TIMEOUT bit gets also set in this case)  0h = No SD due to RV/DISCHARGE_TIMEOUT on BUCK2 occurred 1h = SD due to RV/DISCHARGE_TIMEOUT on BUCK2 occurred
0	BUCK1_RV_SD	R/W1C	Oh	RV on LDO4 rail caused a shutdown during: 1. A transition to STANDBY state, this rail did not discharge at the end of the assigned slot and discharge is enabled for this rail 2. A transition to STANDBY state, RV was observed on this rail during the transition after this rail was disabled and discharge was enabled 3. A transition to ACTIVE state, RV was observed on this rail during the transition when this rail was OFF (rails are expected to be discharged before commencing the sequence to ACTIVE) 4. This rail did not discharge and therefore caused a Timeout-SD while attempting to discharge all rails at the start of a transition from STANDBY to ACTIVE (TIMEOUT bit gets also set in this case)  0h = No SD due to RV/DISCHARGE_TIMEOUT on BUCK1 occurred 1h = SD due to RV/DISCHARGE_TIMEOUT on BUCK1 occurred

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## 6.8.52 INT\_PB Register (Offset = 33h) [Reset = X]

INT\_PB is shown in 図 6-69 and described in 表 6-61.

Return to the Summary Table.

#### 図 6-69. INT\_PB Register

7	6	5	4	3	2	1	0
RESERVED	RESERVED	RESERVED	RESERVED	RESERVED	PB_REAL_TIM E_STATUS	PB_RISING_E DGE_DETECT ED	PB_FALLING_E DGE_DETECT ED
R-X	R-X	R-X	R-X	R-X	R-1h	R/W1C-0h	R/W1C-0h

# 表 6-61. INT\_PB Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	RESERVED	R	Х	Reserved
6	RESERVED	R	Х	Reserved
5	RESERVED	R	Х	Reserved
4	RESERVED	R	Х	Reserved
3	RESERVED	R	X	Reserved
2	PB_REAL_TIME_STATUS	R	1h	Deglitched (64-128ms) real-time status of PB pin. Valid only when EN/PB/VSENSE pin is configured as PB.  0h = Current deglitched status of PB: PRESSED  1h = Current deglitched status of PB: RELEASED
1	PB_RISING_EDGE_DET ECTED	R/W1C	0h	PB was released for > deglitch period (64-128ms) since the previous time this bit was cleared. This bit when set, does assert nINT pin (if config bit MASK_INT_FOR_PB='0').  0h = No PB-release detected  1h = PB-release detected
0	PB_FALLING_EDGE_DE TECTED	R/W1C	0h	PB was pressed for > deglitch period (64-128ms) since the previous time this bit was cleared. This bit when set, does assert nINT pin (if config bit MASK_INT_FOR_PB='0').  0h = No PB-press detected  1h = PB-press detected

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## 6.8.53 USER\_NVM\_CMD\_REG Register (Offset = 34h) [Reset = 00h]

USER\_NVM\_CMD\_REG is shown in 図 6-70 and described in 表 6-62.

Return to the Summary Table.

# 図 6-70. USER\_NVM\_CMD\_REG Register

7	6	5	4	3	2	1	0
NVM_VERIFY_ RESULT	CUST_NVM_V ERIFY_DONE	CUST_PROG_ DONE	I2C_OSC_ON		USER_N	VM_CMD	
R-0h	R/W1C-0h	R/W1C-0h	R-0h		R-	0h	

#### 表 6-62. USER\_NVM\_CMD\_REG Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	NVM_VERIFY_RESULT	R	0h	After an CUST_NVM_VERIFY_CMD is executed, this bit gives the result of the operation. (1 = fail, 0= pass). If '1', can only be cleared if a subsequent CUST_NVM_VERIFY_CMD passes.  0h = PASS 1h = FAIL
6	CUST_NVM_VERIFY_DO NE	R/W1C	Oh	Is set to '1' after a CUST_NVM_VERIFY_CMD is executed. Remains '1' until W1C by user.  Oh = Not yet done / not in progress  1h = Done
5	CUST_PROG_DONE	R/W1C	Oh	Is set to '1' after a CUST_PROG_CMD is executed. Remains '1' until W1C by user.  0h = Not yet done / not in progress 1h = Done
4	I2C_OSC_ON	R	0h	This register field is set to '1' if an EN_OSC_DIY is received.  0h = OSC not controlled via I2C  1h = OSC unconditionally ON due to I2C command EN_OSC_DIY
3-0	USER_NVM_CMD	R	Oh	Commands to enter DIY programming mode and program user NVM space. Always reads as 0.  6h = DIS_OSC_DIY  7h = CUST_NVM_VERIFY_CMD  9h = EN_OSC_DIY  Ah = CUST_PROG_CMD

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## 6.8.54 POWER\_UP\_STATUS\_REG Register (Offset = 35h) [Reset = 00h]

POWER\_UP\_STATUS\_REG is shown in 図 6-71 and described in 表 6-63.

Return to the Summary Table.

#### 図 6-71. POWER\_UP\_STATUS\_REG Register

7	6	5	4	3	2	1	0
POWER_UP_F ROM_FSD	POWER_UP_F ROM_EN_PB_ VSENSE	COLD_RESET_ ISSUED	STA	TE	RETRY_	COUNT	POWER_UP_F ROM_OFF
R/W1C-0h	R/W1C-0h	R/W1C-0h	R-0	Oh	R-0	)h	R/W1C-0h

#### 表 6-63. POWER\_UP\_STATUS\_REG Register Field Descriptions

Bit	Field	Type	Reset	Description
7	POWER_UP_FROM_FSD		0h	Is set if ON_REQ was triggered due to FSD 0h = No power-up via FSD detected 1h = Power-up via FSD detected
6	POWER_UP_FROM_EN_ PB_VSENSE	R/W1C	0h	Is set if ON_REQ was triggered due to EN/PB/VSENSE pin 0h = No power-up via pin detected 1h = Power-up via pin detected
5	COLD_RESET_ISSUED	R/W1C	0h	Is set if we received a COLD_RESET over pin or over I2C 0h = No COLD RESET received 1h = COLD RESET received either through pin or I2C
4-3	STATE	R	0h	Indicates the current device state  0h = Transition state  1h = INITIALIZE  2h = STANDBY  3h = ACTIVE
2-1	RETRY_COUNT	R	0h	Reads the current retry count in the state machine. If RETRY_COUNT = 3 and is not masked, device does not power up.
0	POWER_UP_FROM_OFF	R/W1C	0h	Indicates if we powered up from OFF state (POR was asserted) 0h = OFF state not entered since the previous clearing of this bit 1h = OFF state was entered since the previous clearing of this bit

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## 6.8.55 SPARE\_2 Register (Offset = 36h) [Reset = 00h]

SPARE\_2 is shown in 図 6-72 and described in 表 6-64.

Return to the Summary Table.

#### 図 6-72. SPARE\_2 Register

7	6	5	4	3	2	1	0
SPARE_2_1	SPARE_2_2	SPARE_2_3	SPARE_2_4	SPARE_2_5	SPARE_2_6	SPARE_2_7	SPARE_2_8
R/W-0h							

#### 表 6-64. SPARE\_2 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7	SPARE_2_1	R/W	0h	Spare bit in user non-NVM space
6	SPARE_2_2	R/W	0h	Spare bit in user non-NVM space
5	SPARE_2_3	R/W	0h	Spare bit in user non-NVM space
4	SPARE_2_4	R/W	0h	Spare bit in user non-NVM space
3	SPARE_2_5	R/W	0h	Spare bit in user non-NVM space
2	SPARE_2_6	R/W	0h	Spare bit in user non-NVM space
1	SPARE_2_7	R/W	0h	Spare bit in user non-NVM space
0	SPARE_2_8	R/W	0h	Spare bit in user non-NVM space

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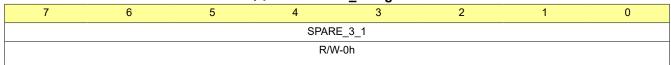


## 6.8.56 SPARE\_3 Register (Offset = 37h) [Reset = 00h]

SPARE\_3 is shown in  $\boxtimes$  6-73 and described in  $\textcircled{\pm}$  6-65.

Return to the Summary Table.

#### 図 6-73. SPARE\_3 Register



#### 表 6-65. SPARE\_3 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	SPARE_3_1	R/W	0h	Spare bit in user non-NVM space

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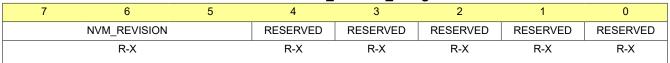
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## 6.8.57 FACTORY\_CONFIG\_2 Register (Offset = 41h) [Reset = X]

FACTORY\_CONFIG\_2 is shown in 図 6-74 and described in 表 6-66.

Return to the Summary Table.

#### 図 6-74. FACTORY\_CONFIG\_2 Register



#### 表 6-66. FACTORY\_CONFIG\_2 Register Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	NVM_REVISION	R	X	Specifies the version of the NVM configuration Note: This register can be programmed only by the manufacturer.  0h = V0  1h = V1
4	RESERVED	R	Х	Reserved
3	RESERVED	R	Х	Reserved
2	RESERVED	R	Х	Reserved
1	RESERVED	R	Х	Reserved
0	RESERVED	R	Х	Reserved

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## 7 Application and Implementation

注

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#### 7.1 Application Information

The following sections provide more detail on the proper utilization of the PMIC. Each orderable part number has unique default non-volatile memory (NVM) settings and the relevant Technical Reference Manual (TRM) for that orderable is available in the product folder, under Technical Documentation. Refer to these TRMs for specific application information. More generic topics and some examples are outlined here.

To help with new designs, a variety of tools and documents are available in the product folder. Some examples are:

- Evaluation module and user guide.
- GUI to communicate with the PMIC
- · Schematic and layout checklist
- User's guide describing how to power specific processors and SoCs with the PMIC.
- Technical Reference Manual (TRM) describing the default register settings on each orderable.

#### 7.2 Typical Application

The TPS6521905 PMIC contains seven regulators; 3 Buck converters and 4 Low Drop-out Regulators (LDOs). In addition to the power resources, it also integrates 3 configurable multi-function pins, 1 GPIO, 2 GPOs and I2C communication making this power management IC an ideal cost and size optimized solution to power multiple processors and SoCs. There are several considerations to take into account when designing the TPS6521905 to power a processor and peripherals. The number of regulators needed, the required sequencing, the load current requirements, and the voltage characteristics are all critical in determining the number of supply rails as well as the external components used with it. The following section provides a generic case. For specific cases, refer to the relevant user's guide and TRM based on the orderable part number.

#### 7.2.1 Typical Application Example

In this example, a single TPS6521905 PMIC is used to power a generic processor. This power distribution network (PDN) shows a 3.3V input supply but 5V can be used as well to supply the Bucks and LDO (if not configured as bypass). To reduce power dissipation, the output from one of the PMIC Buck regulators can be used to supply the LDOs if it meets the required headroom and sequence needs. For example, Buck2 (1.8V) is used to supply LDO2 (0.85V). LDO1 is configured as bypass and assigned to supply the SD card interface. The bypass mode allows voltage change between VSET\_LDO1 and 1.8V to meet the SD spec for UHS speed which requires 3.3V to initialize the card before the voltage can be lowered to 1.8V for faster rise/fall time and lower electromagnetic interference. The VSEL\_SD multifunction pin can be configured to trigger the voltage change during operation. Since Buck1 is the regulator with the highest current capabilities, it was assigned to supply the CORE rail of the processor. Each of the Buck regulators have the option to be configured for high bandwidth to support higher load transients and higher total capacitance (local + point of load). Since the PMIC is being supplied by a 3.3V rail, an external load switch is used to supply the 3.3V IO domain on the processor. One of the PMIC GPOs (GPO2) is configured to be part of the power-up/power-down sequence and enables the external power-switch.

注

If an external discrete is used to supply the 3.3V IO, it must be chosen with active discharge so the voltage can be discharge after the PMIC GPO2 disables it.

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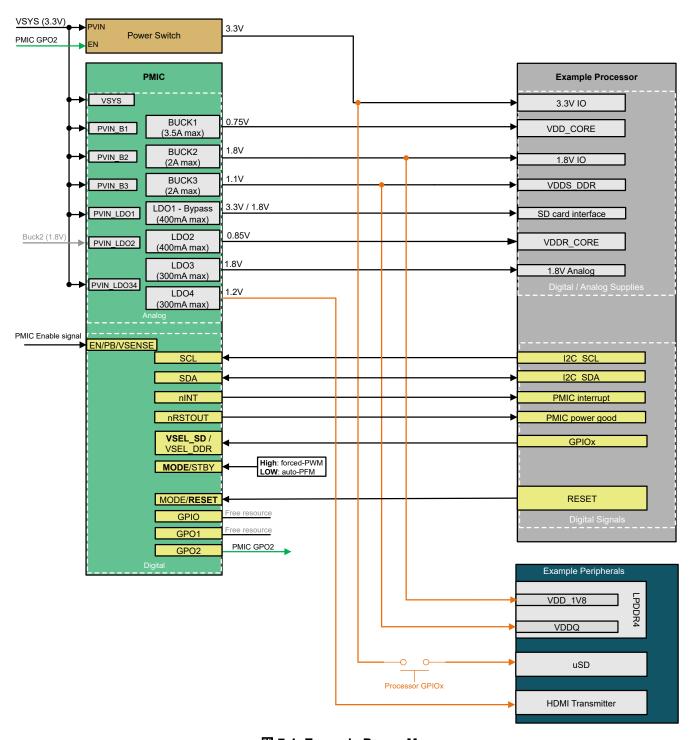


図 7-1. Example Power Map

#### 7.2.2 Design Requirements

The design requirements for the typical application described on this section are outlined below:

- VDD CORE rail requires 0.75 V rail with high loadtransient response.
- VDDR CORE rail requires 0.85V.
- Low noise 1.8V required to supply the analog.
- 3.3V and 1.8V required to supply processor IO domains and peripherals.

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- uSD card interface requires a rail with 3.3V at startup with dynamic voltage capability to switch from 3.3V to 1.8V and support ultra-high speed (UHS)
- · LPDDR4 requires a 1.1V rail.
- HDMI transmitter requires 1.2V rail.

#### 7.2.3 Detailed Design Procedure

This section describes the design procedure for each of the power modules integrated in the TPS6521905 PMIC. Please note, most of the external component values that are mentioned in this section are based on the typical spec. For minimum and maximum values, refer to the corresponding parameter in the Specifications section.

#### 7.2.3.1 Buck1, Buck2, Buck3 Design Procedure

#### Input Capacitance - Buck1, Buck2, Buck3

Each of the Buck converters require an input capacitor on the corresponding PVIN\_Bx pin. The capacitor value must be selected taking into account the voltage and temperature de-rating. Due to the nature of the switching converter, a low ESR ceramic capacitor is required for best input voltage filtering. The typical recommended capacitance is 4.7 uF, 10V capacitor. Higher input capacitance can be used if the PCB size allows larger footprint.

#### Output Capacitance - Buck1, Buck2, Buck3

Every Buck output requires a local output capacitor to form the capacitive part of the LC output filter. Ceramic capacitor with X7 temperature coefficient are recommended. Non-automotive applications can use X6 or lower based on the operating temperature. The Buck converters have multiple switching modes and bandwidth configuration that impact the output capacitor selection. The switching mode configuration (BUCK\_FF\_ENABLE) is a global register field that applies to the three Buck converters and must not be changed at any point. The bandwidth selection is an independent register field for each Buck converter. Refer to the Technical Reference Manual (TRM) for the specific orderable part number to identify the NVM configuration and the corresponding output capacitance requirements.  $\frac{1}{2}$  7-1 shows the required minimum and maximum capacitance (after derating) for each switching mode and bandwidth configuration. DC bias voltage characteristics of ceramic capacitors, tolerance, aging and temperature effects must be considered. ESR must be 10 m $\Omega$  or lower.

Switching Mode Selection	Bandwidth Selection	Spec parameter		Capacitance
Register Field: BUCK_FF_ENABLE	Register fields: BUCK1_BW_SEL, BUCK2_BW_SEL, BUCK3_BW_SEL		Min	Max (Includes local + point of load)
Quasi-fixed frequency	Low Bandwidth	COUT	10 uF	75 uF
(auto-PFM or forced-PWM)	High Bandwidth	COUT_HIGH_BW	30 uF	220 uF

表 7-1. Buck output capacitance

#### Inductor Selection - Buck1, Buck2, Buck3

Internal parameters for the buck converters are optimized for 0.47uH inductor. DCR must be 50 m $\Omega$  or lower. Ensure that the selected inductor is rated to support saturation current of at least 7.4A for Buck1 and 5.4A for Buck2/Buck3.

#### 7.2.3.2 LDO1, LDO2 Design Procedure

#### Input Capacitance - LDO1, LDO2

LDO inputs require an input decoupling capacitor to minimize input ripple voltage. Using a typical of  $2.2-\mu F$  capacitance for each LDO is recommended. Depending on the input voltage of the LDO, a 6.3~V or higher rated capacitor can be used. The same input capacitance requirements applies when the LDO is configured as LDO, bypass or "load-switch.

### **Output Capacitance - LDO1, LDO2**

LDO outputs require an output capacitor to hold up the output voltage during a load step or changes to the input voltage. Using a 2.2-μF local capacitance for each LDO output with ESR of 10 m $\Omega$  or less is recommended. Local capacitance must not exceed 4μF (after derating). This requirement excludes any capacitance seen at the load and only refers to the capacitance seen close to the device. The total capacitance (local + point of load) that each LDO can support depends on the NVM configuration.  $\frac{1}{2}$  7-2 shows the maximum total output capacitance allowed based on the rail configuration. Refer to the Technical Reference Manual (TRM) for the specific orderable part number to identify the LDO configuration based on the register settings and the applicable max total capacitance.

表 7-2. LDO1, LDO2 output capacitance

Registe	er setting	LDO config	Max total capacitance (2.2uF local +		
LDOx_LSW_CONFIG	LDOx_BYP_CONFIG		point of load)		
0	0	LDO	20uF		
0	1	Bypass	50uF		
1	X	Load-switch	50uF		

#### 7.2.3.3 LDO3, LDO4 Design Procedure

### Input Capacitance - LDO3, LDO4

The input supply pin for LDO3 and LDO4 require an input decoupling capacitor to minimize input ripple voltage. These two LDOs share the same input supply pin. Using a minimum of 4.7-µF input capacitance is recommended. Depending on the input voltage of the LDO, a 6.3 V or higher rated capacitor can be used. The same input capacitance requirements applies when the LDO is configured as LDO or load-switch.

#### **Output Capacitance - LDO3, LDO4**

LDO outputs require an output capacitor to hold up the output voltage during a load step or changes to the input voltage. Using a 2.2-μF local capacitance for each LDO output with ESR of 10 m $\Omega$  or less is recommended. Local capacitance must not exceed 4μF (after derating). This requirement excludes any capacitance seen at the load and only refers to the capacitance seen close to the device. The total capacitance (local + point of load) that each LDO can support depends on the NVM configuration.  $\frac{1}{2}$  7-3 shows the maximum total output capacitance allowed. Refer to the Technical Reference Manual (TRM) for the specific orderable part number to identify the LDO configuration based on the register settings and the applicable maximum total capacitance.

表 7-3. LDO3, LDO4 output capacitance

Register setting  LDOx_SLOW_PU_RAMP	LDO ramp config	Max total capacitance (2.2uF local + point of load)
0	fast ramp	15uF
1	slow ramp	30uF

## 7.2.3.4 VSYS, VDD1P8

The VSYS pin provides power to the internal VDD1P8 LDO and other internal functions. This pin requires a typical of 2.2uF ceramic capacitor. The input capacitor can be increased without any limit for better input-voltage filtering. On a typical application, this pin is connected to the same pre-regulator that supplies the PVIN\_Bx pins.

VDD1P8 in an internal reference LDO and must not have any load. This pin requires a 2.2uF ceramic capacitor.

#### 7.2.3.5 Digital Signals Design Procedure

This section describes the external connections required for the digital pins. A VIO supply of 3.3V or 1.8V supply is commonly used as the voltage level for the digital signals that require an external pull-up. However, higher

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voltage can be used (up to the maximum spec). The VIO supply for the digital pins on the PMIC must be the same as the IO domain for the digital signal that is connected to on the processor. 100 k $\Omega$  is the recommended pull-up resistor for EN/PB/VSENSE. Pull-up resistor for I2C pins can be calculated based on system requirements. All other digital pins can use 10 k $\Omega$ .

If GPIO, GPO1 or GPO2 is assigned to the first slot of the power-up sequence to enable an external discrete, they can be pulled up to VSYS.

The EN/PB/VSENSE pin can be driven externally to enable or disable the PMIC. However, if the application does not have an external signal dedicated to drive this pin, it can be pulled up to VSYS.

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Driving the EN/PB/VSENSE pin with an external signal is needed to wake-up the PMIC after an I2C OFF request is sent by I2C (I2C\_OFF\_REQ). If an OFF request is sent by I2C and the EN/PB/VSENSE is not driven by an external signal, a power cycle on VSYS must be performed to transfer the PMIC from Initialize state to Active.

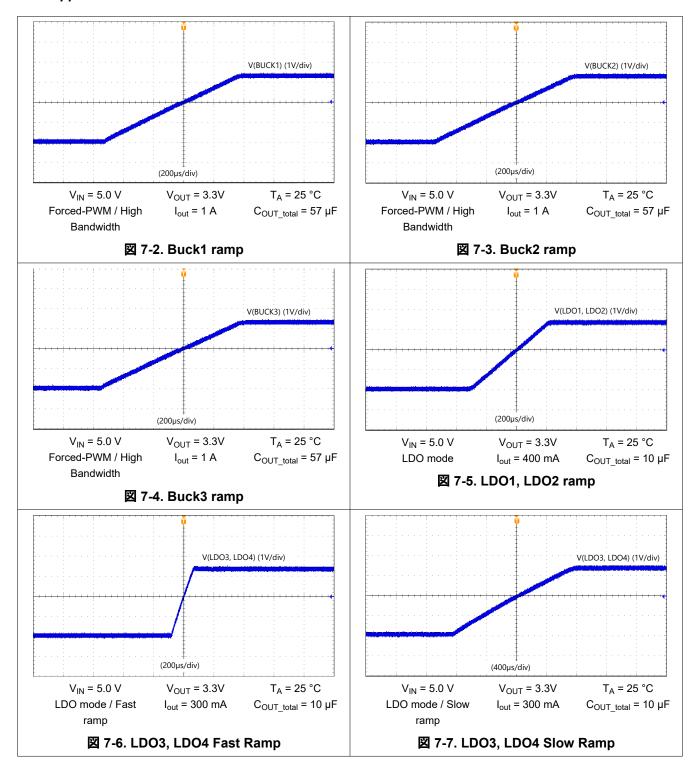
表 7-4. Digital Signals requirements

Digital Pin	External Connection
nINT	Open-drain output. Requires external pull-up.
nRSTOUT	Open-drain output. Requires external pull-up.
EN/PB/VSENSE	When configured as EN, this signal can be driven by external logic to enable or disable the PMIC. When configured as PB, this signal requires a pull-up resistor connected to the VSYS pin. Push-button is optional.  When configured as VSENSE, this signal requires an external resistor divider to monitor the pre-regulator.
SDA	I2C clock signal. Requires external pull-up.
SCL	I2C data signal. Requires external pull-up.
GPIO	When configured as GPIO (for multi-PMIC), this pin shares the external pull-up resistor with the second TPS6521905 PMIC.  When configured as GPO (for single PMIC), requires external pull-up.
GPO1	Open-drain general purpose output. Requires external pull-up.
GPO2	Open-drain general purpose output. Requires external pull-up.
VSEL_SD / VSEL_DDR	Input digital pin. The initial state (pull-up or pull-down) must be set before the assigned PMIC rail ramps up. For example, if this pin is used to set the voltage on LDO1, the state must be set before LDO1 powers up.
MODE / STBY	Input digital pin. The initial state (pull-up or pull-down) must be set before the power-up sequence is complete.
MODE / RESET	Input digital pin. The initial state (pull-up or pull-down) must be set before the power-up sequence is complete.

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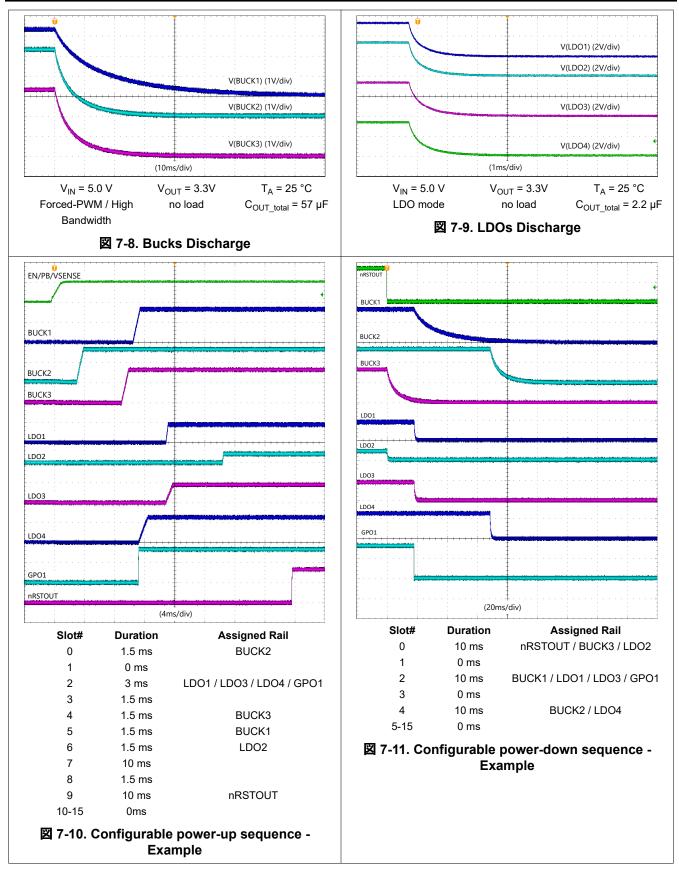
# 7.2.4 Application Curves



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# 7.3 Power Supply Recommendations

The device is designed to operate with an input voltage supply range between 2.5 V and 5.5 V. This input supply can be generated from a single cell Li-lon battery, two primary cells or a regulated pre-regulator. The voltage headroom required for each of the PMIC regulators must be taken into account when defining selecting the supply voltage. For example, if the Bucks require 700 mV head room and the output voltage is configured as 3.3V, then the input supply must be at least 4 V to allow sufficient headroom. The resistance of the input supply rail must be low enough that the input current transient does not cause too high drop in the device supply voltage that can cause false UVLO fault triggering. If the input supply is located more than a few inches from the device, additional bulk capacitance may be required in addition to the ceramic bypass capacitors. An electrolytic capacitor with a value of 47  $\mu$ F is a typical choice. When using a pre-regulator to supply the PMIC, it is recommended to select the pre-regulator without active discharge to hold the voltage at the input of the PMIC for as long as possible during a uncontrolled power-down.

#### 注意

Sequencing and Voltage requirements: The voltage on PVIN\_Bx, and PVIN\_LDOx must not exceed VSYS. The Pull-up supply for the digital signals must not exceed VSYS at any point.

## 7.4 Layout

# 7.4.1 Layout Guidelines

For all switching power supplies, the layout is an important step in the design. If the layout is not carefully done, the regulators can have stability and EMI issues. Therefore, use wide and short traces for the main current path and for the power ground tracks. The input capacitors, output capacitors, and inductors must be placed as close as possible to the device. The output capacitors must have a low impedance to ground. Use multiple VIAS (at least three) directly at the ground landing pad of the capacitor. Here are some layout guidelines:

- PVIN\_Bx: Place the input capacitor as close to the IC as allowed by the layout DRC rules. Any extra parasitic inductance between the input cap and the PVIN\_Bx pin can create a voltage spike. It is recommended to have wide a short traces or polygon to help minimize trace inductance. Do not route any sensitive signals close to the input cap and the device pin as this node has high frequency switching currents. Add 3-4 vias per amp of current on the GND pads for each DCDC. If the space is limited and does not allow to place the input capacitors on the same layer as the PMIC, then place the input capacitors on the opposite layer with VIAS, close to the IC, and add a small input capacitor (0.1uF) on the same layer as the PMIC. This small capacitor must be placed close to the PVIN Bx pin.
- LX\_Bx: Place the inductor close to the PMIC without compromising the PVIN input caps and use short & wide traces or polygons to connect the pin to the inductor. Do not route any sensitive signals close to this node. The inductor must be placed in the same layer as the IC to prevent having to use VIAS in the SW node. Since the SW-node voltage swings from the input voltage to ground with very fast rise and fall times, it is the main generator of EMI. If needed, to reduce EMI, a RC snubber can be added to the SW node.
- **FB\_Bx**: Route each of the FB\_Bx pins as a trace to the output capacitor. Do not extend the output voltage polygon to the FB\_Bx pin as this pin requires to be routed as a trace. The trace resistance from the output capacitor to the FB\_Bx pin must be less than 1 Ω. The TPS6521905 does not support remote sensing so the FB\_Bx pins must be connected to the local capacitor of the PMIC. Avoid routing the FB\_Bx close to any noisy signals such as the switch node or under the inductor to avoid coupling. If space is constraint, FB\_Bx pin can be routed through an inner layer. See example layout.
- **Bucks Cout**: The local output capacitors must be placed as close to the inductor as possible to minimize electromagnetic emissions.
- PVIN\_LDOx: Place the input capacitor as close as possible to the PVIN LDOx pin.
- VLDOx: Place the output capacitor close to the VLDOx pin. For the LDO regulators, the feedback connection is internal. Therefore, it is important to keep the PCB resistance between LDO output and target load in the range of the acceptable voltage, IR, drop for LDOs.

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VSYS: Connect VSYS directly to a quiet system voltage node. Place the decoupling capacitor as close as
possible to the VSYS pin.

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- VDD1P8: Place the 2.2 uF cap as close as possible to the VDD1P8 pin. This capacitor needs to be placed in the same layer as the IC. Two to Three VIAS can be used to connect the GND side of the capacitor to the GND plane of the PCB.
- Power Pad: The thermal pad must be connected to the PCB ground plane with a minimum of nine VIAS.
- **AGND**: Do not connect AGND to the power pad (or thermal pad). The AGDN pin must be connected to the PCB ground planes through a VIA. Keep the trace from the AGDN pin to the VIA short.

#### 7.4.2 Layout Example

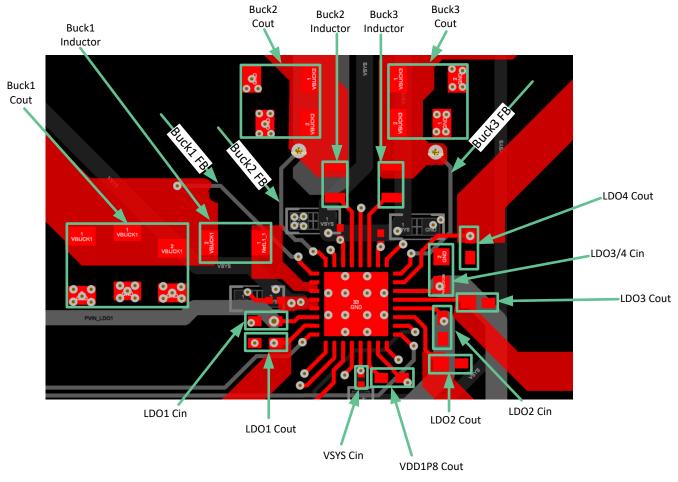


図 7-12. Example PMIC Layout

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# 8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

# 8.1 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、www.tij.co.jp のデバイス製品フォルダを開いてください。[通知] をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。 変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

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## 8.5 用語集

テキサス・インスツルメンツ用語集 この用語集には、用語や略語の一覧および定義が記載されています。

# 9 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Changes from Revision * (June 2023) to Revision A (June 2024)	Page
- アプリケーション一覧を更新	1
• Removed fixed frequency parameters that are only supported on automotive version	
Removed push-pull parameters for GPIOs. All GPIOs are open-drain	7
Updated CDM test condition to reflect correct spec	7
Updated test condition for voltage headroom on PWM, parameter 6.1.3a	13
Added a note to define VIO	27

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Product Folder Links: TPS6521905



# 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

資料に関するフィードバック(ご意見やお問い合わせ)を送信

Product Folder Links: TPS6521905

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#### PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
TPS6521905RHBR	Active	Production	VQFN (RHB)   32	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	65219 NVM 05
TPS6521905RHBR.A	Active	Production	VQFN (RHB)   32	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	65219 NVM 05
TPS6521905RSMR	Active	Production	VQFN (RSM)   32	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	65219 NVM 05
TPS6521905RSMR.A	Active	Production	VQFN (RSM)   32	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	65219 NVM 05

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# PACKAGE OPTION ADDENDUM

www.ti.com 23-May-2025

#### OTHER QUALIFIED VERSIONS OF TPS6521905:

Automotive: TPS6521905-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

# **PACKAGE MATERIALS INFORMATION**

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# TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS6521905RHBR	VQFN	RHB	32	3000	330.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2
TPS6521905RSMR	VQFN	RSM	32	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

**PACKAGE MATERIALS INFORMATION** 

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## \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS6521905RHBR	VQFN	RHB	32	3000	367.0	367.0	35.0
TPS6521905RSMR	VQFN	RSM	32	3000	367.0	367.0	35.0

4 x 4, 0.4 mm pitch

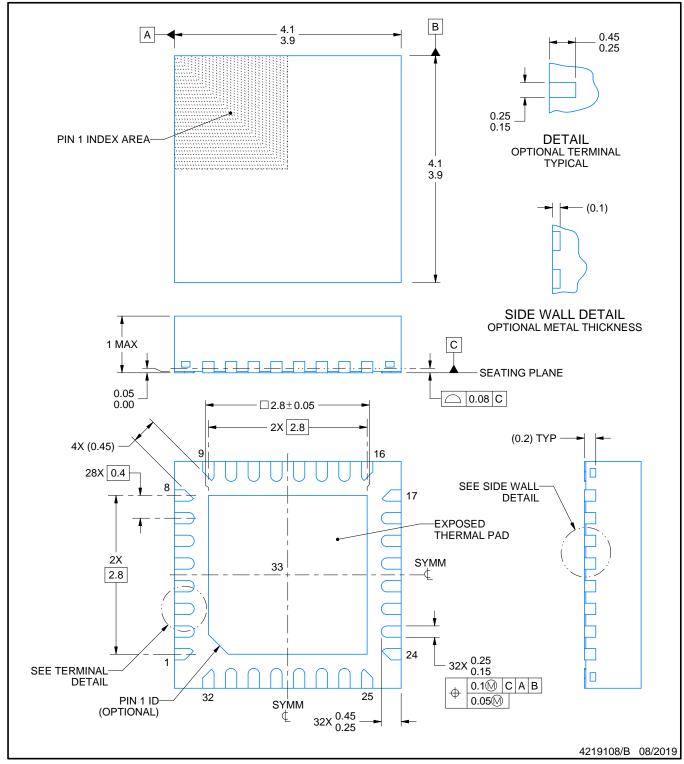
PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.







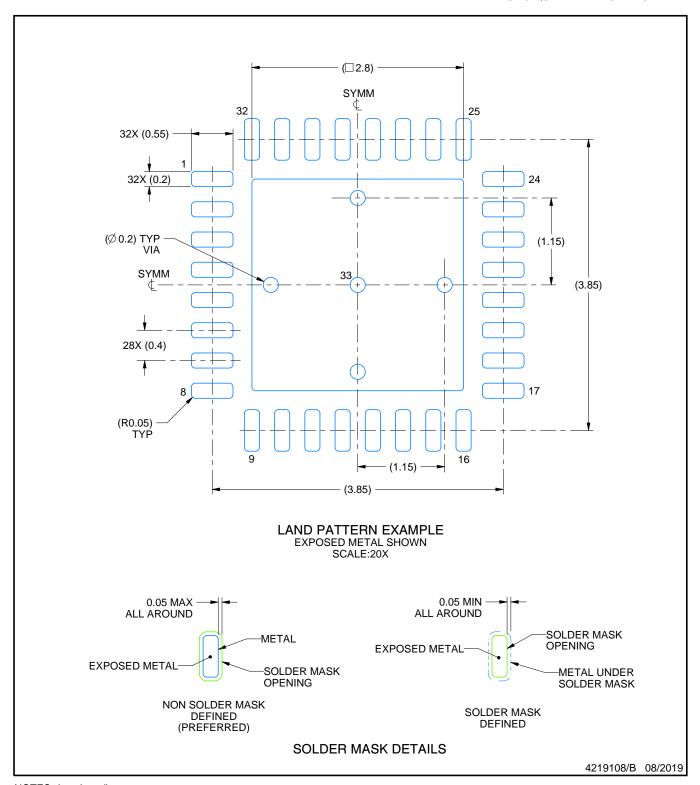


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

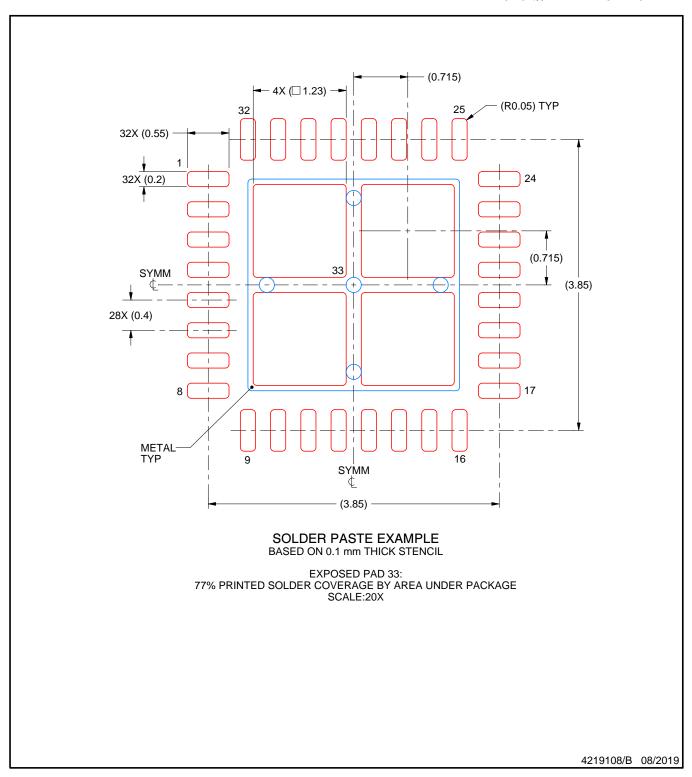




NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.





NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



5 x 5, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

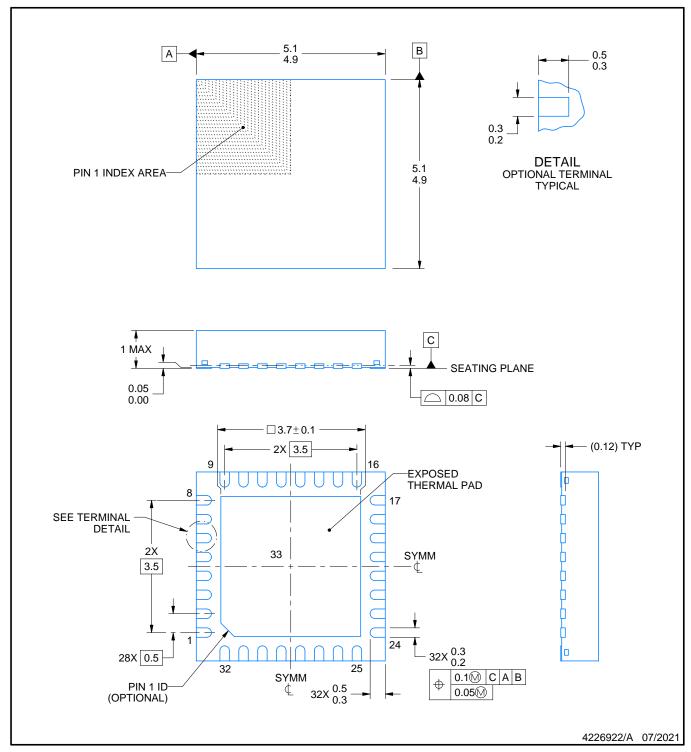


Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

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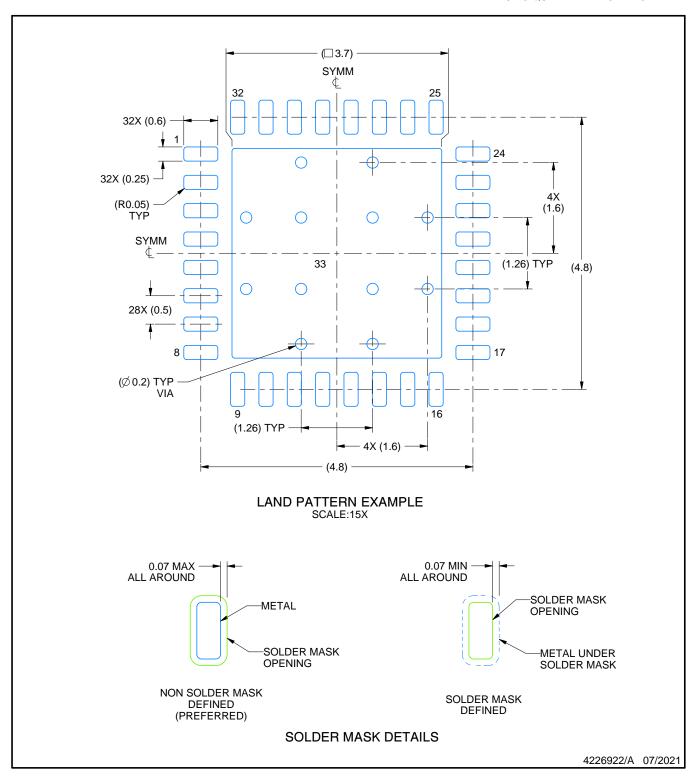




#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

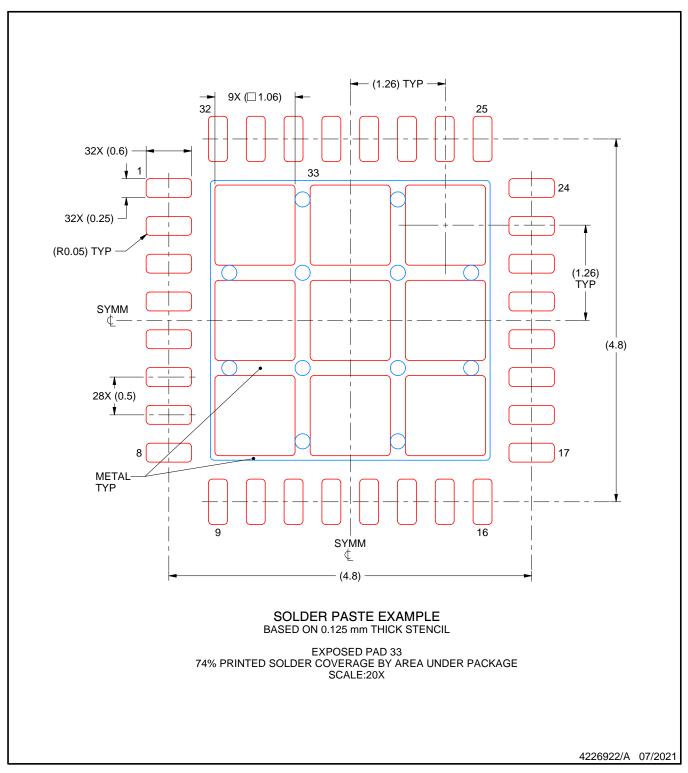




NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.





NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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